

TESTING CERT #2174.01

FCC RF Test Report

Product Name: Smart Phone

**Model Number: Y538-A1, Y538A1, Y538, HUAWEI Y538-A1,
HUAWEI Y538A1, HUAWEI Y538**

Report No: SYBH(Z-RF)006042015-2003

FCC ID: QISY538

Reliability Laboratory of Huawei Technologies Co., Ltd.

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Notice

1. The laboratory has Passed the accreditation by China National Accreditation Service for Conformity Assessment (CNAS). The accreditation number is L0310.
2. The laboratory has Passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01.
3. The laboratory has been listed by the US Federal Communications Commission to perform electromagnetic emission measurements. The site recognition number is 97456.
4. The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-2.
5. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
6. The test report is invalid if there is any evidence of erasure and/or falsification.
7. The test report is only valid for the test samples.
8. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.



Applicant: Huawei Technologies Co., Ltd.

Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,
Bantian, Longgang District, Shenzhen, 518129, P.R.C

Date of Receipt Sample: 2015-05-05

Start Date of Test: 2015-05-05

End Date of Test: 2015-05-19

Test Result: Pass

Approved by Senior

2015-05-20

Liu Chunlin

Engineer:

Date

Name

Signature

Prepared by:

2015-05-20

Wu Tingsi

Date

Name

Signature



Modification Record

No.	Last Report No.	Modification Description
		First report



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1 General Information

1.1 Applied Standard

Applied Rules: 47 CFR FCC Part 2, Subpart J 2014
47 CFR FCC Part 15, Subpart C 2014

Test Method: FCC PUBLIC NOTICE DA 00-705 Filing and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems (Released March 30, 2000)

ANSI C63.4-2003/-2009, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz.

ANSI C63.10-2009, American National Standard for Testing Unlicensed Wireless Devices.

1.2 Test Location

Test Location 1: Reliability Laboratory of Huawei Technologies Co., Ltd.
Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

Test Location 2: BTL Laboratory
Address : No.3,Jinshagang 1st Road,ShiXia,Dalang Town,DongGuan,China.

1.3 Test Environment Condition

Ambient Temperature: 19.5 to 25 °C
Ambient Relative Humidity: 45 to 55 %
Atmospheric Pressure: Not applicable



2 Test Summary

Test Item	FCC Part No.	Requirements	Test Result	Verdict (NOTE)
20dB Emission Bandwidth (EBW)	15.247(a)(1)	No limit.	Appendix A	Pass
Carrier Frequency Separation	15.247(a)(1)	$\geq \text{MAX} \{25\text{kHz}, \text{IIF}\{\text{output power} \leq 125\text{mW}, 2/3 * 20\text{dB EBW}, 20\text{dB EBW}\}\}$.	Appendix B	Pass
Number of Hopping Channel	15.247(a)(1)(iii)	≥ 15 channels.	Appendix C	Pass
Time of Occupancy (Dwell Time)	15.247(a)(1)(iii)	$< 0.4\text{s}$ within a period of $(0.4\text{s} * \text{hopping number})$.	Appendix D	Pass
Maximum Peak Conducted Output Power	15.247(b)(1)	$< 1\text{ W}$ if using ≥ 75 non-overlapping channels.	Appendix E	Pass
Band edge spurious emission	15.247(d)	$< -20\text{ dBm}/100\text{ kHz}$ if total peak power $\leq$ power limit.	Appendix F	Pass
Conducted RF Spurious Emission			Appendix G	Pass
Radiated Emissions in the Restricted Bands	15.247(d) 15.209	FCC Part 15.209 field strength limit;	Appendix H	Pass
AC Power Line Conducted Emissions	15.207	FCC Part 15.207 conducted limit;	Appendix I	Pass
NOTE1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".				

3 Description of the Equipment under Test (EUT)

3.1 General Description

Y538-A1, Y538A1, Y538, HUAWEI Y538-A1, HUAWEI Y538A1, HUAWEI Y538 Smart Phone is subscriber equipment in the GSM/CDMA/EVDO/WCDMA/LTE system. The frequency band is CDMA BC0 (Cell 800) and BC1 (PCS1900) and BC10 (Sec 800). The GSM/GPRS/EDGE frequency band includes GSM850 and GSM900 and DCS1800 and PCS1900. The UMTS frequency band is band II and band V. The LTE frequency band is B25 and B26 and B41. The Mobile Phone implements such functions as RF signal receiving/transmitting, CDMA2000 1x /1X EV-DO and LTE/UMTS and GSM/GPRS/EDGE protocol processing, voice, MMS service, GPS, AGPS and WIFI etc. Externally it provides micro SD card interface, earphone port (to provide voice service). It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.

3.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

3.2.1 Board

Board		
Description	Hardware Version	Software Version
Main Board	HL1Y538A1M	URX0115327000242

3.2.2 Sub-Assembly

Name	Manufacture	Description
Adapter	Huawei Technologies Co., Ltd.	Model: HW-050100U2W Input voltage: 100V~240V AC and 50/60 Hz, 0.2A Output voltage: +5V --- 1A Rated Power: 5W



3.2.3 Battery

Name	Manufacture	Description
Rechargeable Li-ion	Huawei Technologies Co., Ltd.	Battery Model: HB474284RBC Rated capacity: 2000mAh Nominal Voltage:  +3.8V Charging Voltage:  +4.35V

3.3 Technical Description

Characteristics	Description	
TX/RX Operating Range	2400-2483.5 MHz band	$f_c = 2402 \text{ MHz} + N * 1 \text{ MHz}$, where: - f_c = "Operating Frequency" in MHz, - N = "Channel Number" with the range from 0 to 78.
	Carrier	Frequency Hopping Spread Spectrum (FHSS)
Modulation Type	Digital	GFSK, $\pi/4$ -DQPSK, 8DPSK
	Emission Designator	
Emission Designator	GFSK: 1M00GXD	
	$\pi/4$ -DQPSK: 1M28GXD	
	8DPSK: 1M46GXD	
Bluetooth Power Class	Class 1	

4 General Test Conditions / Configurations

4.1 EUT Configurations

4.1.1 General Configurations

Configuration	Description
Test Antenna Ports	Until otherwise specified, - All TX tests are performed at all TX antenna ports of the EUT, and - All RX tests are performed at all RX antenna ports of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

4.1.2 Customized Configurations

# EUT Conf.	Signal Description	Operating Frequency
TM1_DH5_Hop	GFSK modulation, package type DH5, hopping on.	---
TM1_DH5_Ch0	GFSK modulation, package type DH5, hopping off.	Ch No. 0 / 2402 MHz
TM1_DH5_Ch39	GFSK modulation, package type DH5, hopping off.	Ch No. 39 / 2441 MHz
TM1_DH5_Ch78	GFSK modulation, package type DH5, hopping off.	Ch No. 78 / 2480 MHz
TM2_2DH5_Hop	$\pi/4$ -DQPSK modulation, package type 2DH5, hopping on.	---
TM2_2DH5_Ch0	$\pi/4$ -DQPSK modulation, package type 2DH5, hopping off.	Ch No. 0 / 2402 MHz
TM2_2DH5_Ch39	$\pi/4$ -DQPSK modulation, package type 2DH5, hopping off.	Ch No. 39 / 2441 MHz
TM2_2DH5_Ch78	$\pi/4$ -DQPSK modulation, package type 2DH5, hopping off.	Ch No. 78 / 2480 MHz
TM3_3DH5_Hop	8DPSK modulation, package type 3DH5, hopping on.	---
TM3_3DH5_Ch0	8DPSK modulation, package type 3DH5, hopping off.	Ch No. 0 / 2402 MHz
TM3_3DH5_Ch39	8DPSK modulation, package type 3DH5, hopping off.	Ch No. 39 / 2441 MHz
TM3_3DH5_Ch78	8DPSK modulation, package type 3DH5, hopping off.	Ch No. 78 / 2480 MHz



4.2 Test Environments

NOTE: The values used in the test report may be stringent than the declared.

Environment Parameter	Selected Values During Tests		
	Temperature	Voltage	Relative Humidity
NTNV	Ambient	3.8 VDC	Ambient

4.3 Antenna requirements

Excerpt from §15.203 of the FCC Rules/Regulations:

“An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.”

The antennas of the **Y538-A1, Y538A1, HUAWEI Y538-A1, HUAWEI Y538A1** are **permanently attached**. There are no provisions for connection to an external antenna.

Conclusion:

The **Smart Phone FCC ID: QISY538-A1** unit complies with the requirement of §15.203.

Ch. Frequency (MHz)

Ch.	Frequency (MHz)
00	2402
.	.
.	.
39	2441
.	.
.	.
78	2480

Frequency/ Channel Operations

4.4 Description of tests

4.4.1 Bandwidth measurement

- (a) Connect EUT test port to universal communication tester.
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch off frequency hopping function, then set the measuring frequency number, finally test the bandwidth with universal communication tester.

4.4.2 Carrier frequency separation measurement

- (a) Connect EUT test port to spectrum analyzer and universal communication tester.
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch off frequency hopping function, then set the measured frequency number to two adjacent channels separately and test the carrier frequency separation with spectrum analyzer.

4.4.3 Number of hopping channel

- (a) Connect EUT test port to spectrum analyzer and universal communication tester.
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch on frequency hopping function, then set enough count time (larger than 5000 times) to get all the hopping frequency channel displayed on the screen of spectrum analyzer.
- (c) Count the quantity of peaks to get the number of hopping channels.

4.4.4 Time of occupancy

- (a) Connect test port of EUT to spectrum analyzer and universal communication tester.
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch on frequency hopping function.
- (c) Set the span of spectrum analyzer to 0 Hz, and set the resolution bandwidth to 1 MHz and the video bandwidth to 1 MHz, then get the time domain measured diagram. and set sweep time to 2 times of one burst occupancy time, and measure the time of occupancy of one burst.
- (d) Set the resolution bandwidth to 1 MHz and the video bandwidth to 3 MHz, and set the sweep time to a period (0.4 seconds multiplied by the number of hopping channels employed), and count the number of the bursts.
- (e) Calculate the time of occupancy in a period with time occupancy of a burst and quantity of bursts

4.4.5 Peak output power

- (a) Connect EUT test port to spectrum analyzer and universal communication tester.
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch off frequency hopping function.
- (c) Then set the EUT to transmit at high, middle and low frequency and measure the conducted output power separately.

4.4.6 Band edge spurious emission

- (a) Connect EUT test port to spectrum analyzer and universal communication tester
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch off frequency hopping function.
- (c) Then set the EUT to transmit at high, low frequency and measure the conducted band edge spurious separately.
- (d) Switch on the frequency hopping function, and repeat above measurement.

4.4.7 Conducted RF Spurious

- (a) Connect EUT test port to spectrum analyzer and universal communication tester
- (b) Set the EUT to transmit maximum output power at 2.4GHz and switch off frequency hopping function.
- (c) Then set the EUT to transmit at high, middle and low frequency and measure the conducted spurious separately.
- (d) Switch on the frequency hopping function, and repeat the above measurement.

4.4.8 Radiated spurious emission & spurious in restricted band

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4dB according to the standards: ANSI C63.10 (2009). The EUT was set-up on insulator 80cm above the Ground Plane. The set-up and test methods were according to ANSI C63.10:2009. The Radiated Disturbance measurements were made using a Rohde and Schwarz Test Receiver and control software.

A preliminary scan and a final scan of the emissions were made by using test script of software; the emissions were measured using a Quasi-Peak Detector below 1GHz, Peak Detector and AV detector above 1GHz. The maximal emission value was acquired by adjusting the antenna height, polarisation and turntable azimuth in accordance with the software setup. Normally, the height range of antenna was 1m to 4m, and the azimuth range of turntable was 0° to 360°. The receive antenna has two polarizations V and H.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other nonmetallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized.

The EUT communicates with the BTS simulator through Air interface. The EUT transmits maximum output power at 2.4GHz and switch off frequency hopping function.

Measurement bandwidth: 30 MHz - 1000 MHz: 120 kHz

Measurement bandwidth: 1000 MHz - 10th Carrier Frequency: 1 MHz

4.4.9 Conducted Emission at Power Port

The Table-top EUT was placed upon a non-metallic table 0.8 m above the horizontal metal reference ground plane. EUT was connected to LISN and LISN was connected to reference Ground Plane. EUT was 80cm from LISN. The set-up and test methods were according to ANSI C63.10: 2009.



Conducted Disturbance at AC Port measurements were undertaken on the L and N Lines. The emissions were measured using a Quasi-Peak Detector and Average Detector.

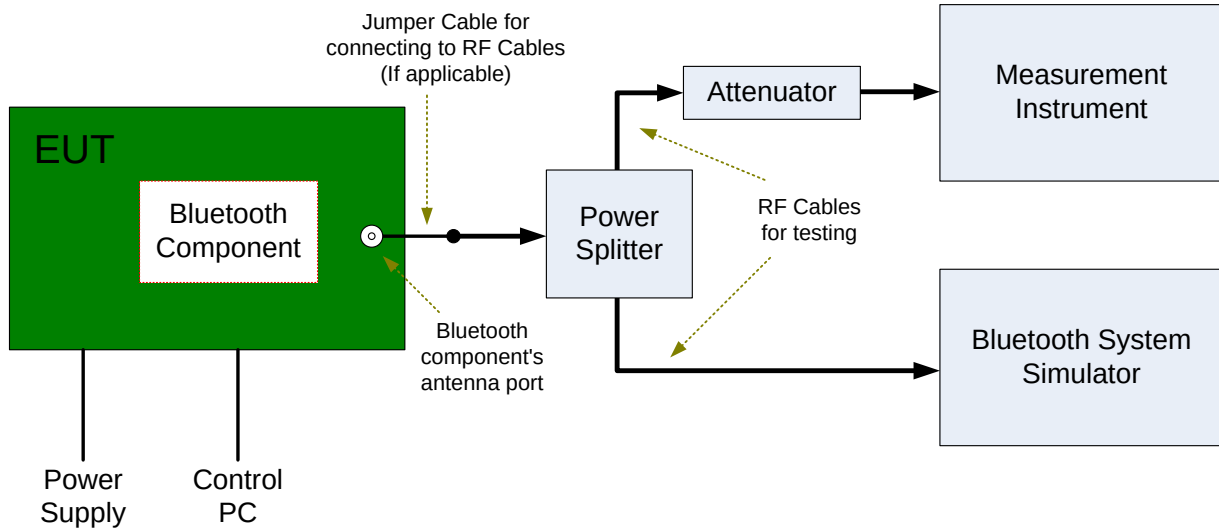
The EUT communicates with the BTS simulator through Air interface, the BTS simulator controls the EUT to transmit the maximum power which is defined in the specification of the product. The EUT operated on the typical channel.

Measurement bandwidth (RBW) for 150kHz to 30 MHz: 9 kHz;

4.5 Test Setups

4.5.1 Test Setup 1

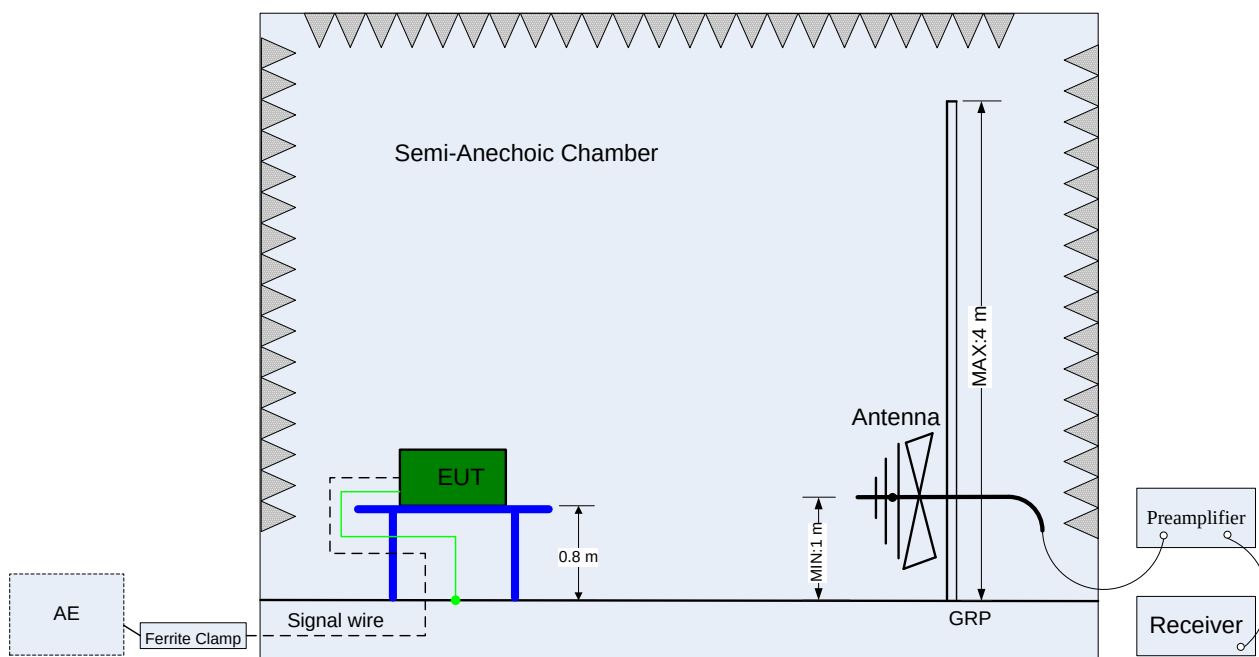
The Bluetooth component's antenna ports(s) of the EUT are connected to the measurement instrument per an appropriate attenuator. The EUT is controlled by Bluetooth System Simulator and/or PC/software to emit the specified signals for the purpose of measurements.



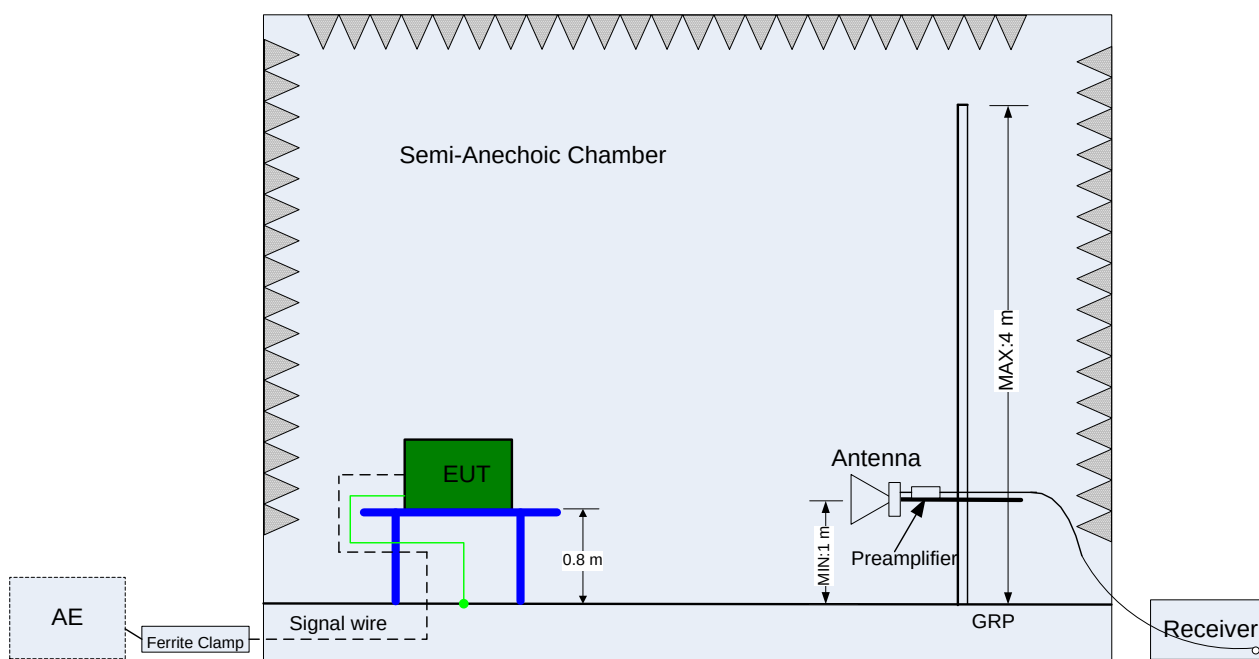
4.5.2 Test Setup 2

The test site semi-anechoic chamber has met the requirement of NSA tolerance 4 dB according to the standards: ANSI C63.4. The test distance is 3m. The setup is according to ANSI C63.4 and CAN/CSA-CEI/IEC CISPR 22.

The maximal emission value is acquired by adjusting the antenna height, polarisation and turntable azimuth. Normally, the height range of antenna is 1 m to 4 m, the azimuth range of turntable is 0° to 360°, and the receive antenna has two polarizations Vertical (V) and Horizontal (H).



(Below 1 GHz)

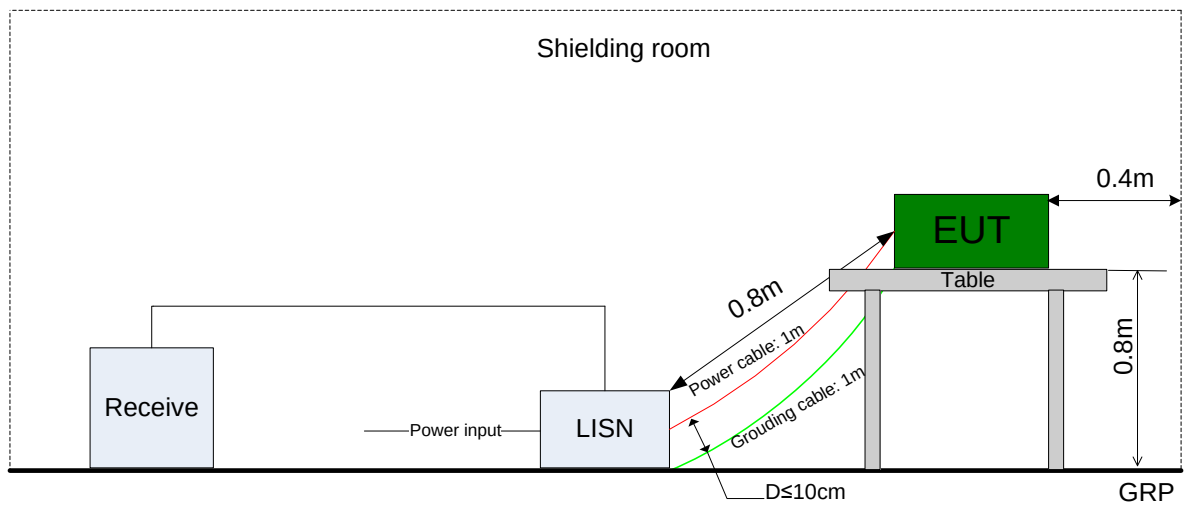


(Above 1 GHz)

4.5.3 Test Setup 3

The mains cable of the EUT (maybe per AC/DC Adapter) must be connected to LISN. The LISN shall be placed 0.8 m from the boundary of EUT and bonded to a ground reference plane for LISN mounted on top of the ground reference plane. This distance is between the closest points of the LISN and the EUT. All other units of the EUT and associated equipment shall be at least 0.8m from the LISN.

Ground connections, where required for safety purposes, shall be connected to the reference ground point of the LISN and, where not otherwise provided or specified by the manufacturer, shall be of same length as the mains cable and run parallel to the mains connection at a separation distance of not more than 0.1 m.



4.6 Test Conditions

Test Case	Test Conditions	
	Configuration	Description
20dB Emission Bandwidth (EBW)	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Ch0, TM1_DH5_Ch39, TM1_DH5_Ch78, TM2_2DH5_Ch0, TM2_2DH5_Ch39, TM2_2DH5_Ch78, TM3_3DH5_Ch0, TM3_3DH5_Ch39, TM3_3DH5_Ch78.
Carrier Frequency Separation	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Hop, TM2_2DH5_Hop, TM3_3DH5_Hop.
Number of Hopping Channel	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Hop, TM2_2DH5_Hop, TM3_3DH5_Hop.
Time of Occupancy (Dwell Time)	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Ch39, TM2_2DH5_Ch39, TM3_3DH5_Ch39.
Maximum Peak Conducted Output Power	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Ch0, TM1_DH5_Ch39, TM1_DH5_Ch78, TM2_2DH5_Ch0, TM2_2DH5_Ch39, TM2_2DH5_Ch78, TM3_3DH5_Ch0, TM3_3DH5_Ch39, TM3_3DH5_Ch78.
Band edge spurious emission	Meas. Method	DA 00-705
	Test Env.	NTNV
	Test Setup	Test Setup 1
	EUT Conf.	TM1_DH5_Ch0, TM1_DH5_Ch78, TM2_2DH5_Ch0, TM2_2DH5_Ch78, TM3_3DH5_Ch0, TM3_3DH5_Ch78.
Conducted RF Spurious Emission	Meas. Method	DA 00-705
	Test Env.	NTNV

Test Case	Test Conditions			
	Configuration	Description		
	Test Setup	Test Setup 1		
	EUT Conf.	TM1_DH5_Ch0, TM1_DH5_Ch39, TM1_DH5_Ch78, TM2_2DH5_Ch0, TM2_2DH5_Ch39, TM2_2DH5_Ch78, TM3_3DH5_Ch0, TM3_3DH5_Ch39, TM3_3DH5_Ch78.		
Radiated Emissions in the Restricted Bands	Meas. Method	DA 00-705, C63.4, C63.10. (1) 30 MHz to 1 GHz: Pre: RBW = 100 kHz; VBW = 300 kHz; Det. = Peak. Final: RBW = 120 kHz; Det. = CISPR Quasi-Peak. (2) 1 GHz to 26.5 GHz: Average: RBW = 1 MHz; VBW = 10 Hz; Det. = Peak; Sweep-time = Auto; Trace = Single. Peak: RBW = 1 MHz; VBW = 3 MHz; Det. = Peak; Sweep-time = Auto; Trace ≥ Max Hold * 100.		
	Test Env.	NTNV		
	Test Setup	Test Setup 2		
	EUT Conf.	30 MHz -1 GHz	TM1_DH5_Ch0 (Worst Conf.).	
		1-3 GHz	TM1_DH5_Ch0, TM1_DH5_Ch39, TM1_DH5_Ch78, TM2_2DH5_Ch0, TM2_2DH5_Ch39, TM2_2DH5_Ch78, TM3_3DH5_Ch0, TM3_3DH5_Ch39, TM3_3DH5_Ch78.	
		3-18 GHz	TM1_DH5_Ch0 (Worse Conf.), TM1_DH5_Ch39 (Worse Conf.), TM1_DH5_Ch78 (Worse Conf.).	
		18-26.5 GHz	TM1_DH5_Ch0 (Worst Conf.).	
AC Power Line Conducted Emissions	Meas. Method	AC mains conducted. Pre: RBW = 10 kHz; Det. = Peak. Final: RBW = 9 kHz; Det. = CISPR Quasi-Peak & Average.		
	Test Env.	NTNV		
	Test Setup	Test Setup 3		
	EUT Conf.	TM1_DH5_Ch39.		



5 Main Test Instruments

Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal- Due
Power supply	KEITHLEY	2303	A120714713	2014-08-07	2016-08-06
Wireless Communication Test set	Agilent	N4010A	MY49081592	2014-11-04	2015-11-03
Universal Radio Communication Tester	R&S	CMU200	123299	2014-11-04	2015-11-03
Spectrum Analyzer	Agilent	N9020A	MY52090652	2014-07-11	2015-07-10
Universal Radio Communication Tester	R & S	CMW500	126854	2015-02-13	2016-02-12
Spectrum Analyzer	Agilent	E4440A	MY48250119	2014-07-11	2015-07-10
Signal Analyzer	R&S	FSQ31	200021	2014-11-04	2015-11-03
Spectrum Analyzer	Agilent	N9030A	MY49431698	2014-11-04	2015-11-03
Temperature Chamber	WEISS	WKL64	56246002940010	2015-02-13	2016-02-12
Signal generator	Agilent	E8257D	MY49281095	2014-11-04	2015-11-03
Vector Signal Generator	R&S	SMU200A	104162	2014-11-04	2015-11-03
Spectrum analyzer	R&S	FSU3	200474	2014-11-04	2015-11-03
Spectrum analyzer	R&S	FSU43	100144	2014-11-04	2015-11-03
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100391	2013-12-21	2015-12-20
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	2013-12-21	2015-12-20
Pyramidal Horn Antenna(18GHz-26-5GHz)	ETS-LINDGREN	3160-09	5140299	2015-01-05	2017-01-04
Artificial Mains Network	R&S	ENV4200	100134	2014-11-04	2015-11-03
Artificial Mains Network	R&S	ENV216	100382	2014-11-04	2015-11-03
Power Detecting & Sampling Unit	R&S	OSP-B157	19709DD	2014-09-08	2015-09-07
Signal Generator	Agilent	E4438C	MY47271904	2014-10-28	2015-10-27

Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE
EXA Spectrum Analyzer	N9010A	MY5052044	Agilent	Mar.28,2016
Microwave Preamplifier With Adaptor	EMC012645B	980221	EMC INSTRUMENT	Oct.22,2015
Amplifier	8449B	3008A02274	Agilent	Mar.28,2016
Double Ridged Guide Antenna	3115	00075846	ETS.LINDGREN	Mar.28,2016
Antenna	VULB9160	9160-3231	SCHWARZBECK	Mar.28,2016



Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE
controller	SC100	9163-235	CT	N/A

END



Appendix A: 20dB Emission Bandwidth (EBW)



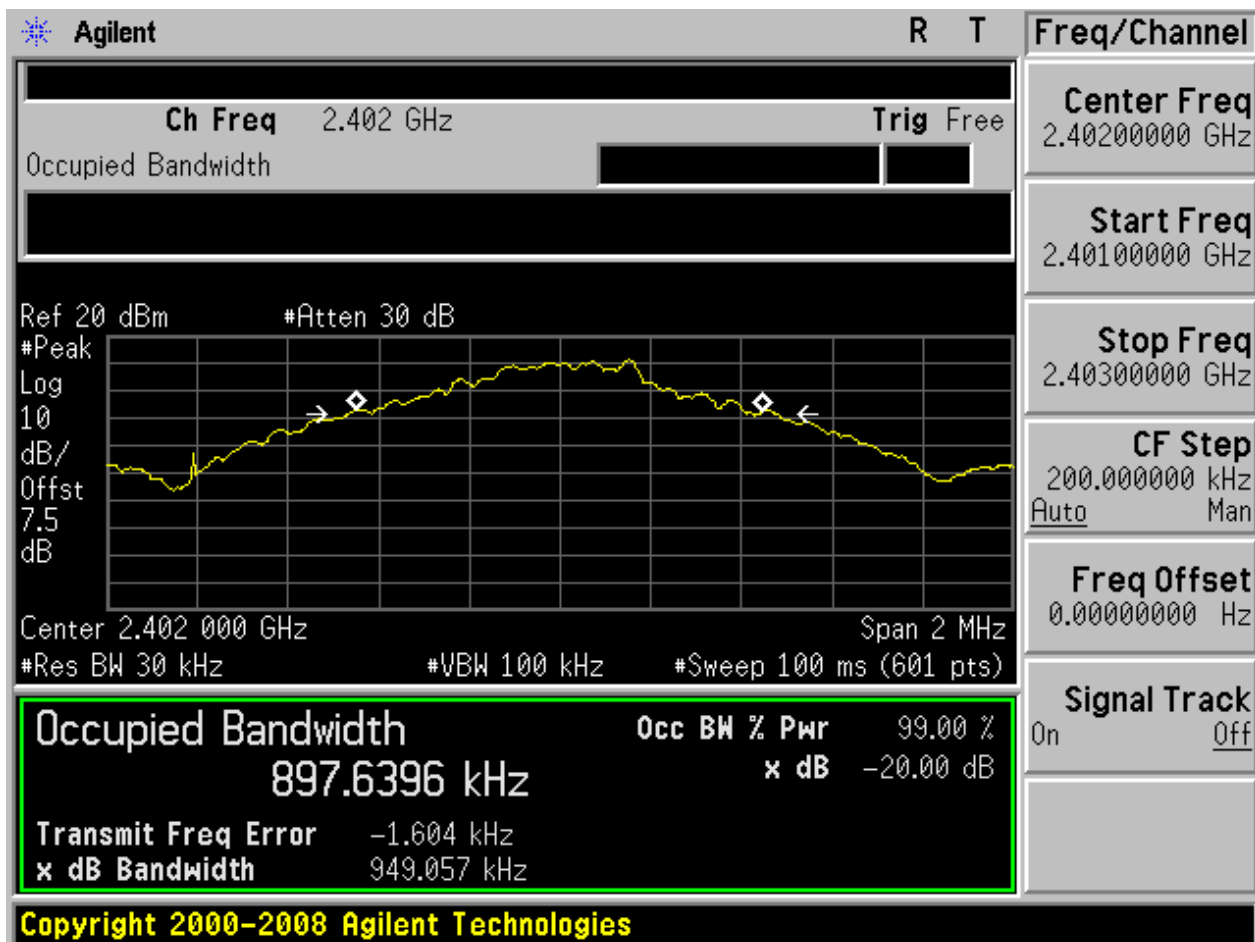
1 Result Table

EUT Conf.	EBW [MHz]	Verdict
TM1_DH5_Ch0	0.949	Pass
TM1_DH5_Ch39	0.950	Pass
TM1_DH5_Ch78	0.948	Pass
TM2_2DH5_Ch0	1.286	Pass
TM2_2DH5_Ch39	1.281	Pass
TM2_2DH5_Ch78	1.285	Pass
TM3_3DH5_Ch0	1.277	Pass
TM3_3DH5_Ch39	1.468	Pass
TM3_3DH5_Ch78	1.275	Pass



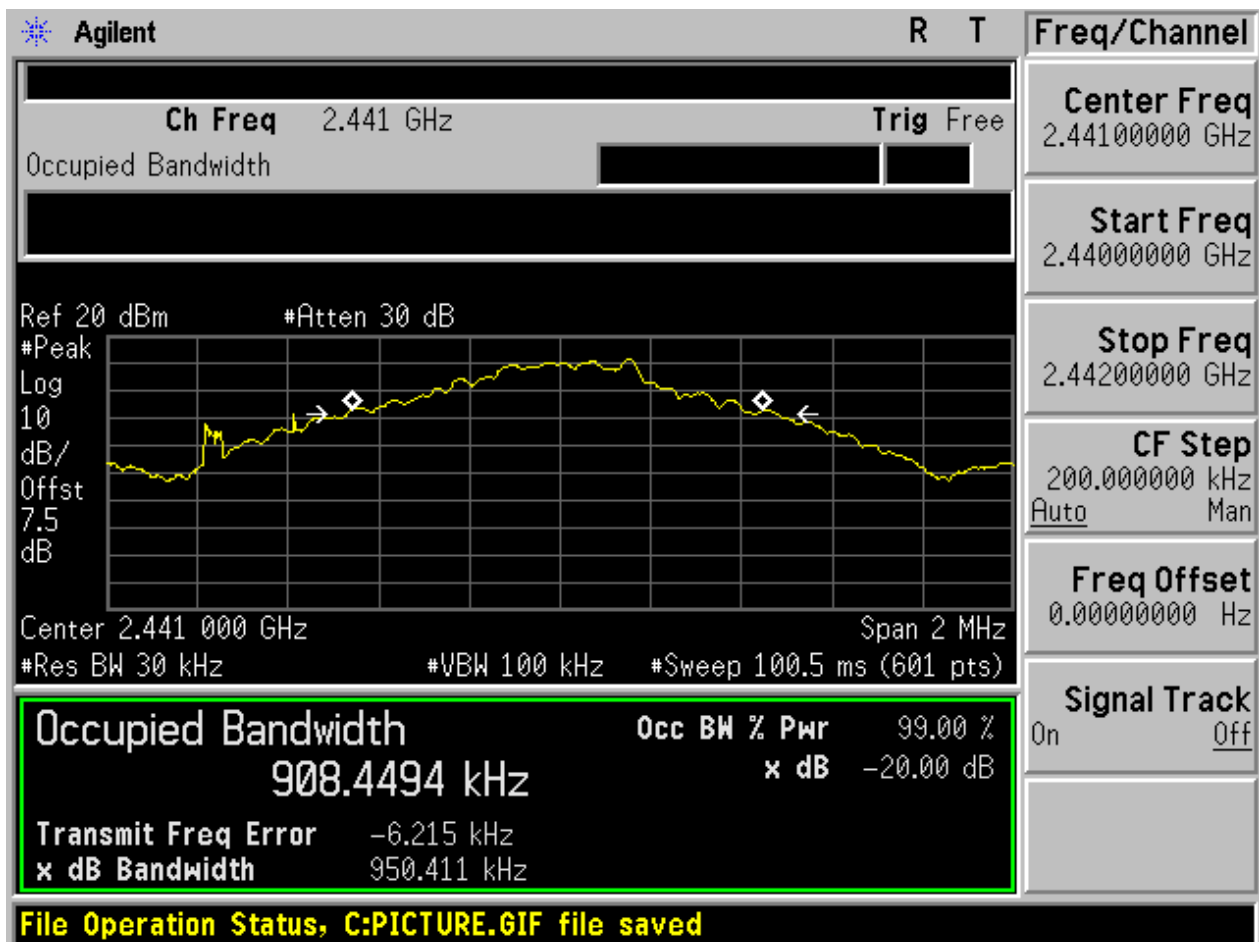
2 Test Plot

2.1 TM1_DH5_Ch0



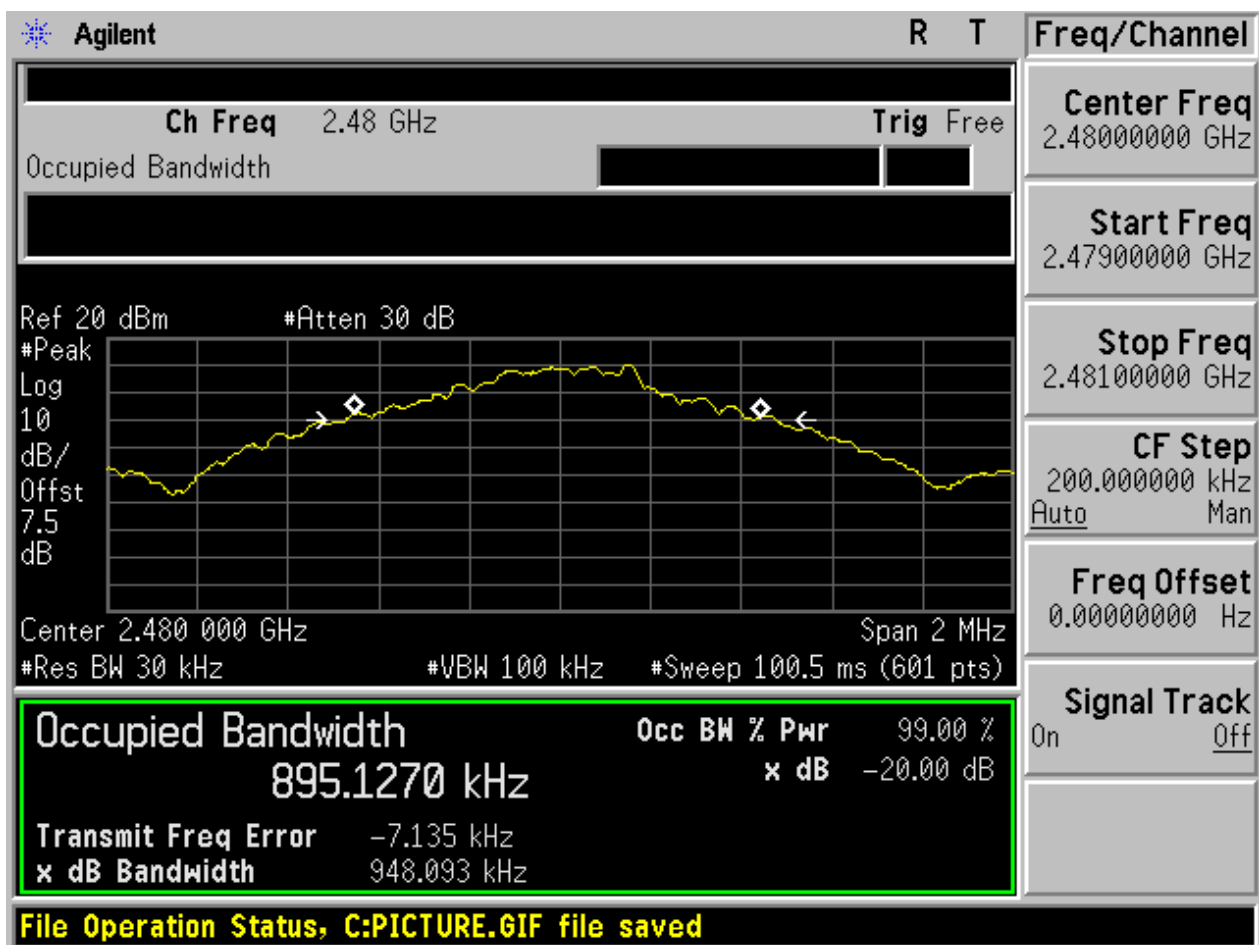


2.2 TM1_DH5_Ch39



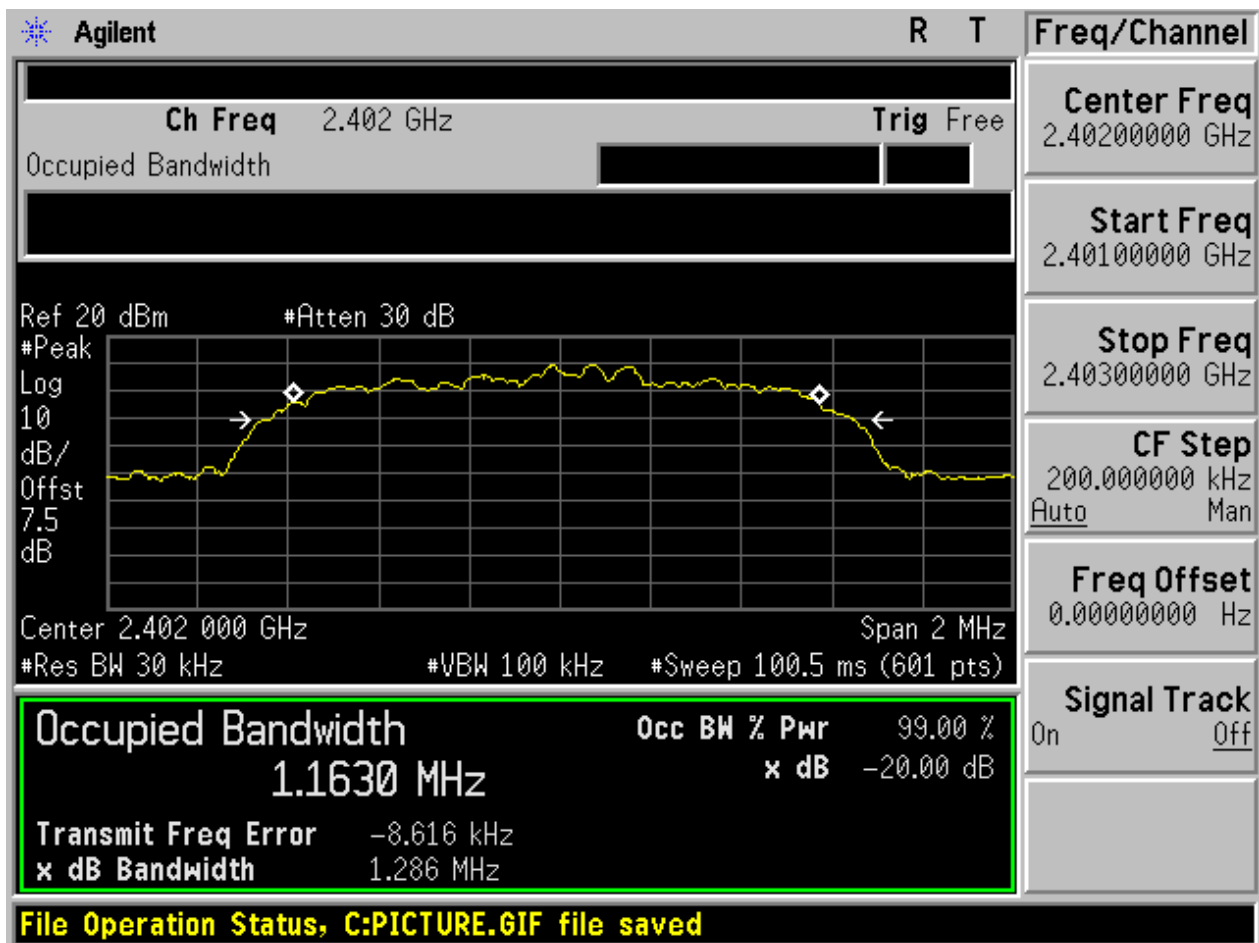


2.3 TM1_DH5_Ch78



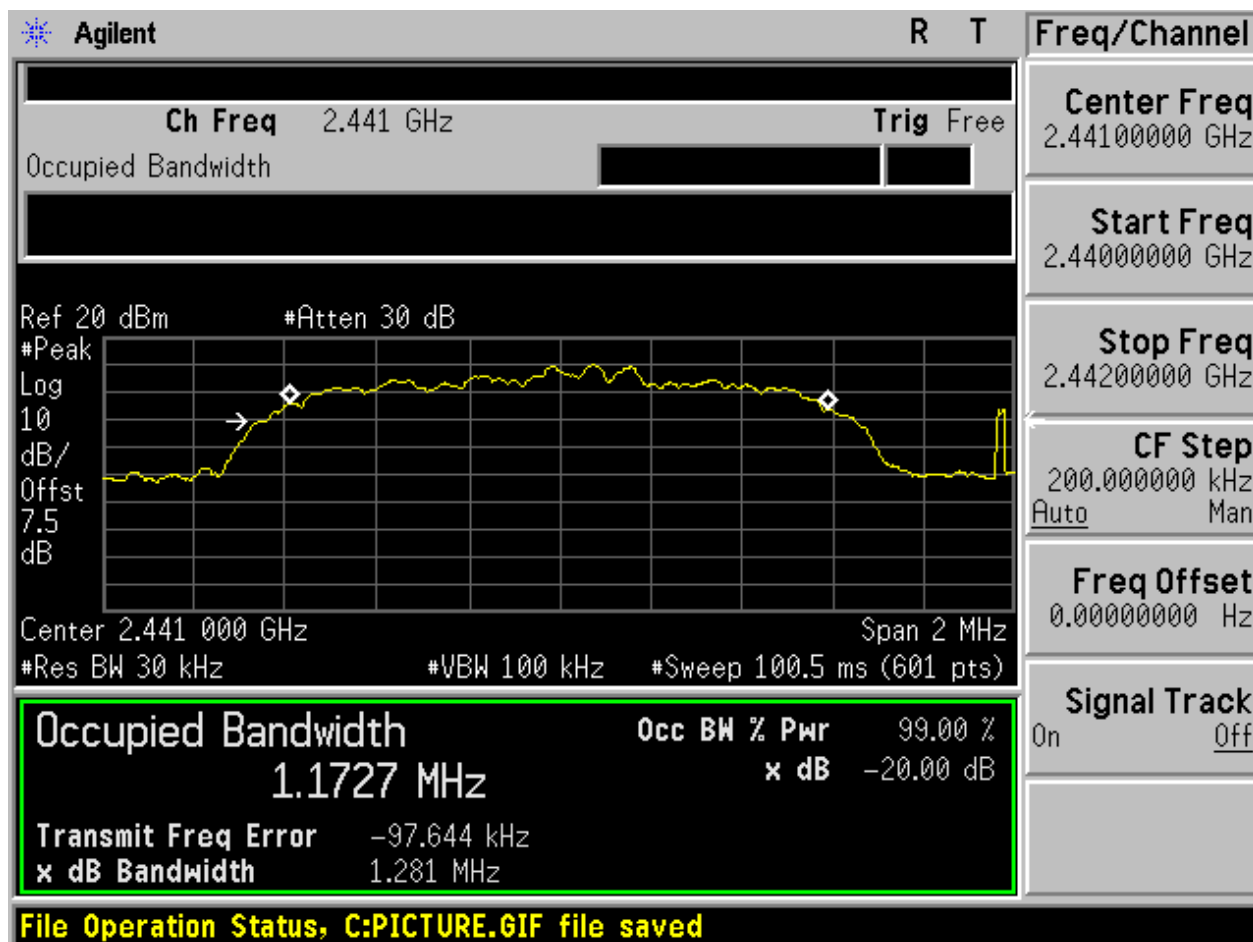


2.4 TM2_2DH5_Ch0

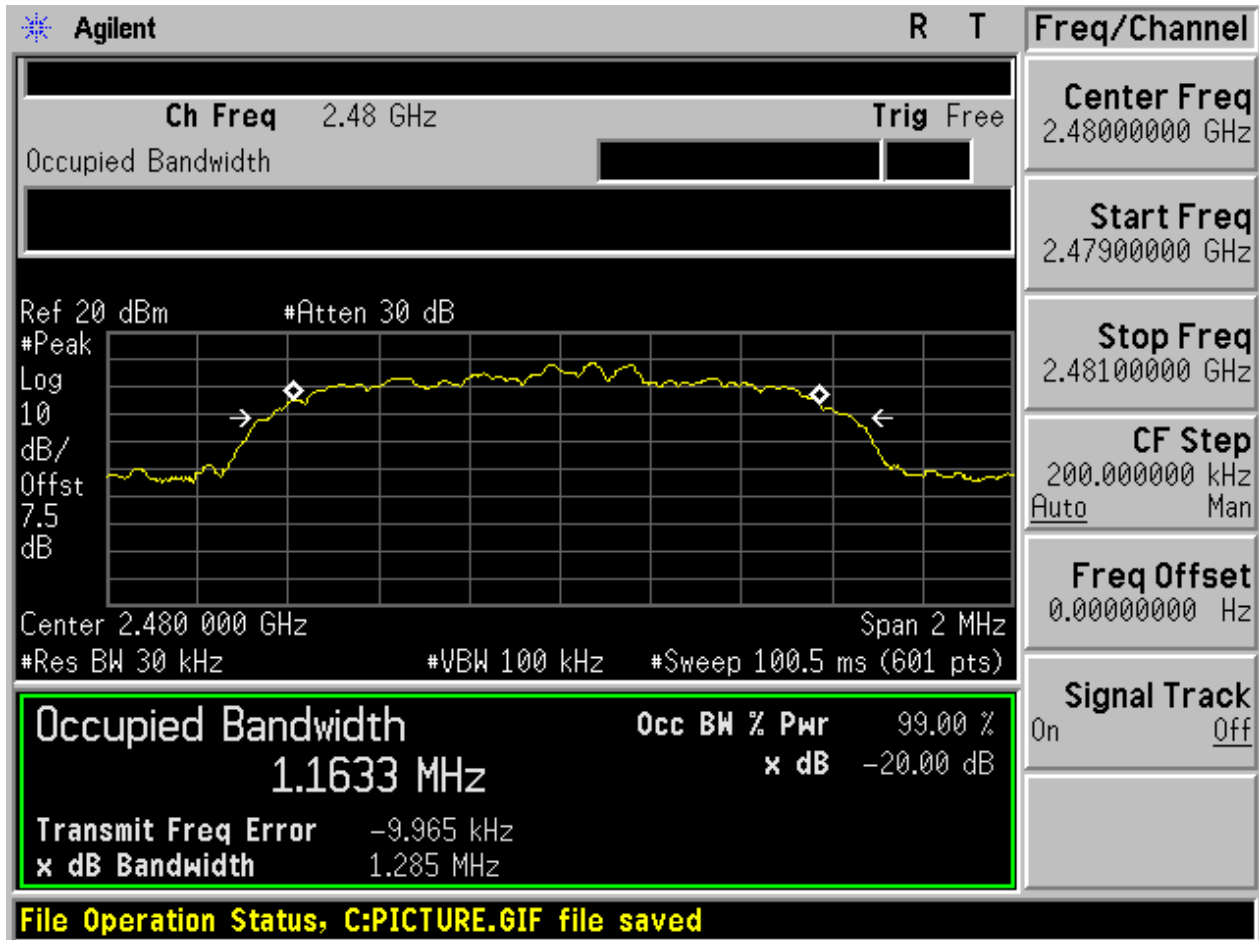




2.5 TM2_2DH5_Ch39

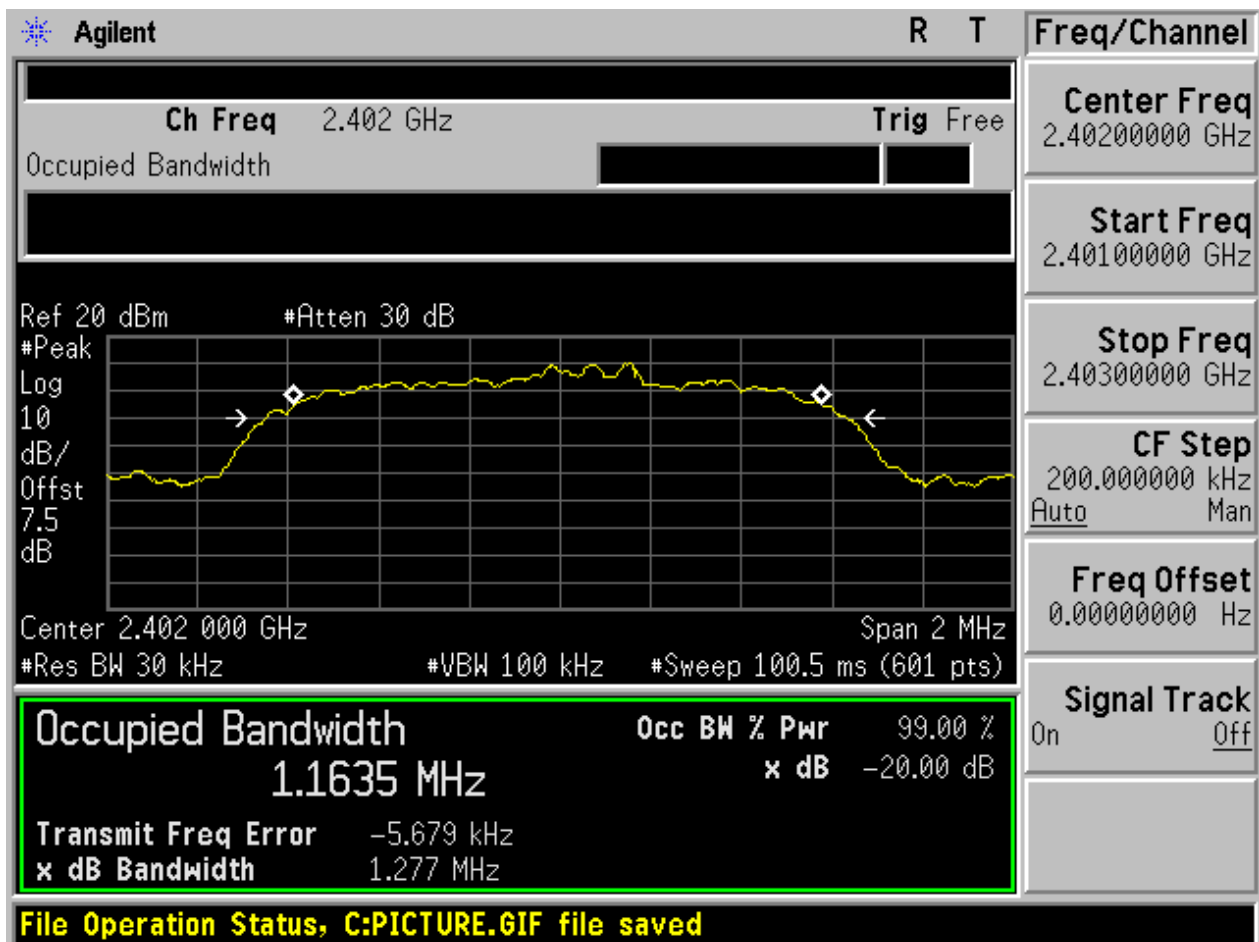


2.6 TM2_2DH5_Ch78



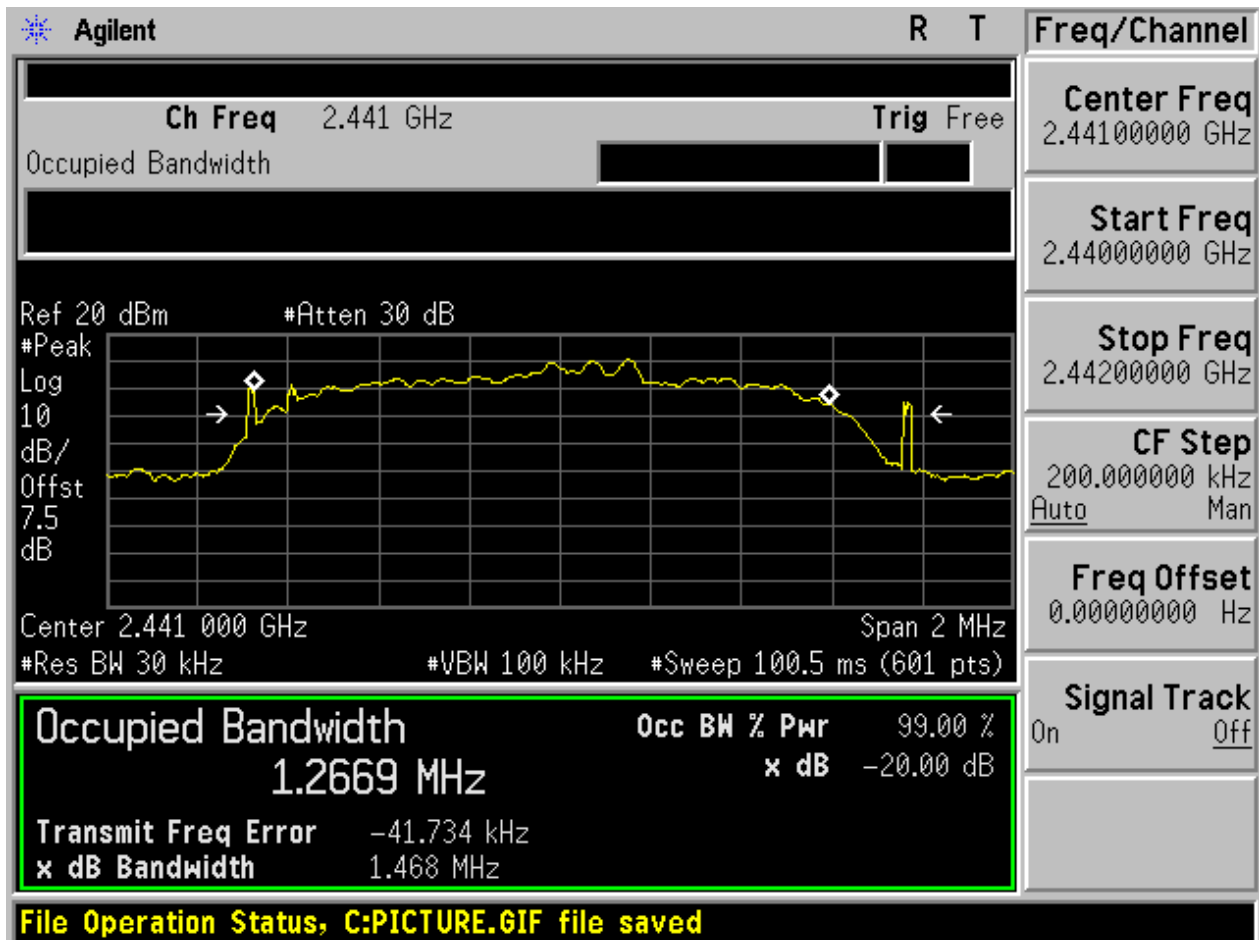


2.7 TM3_3DH5_Ch0



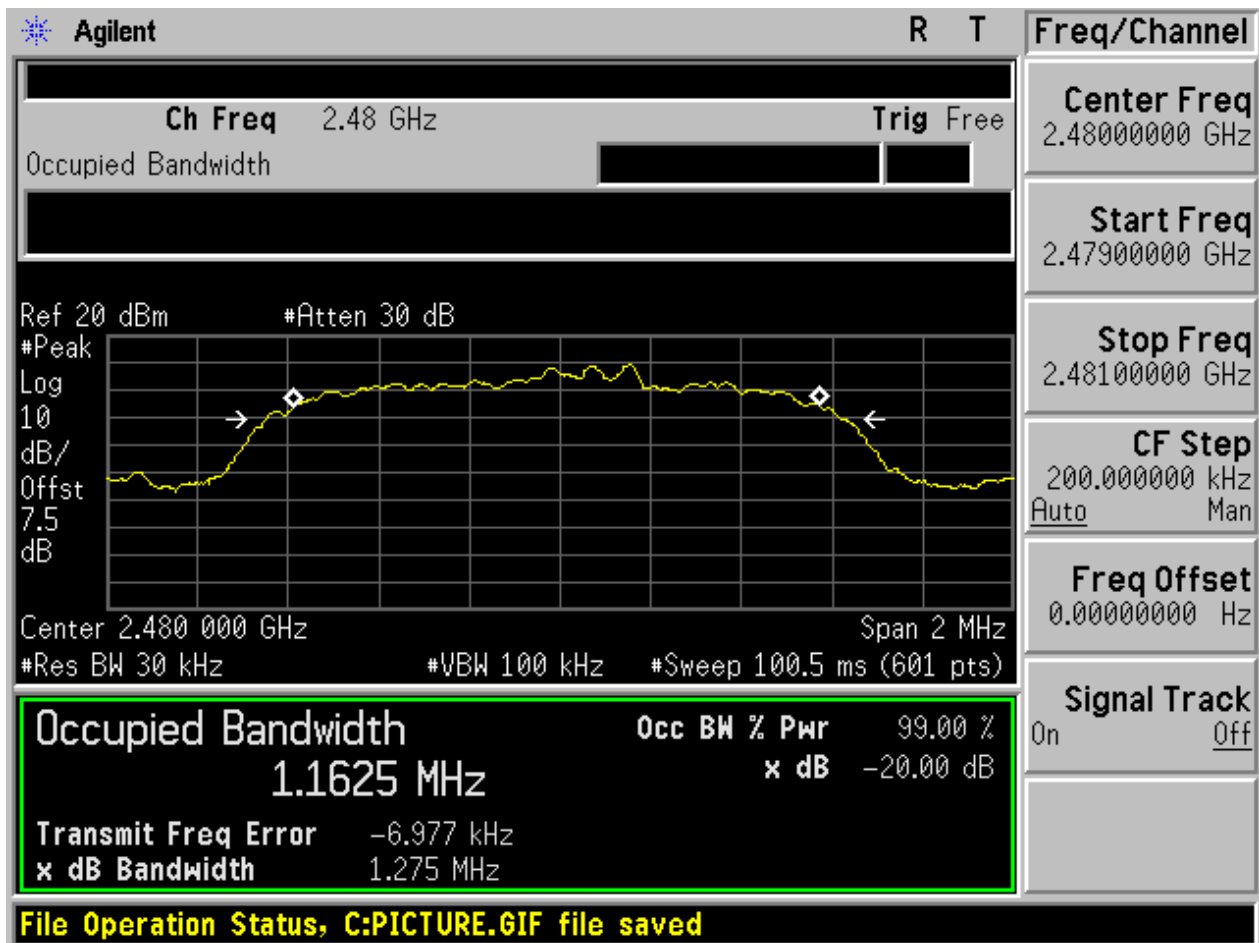


2.8 TM3_3DH5_Ch39





2.9 TM3_3DH5_Ch78





Appendix B: Carrier Frequency Separation



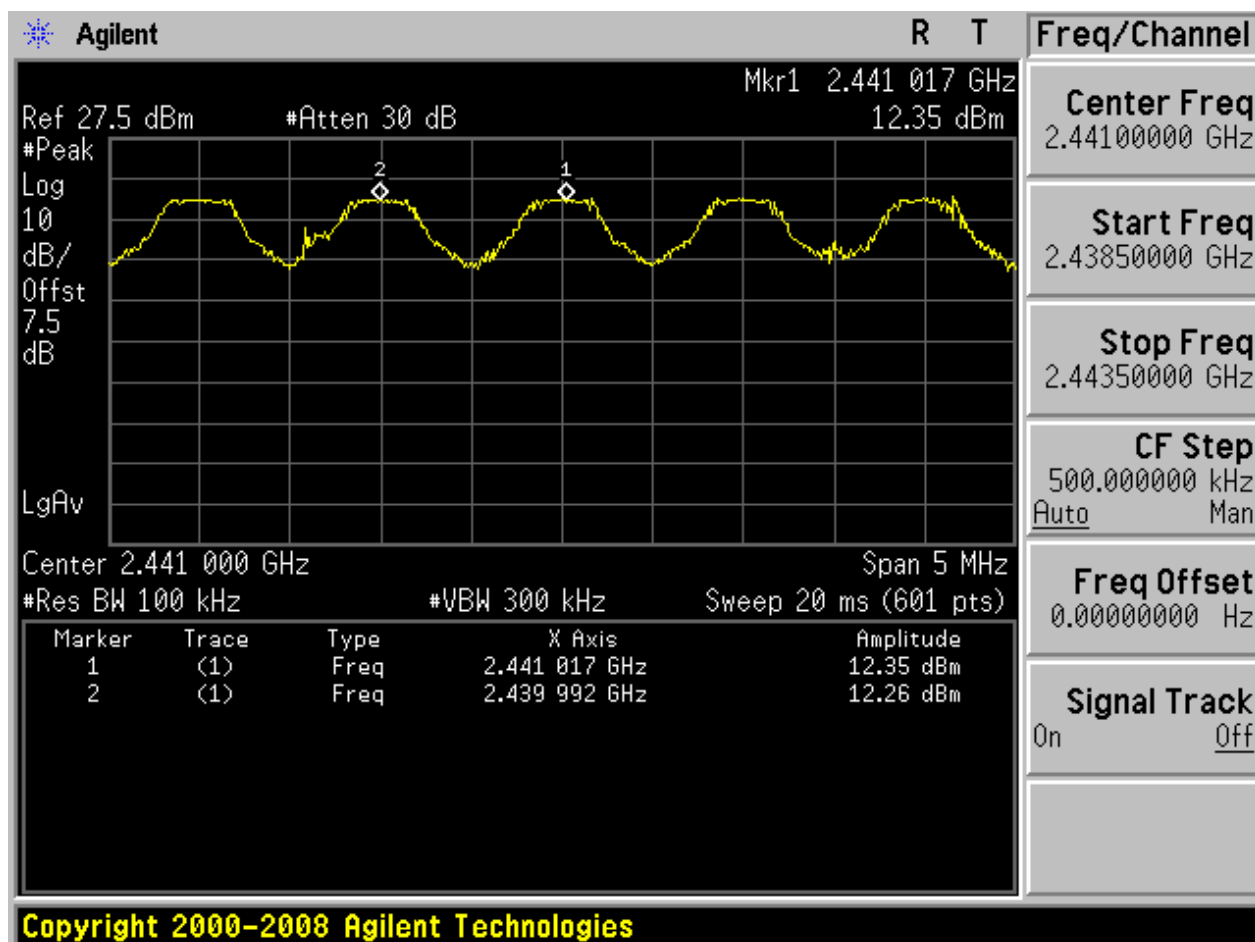
1 Result Table

EUT Conf.	Carrier Frequency Separation [MHz]	Verdict
TM1_DH5_Hop	1.025	Pass
TM2_2DH5_Hop	1.025	Pass
TM3_3DH5_Hop	1.034	Pass

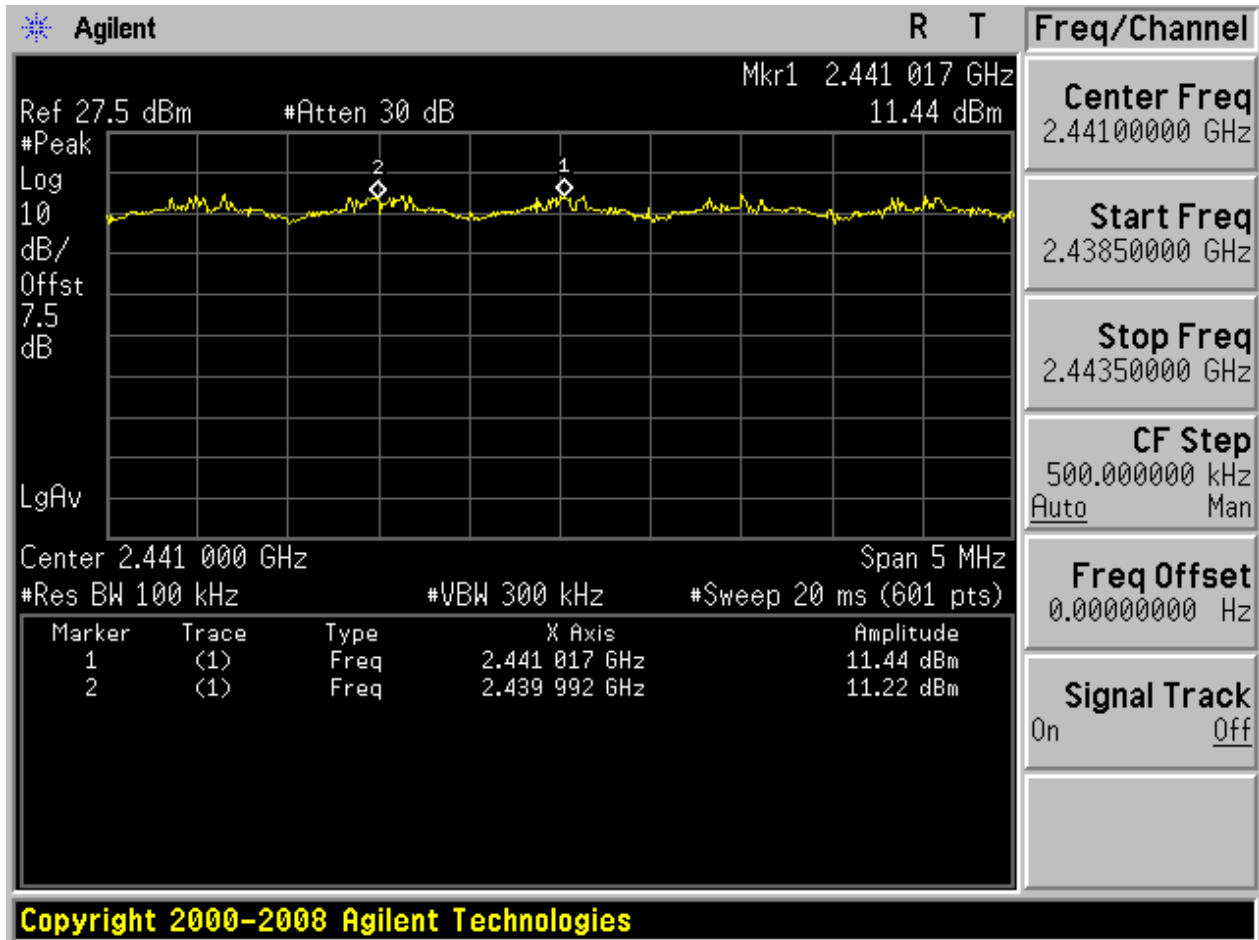


2 Test Plot

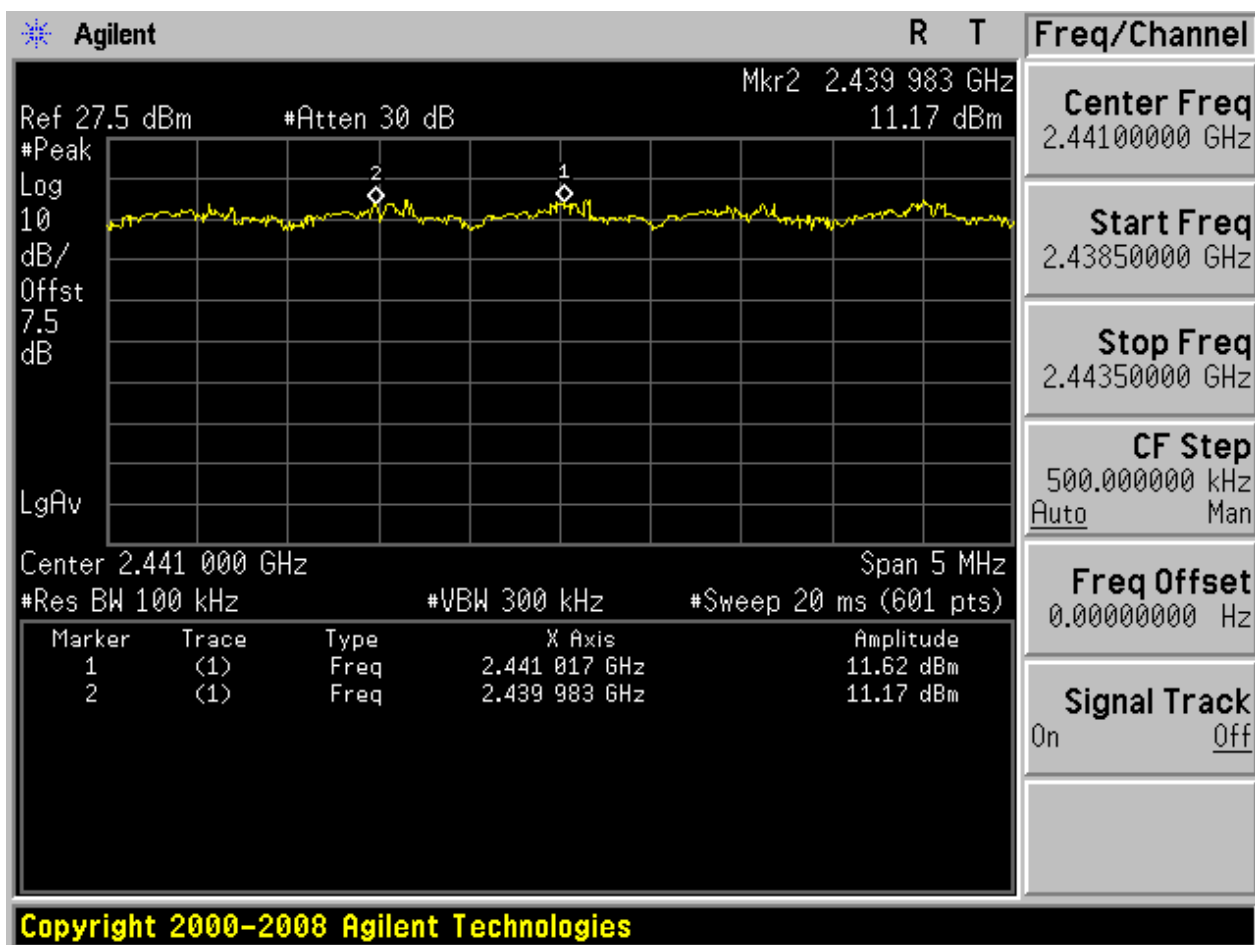
2.1 TM1_DH5_Hop



2.2 TM2_2DH5_Hop



2.3 TM3_3DH5_Hop





Appendix C: Number of Hopping Channel



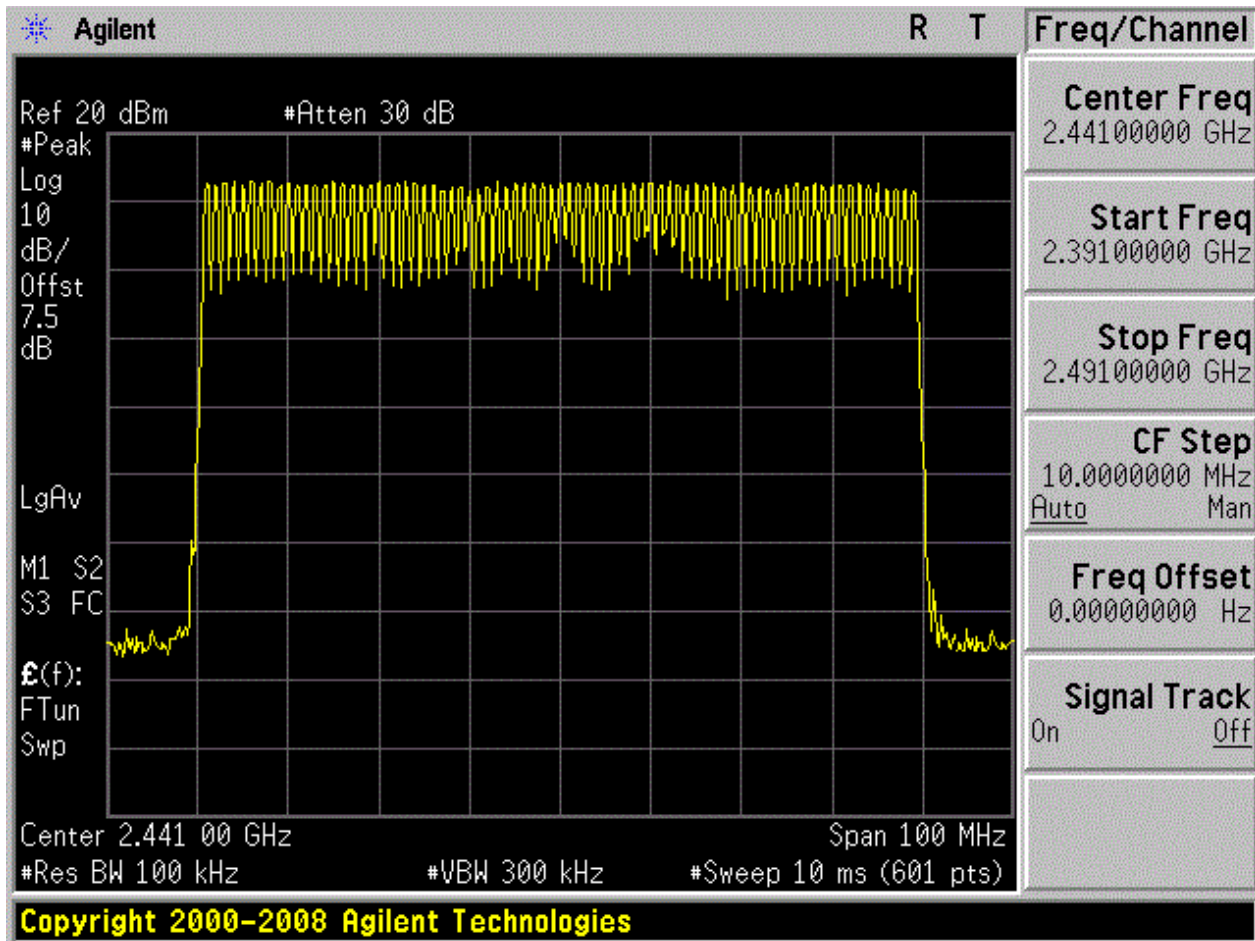
1 Result Table

EUT Conf.	Number of Hopping Channel	Verdict
TM1_DH5_Hop	79	Pass
TM2_2DH5_Hop	79	Pass
TM3_3DH5_Hop	79	Pass

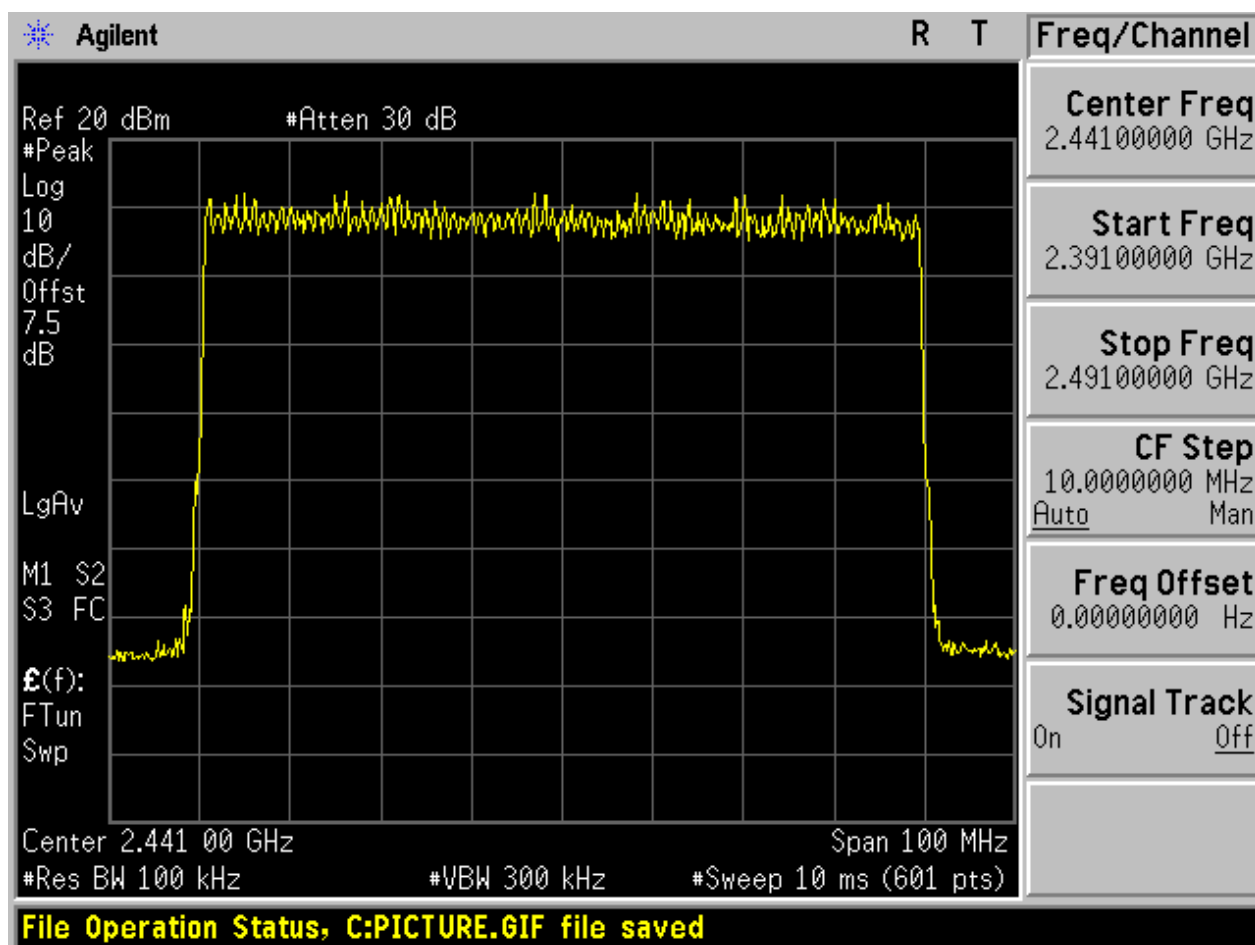


2 Test Plot

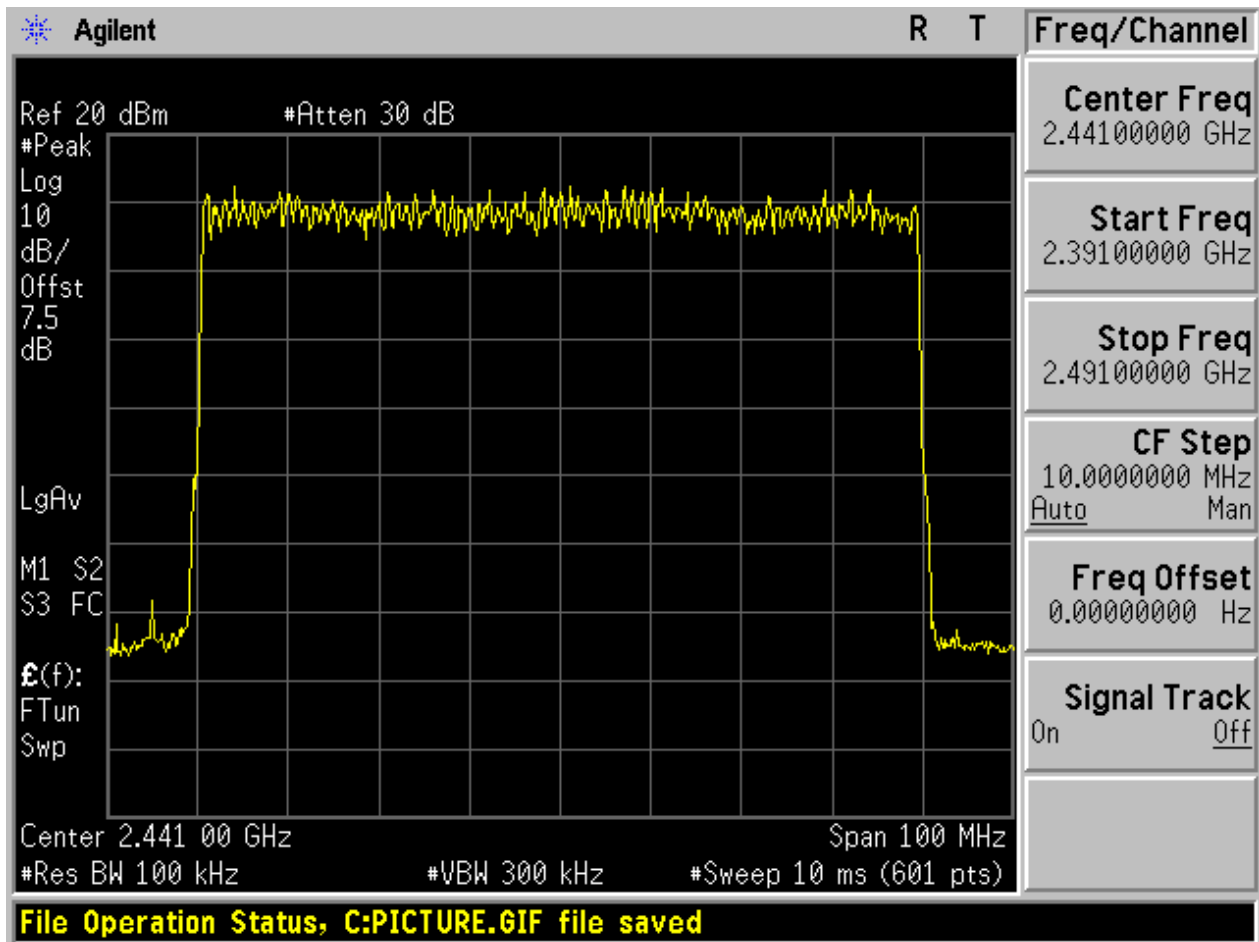
2.1 TM1_DH5_Hop



2.2 TM2_2DH5_Hop



2.3 TM3_3DH5_Hop





Appendix D: Time of Occupancy (Dwell Time)

1 Result Table

The Dwell Time = Burst Width * Total Hops. The detailed calculations are showed as follows:

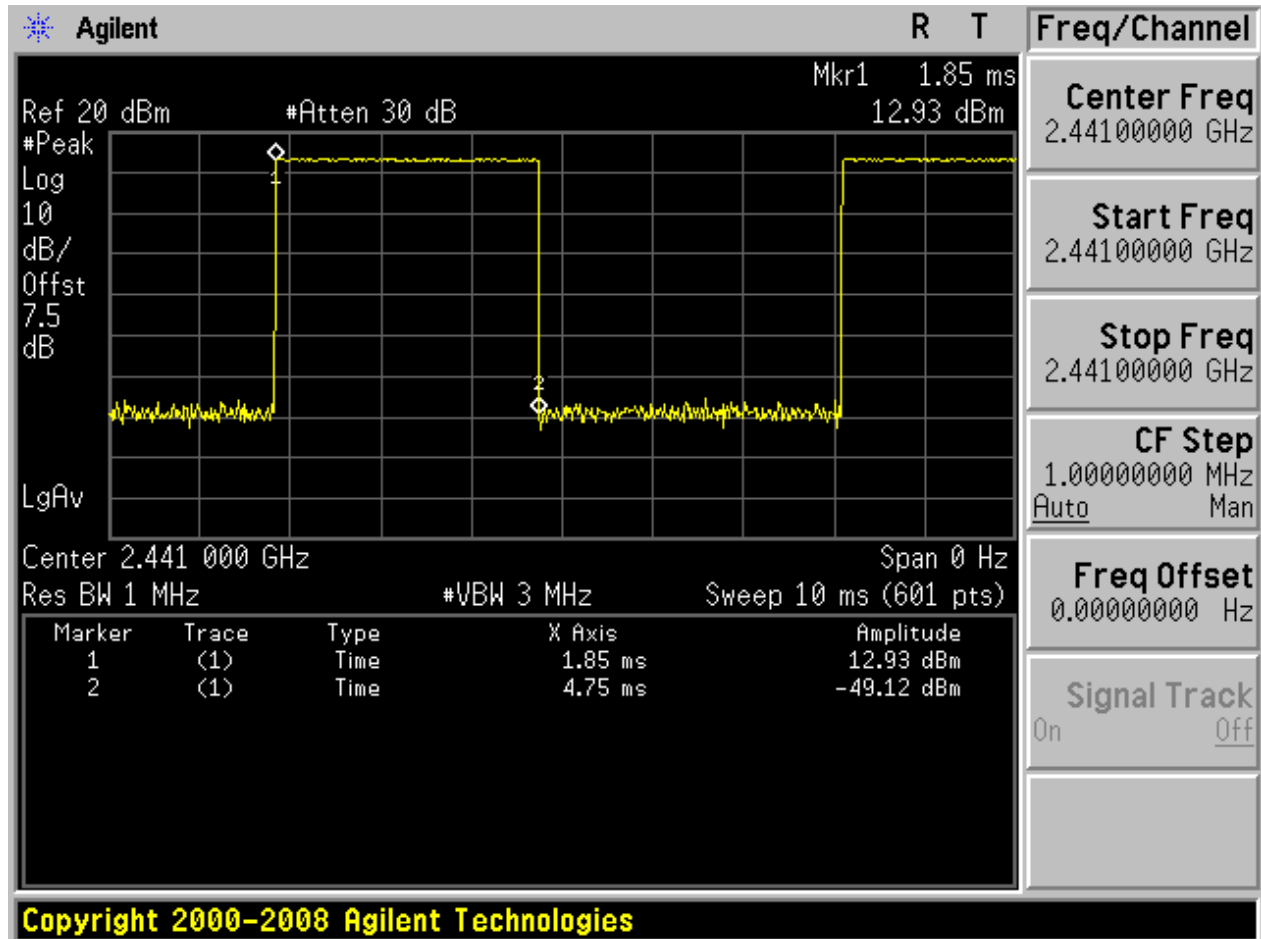
- The duration for dwell time calculation: $0.4 \text{ [s]} * \text{hopping number} = 0.4 \text{ [s]} * 79 \text{ [ch]} = 31.6 \text{ [s*ch]}$;
- The burst width [ms/hop/ch], which is directly measured, refers to the duration on one channel hop.
- The hops per second for all channels: The selected EUT Conf uses a slot type of 5-Tx&1-Rx and a hopping rate of 1600 [ch*hop/s] for all channels. So the final hopping rate for all channels is $1600 / 6 = 266.67 \text{ [ch*hop/s]}$;
- The hops per second on one channel: $266.67 \text{ [ch*hop/s]} / 79 \text{ [ch]} = 3.38 \text{ [hop/s]}$;
- The total hops for all channels within the dwell time calculation duration: $3.38 \text{ [hop/s]} * 31.6 \text{ [s*ch]} = 106.67 \text{ [hop*ch]}$;
- The dwell time for all channels hopping: $106.67 \text{ [hop*ch]} * \text{Burst Width [ms/hop/ch]}$.

EUT Conf.	Burst Width [ms/hop/ch]	Total Hops [hop*ch]	Dwell Time [s]	Verdict
TM1_DH5_Ch39	2.900	106.67	0.309	Pass
TM2_2DH5_Ch39	2.900	106.67	0.309	Pass
TM3_3DH5_Ch39	2.900	106.67	0.309	Pass

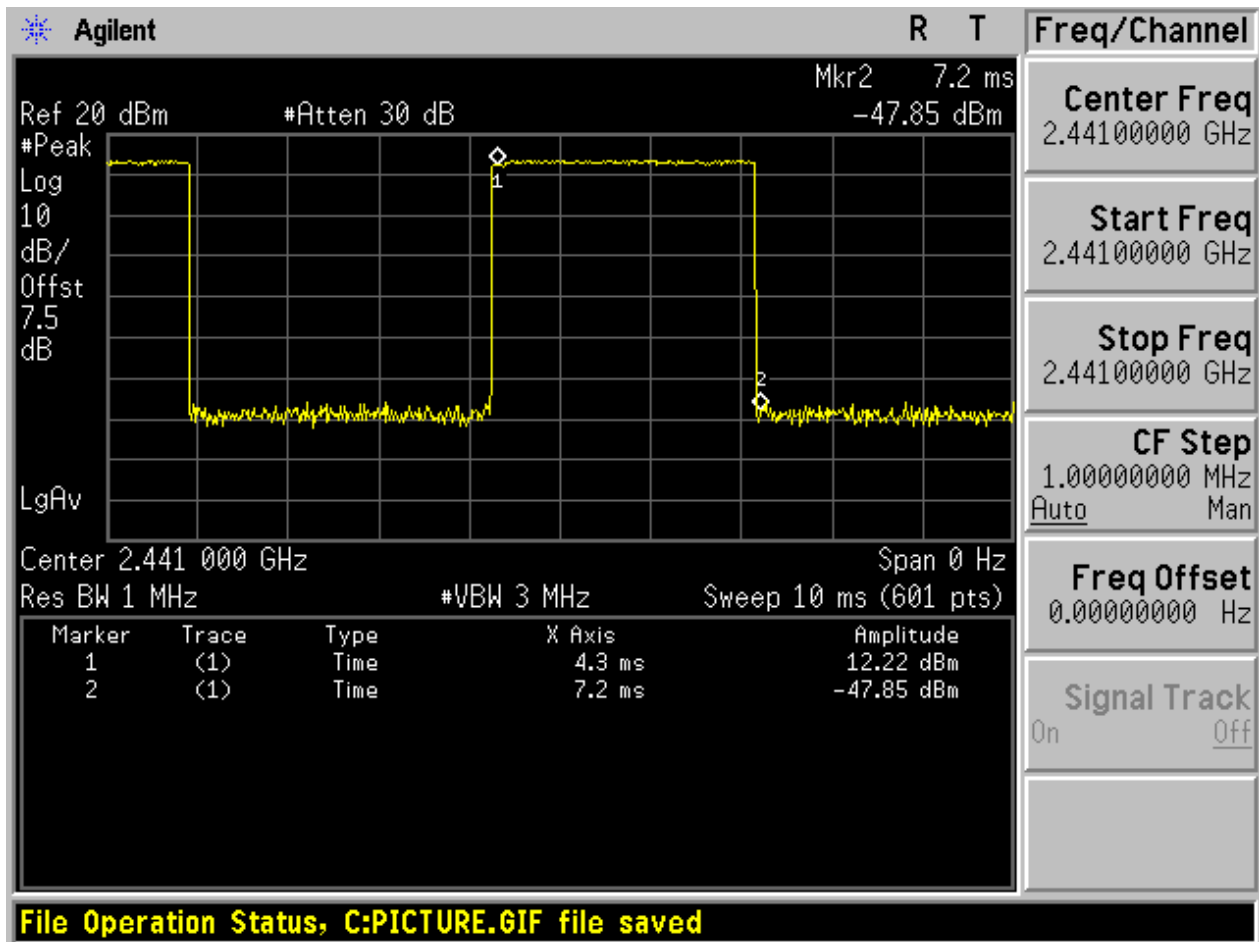
2 Test Plot

NOTE: The test plots are only for Burst Width measurements.

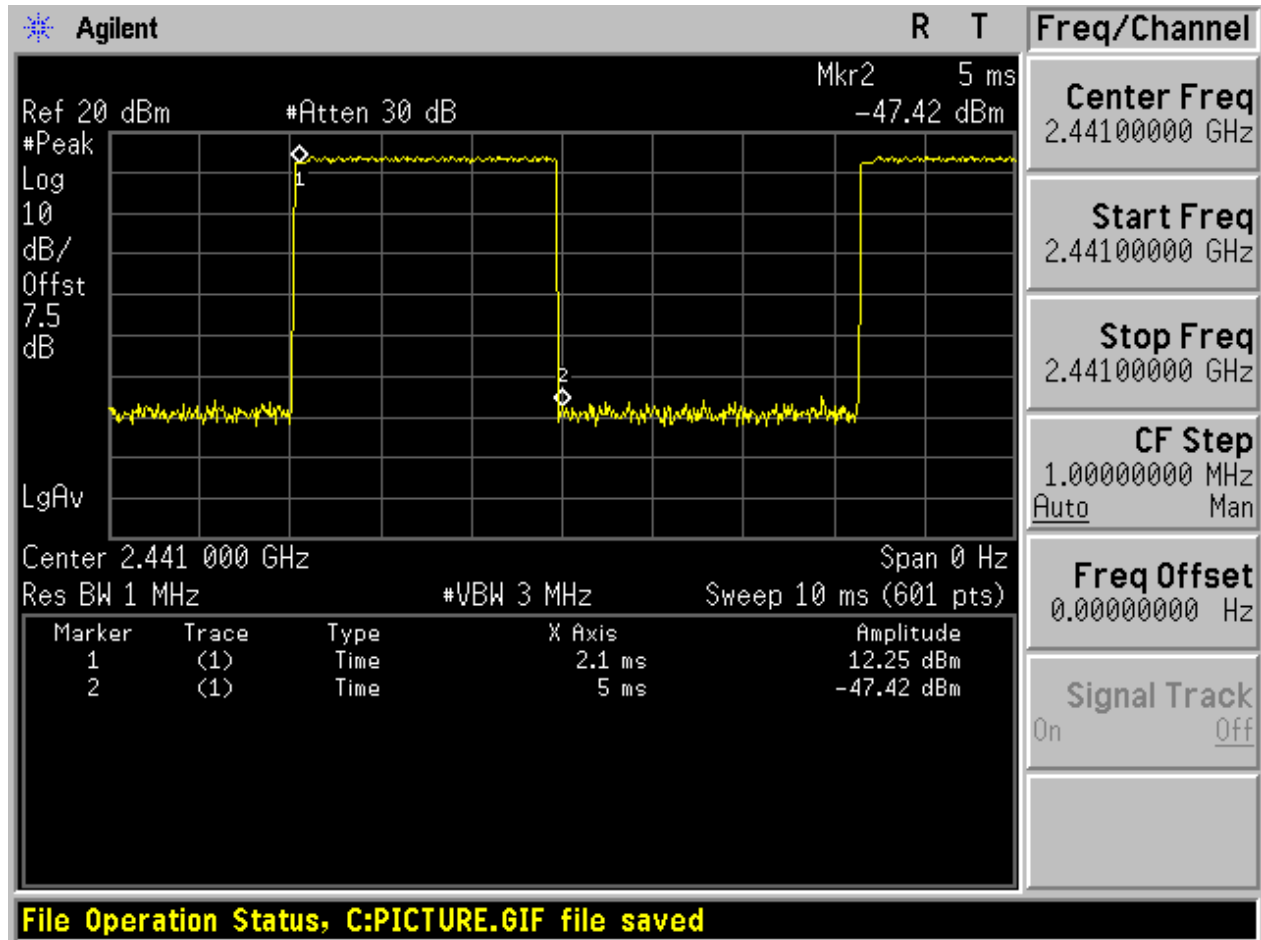
2.1 TM1_DH5_Ch39



2.2 TM2_2DH5_Ch39



2.3 TM3_3DH5_Ch39





Appendix E: Maximum Peak Conducted Output Power

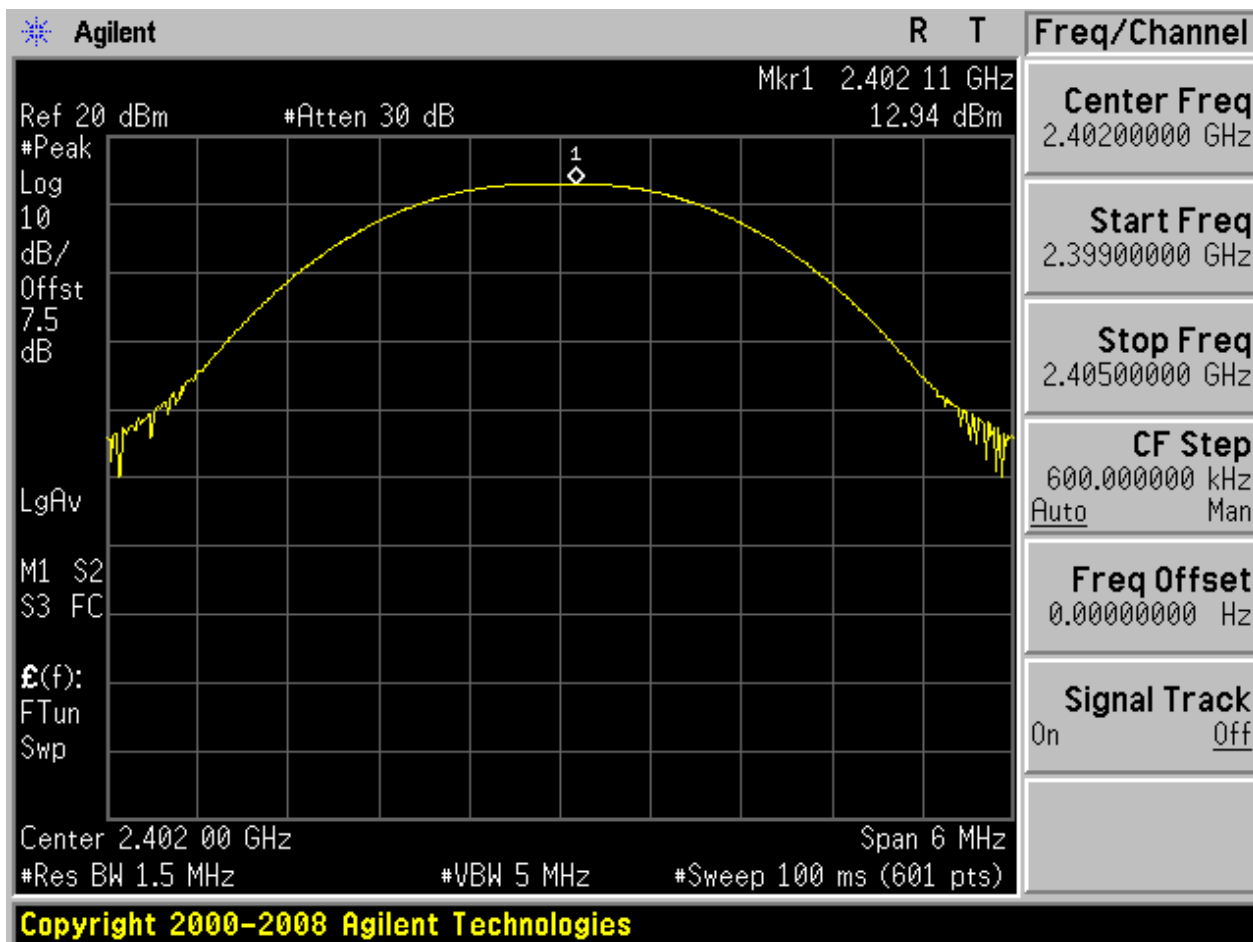


1 Result Table

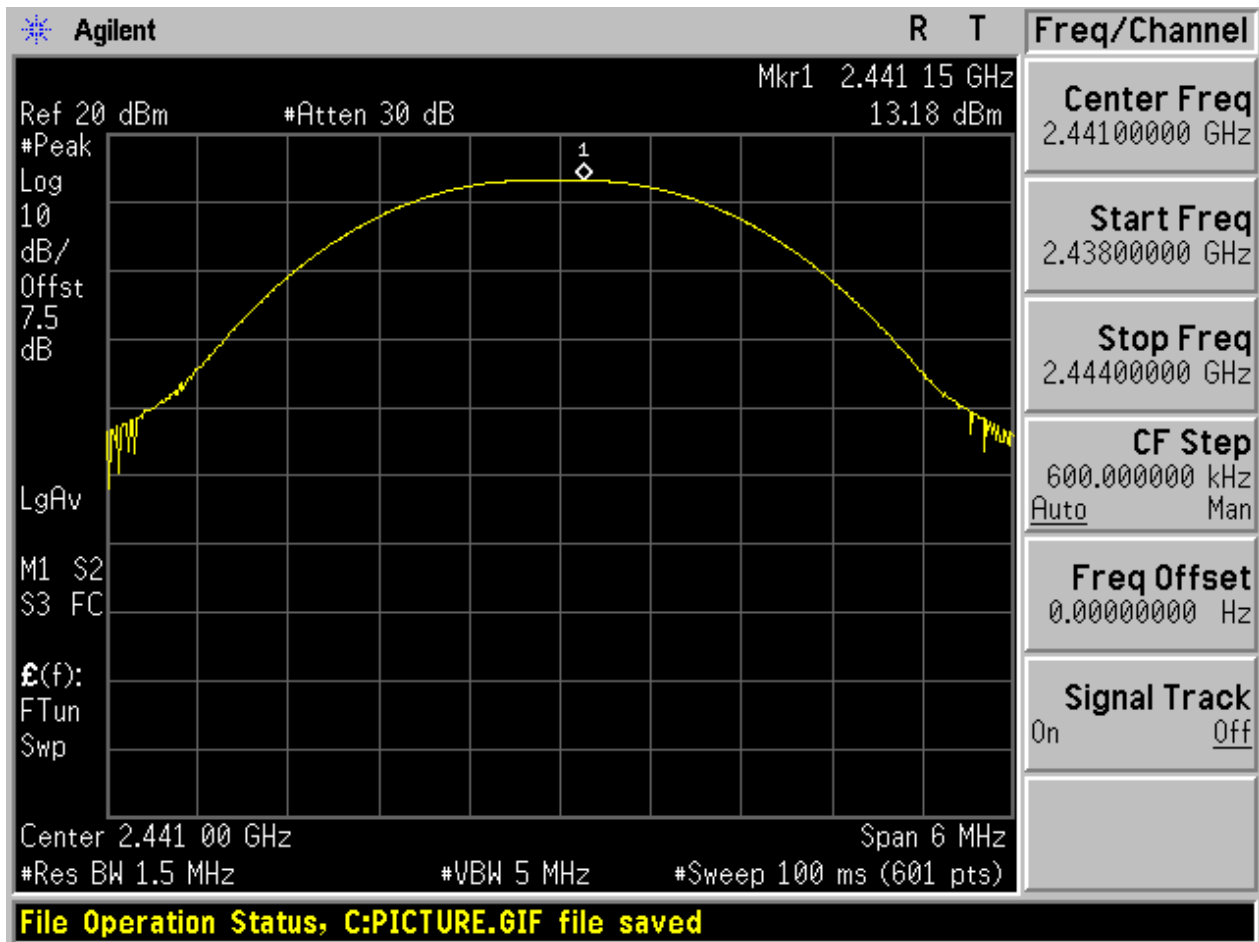
EUT Conf.	Max. Peak Power [dBm]	Verdict
TM1_DH5_Ch0	12.94	Pass
TM1_DH5_Ch39	13.18	Pass
TM1_DH5_Ch78	12	Pass
TM2_2DH5_Ch0	13.71	Pass
TM2_2DH5_Ch39	13.88	Pass
TM2_2DH5_Ch78	12.68	Pass
TM3_3DH5_Ch0	13.91	Pass
TM3_3DH5_Ch39	15.44	Pass
TM3_3DH5_Ch78	12.97	Pass

2 Test Plot

2.1 TM1_DH5_Ch0

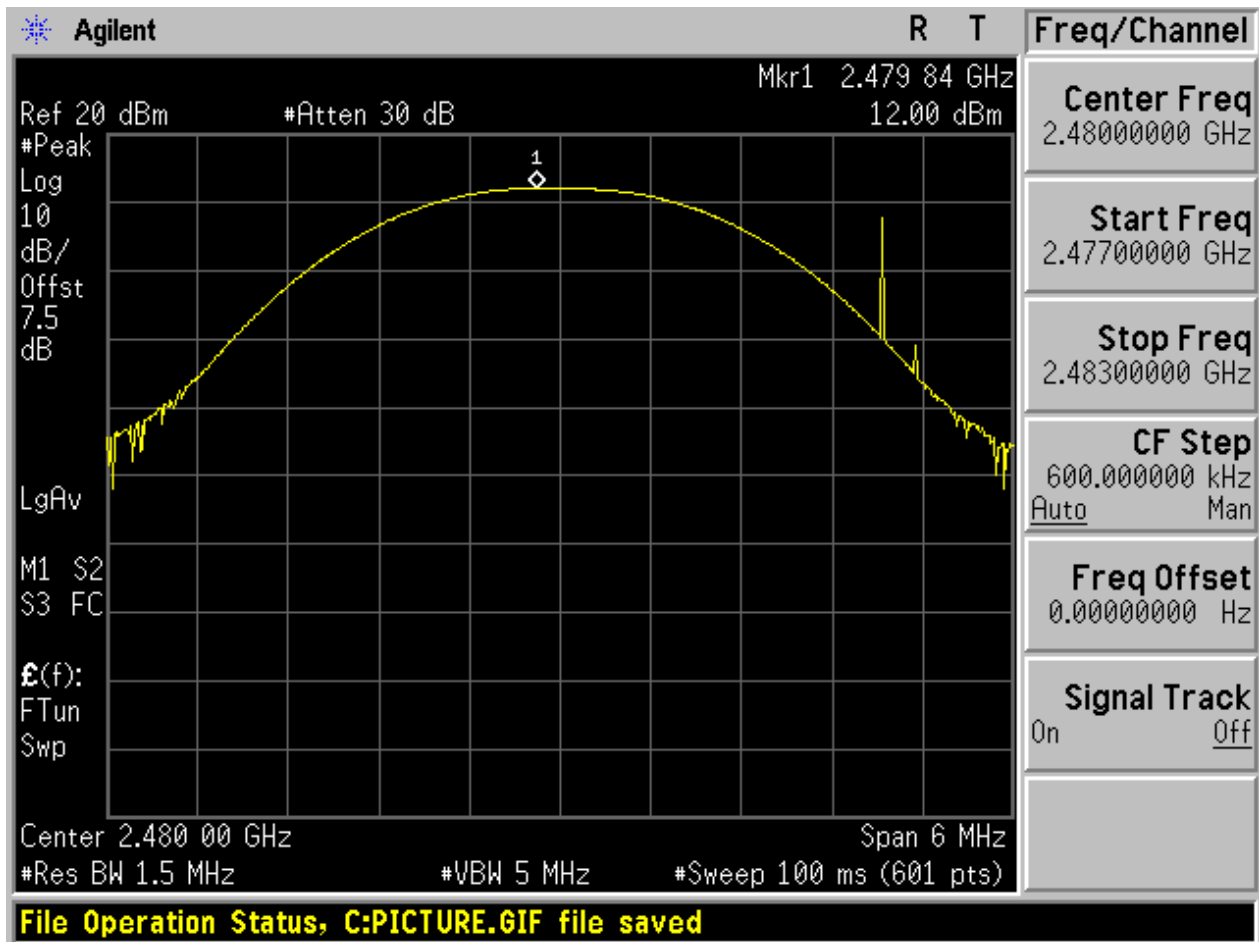


2.2 TM1_DH5_Ch39



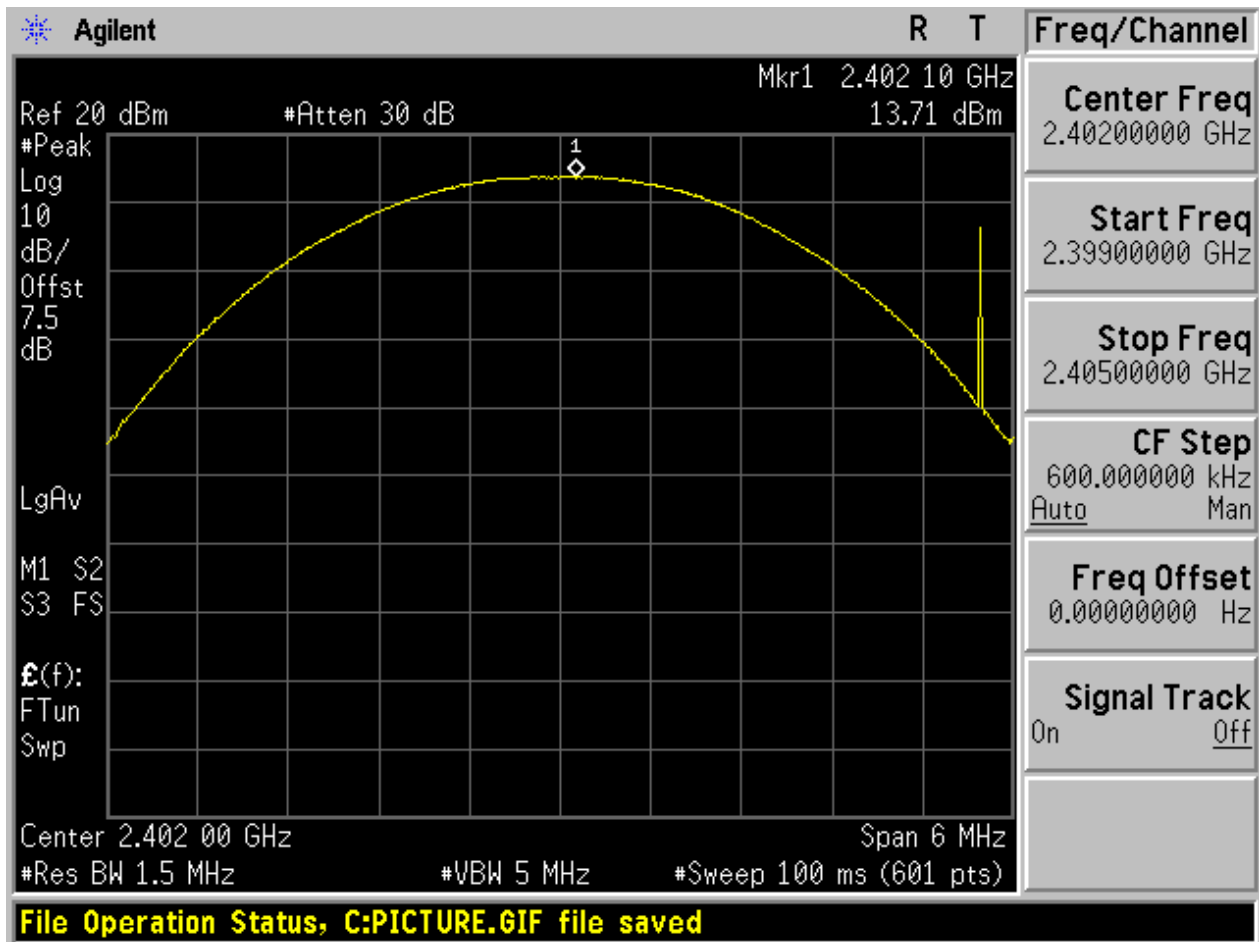


2.3 TM1_DH5_Ch78

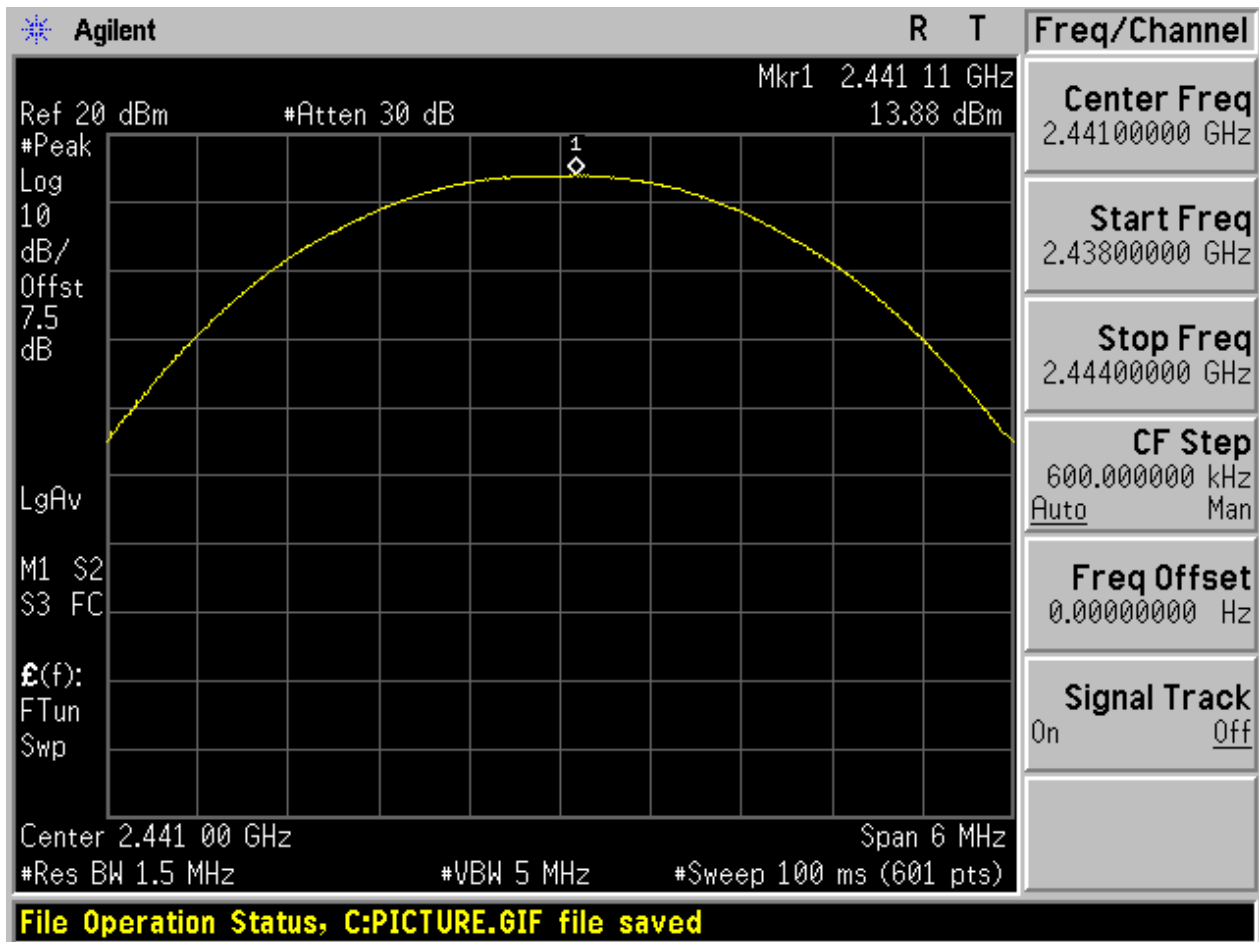




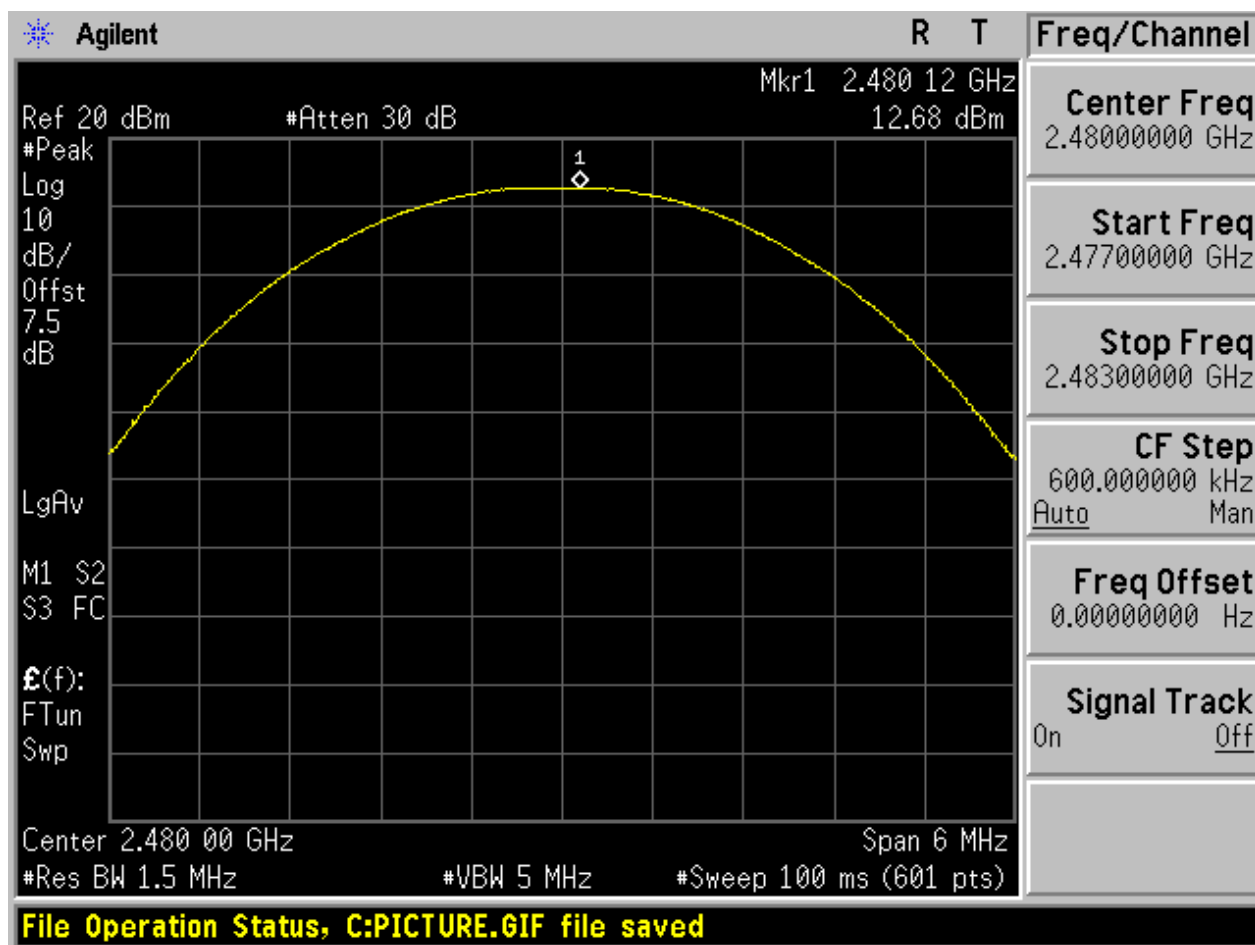
2.4 TM2_2DH5_Ch0



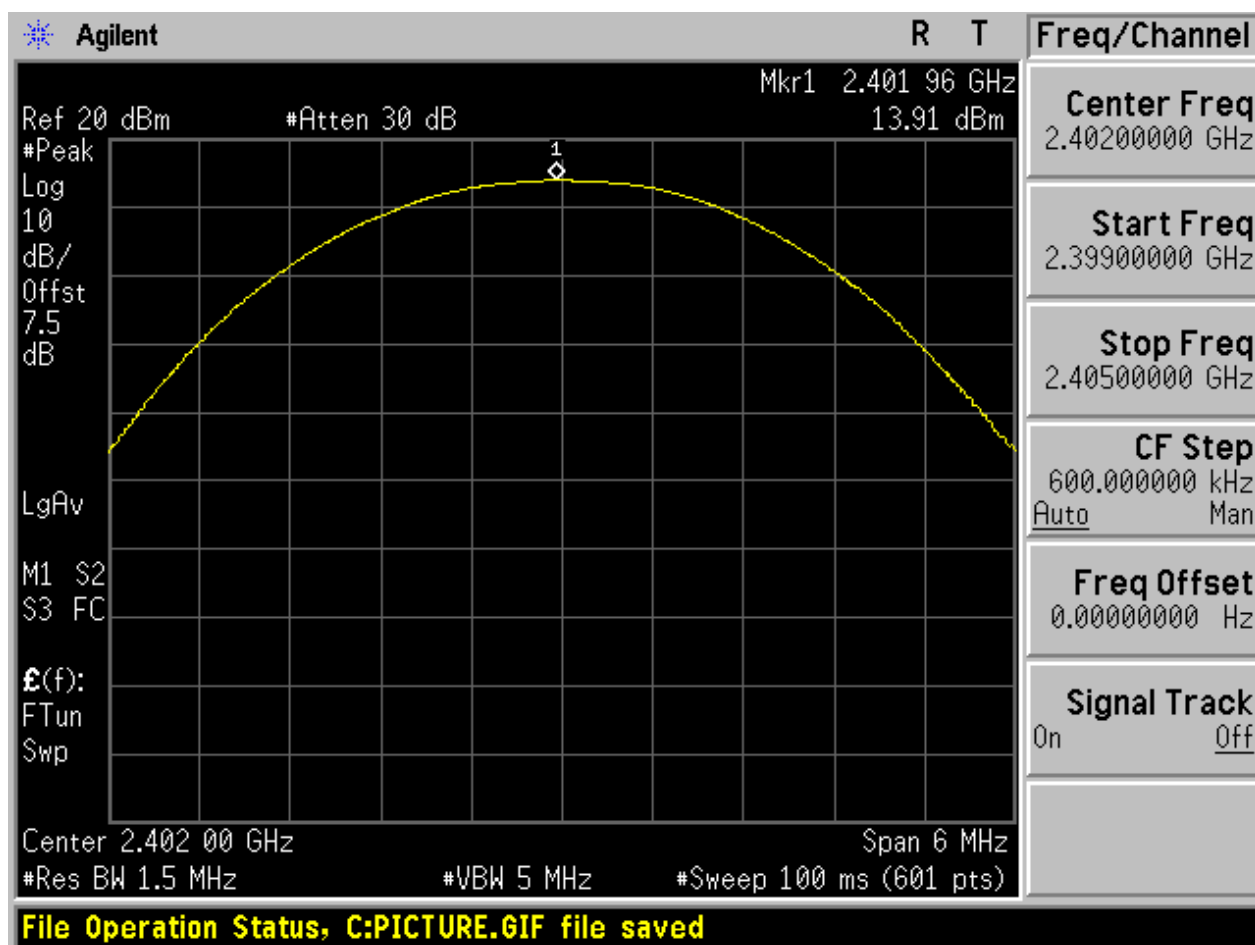
2.5 TM2_2DH5_Ch39



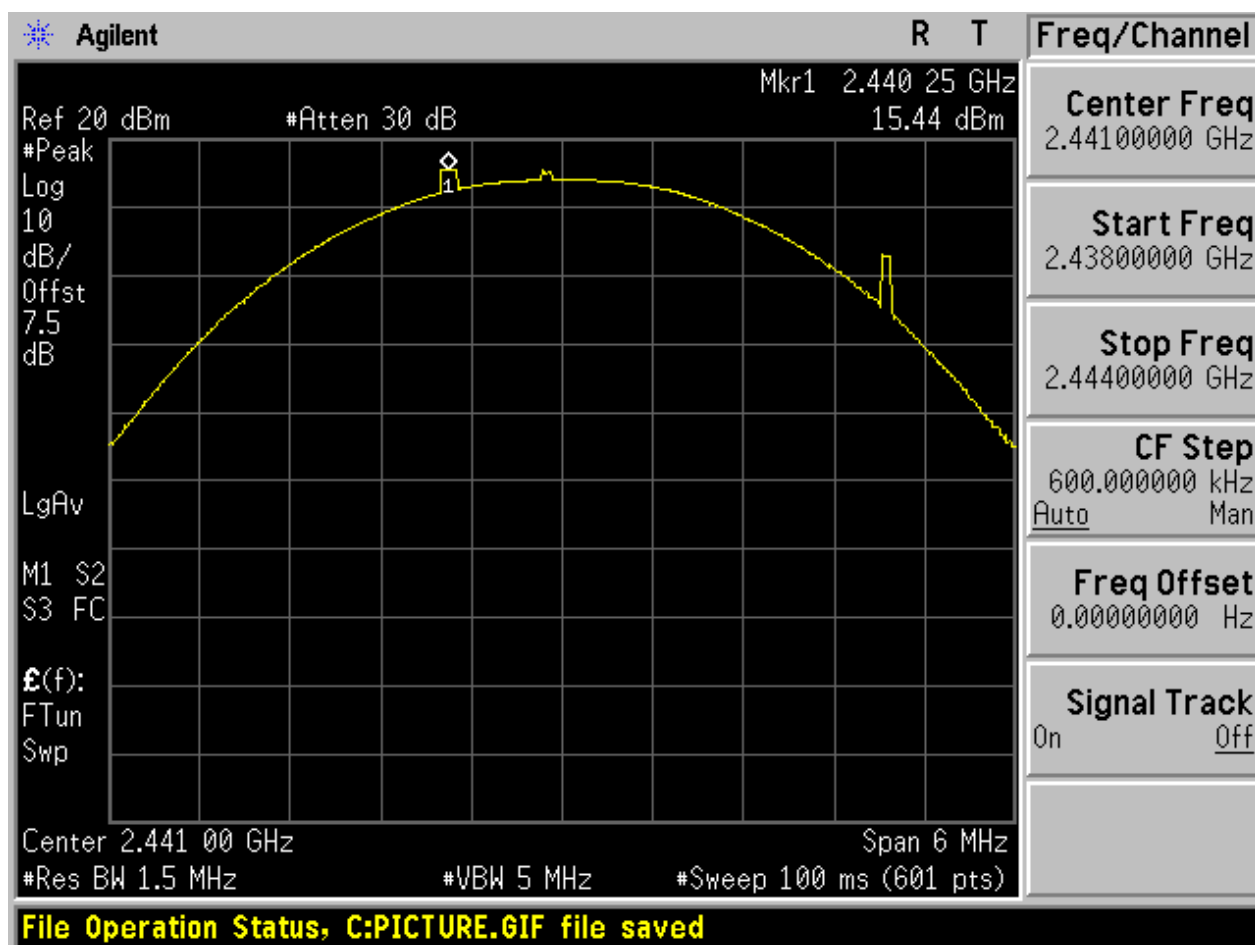
2.6 TM2_2DH5_Ch78



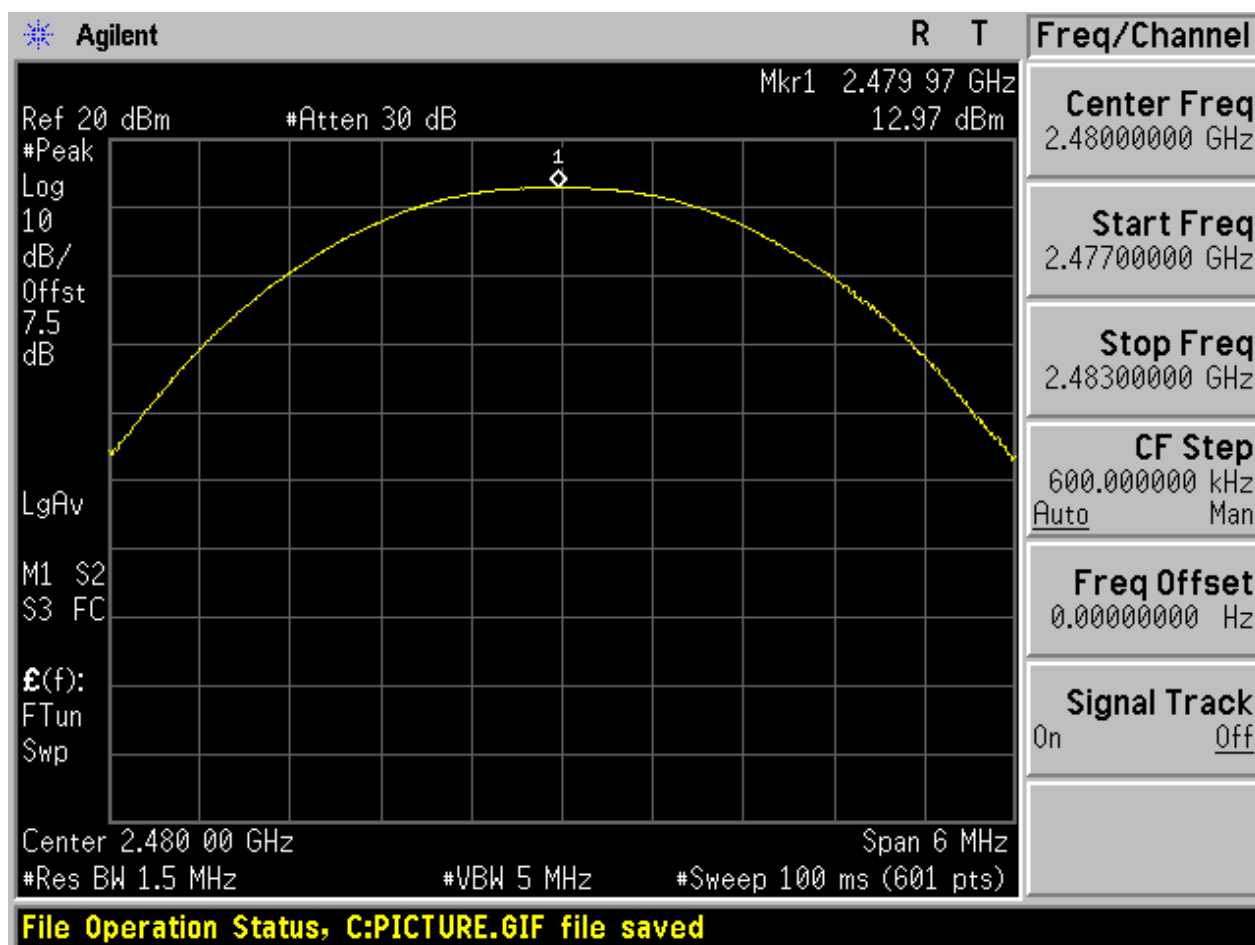
2.7 TM3_3DH5_Ch0



2.8 TM3_3DH5_Ch39



2.9 TM3_3DH5_Ch78





Appendix F: Band edge spurious emission



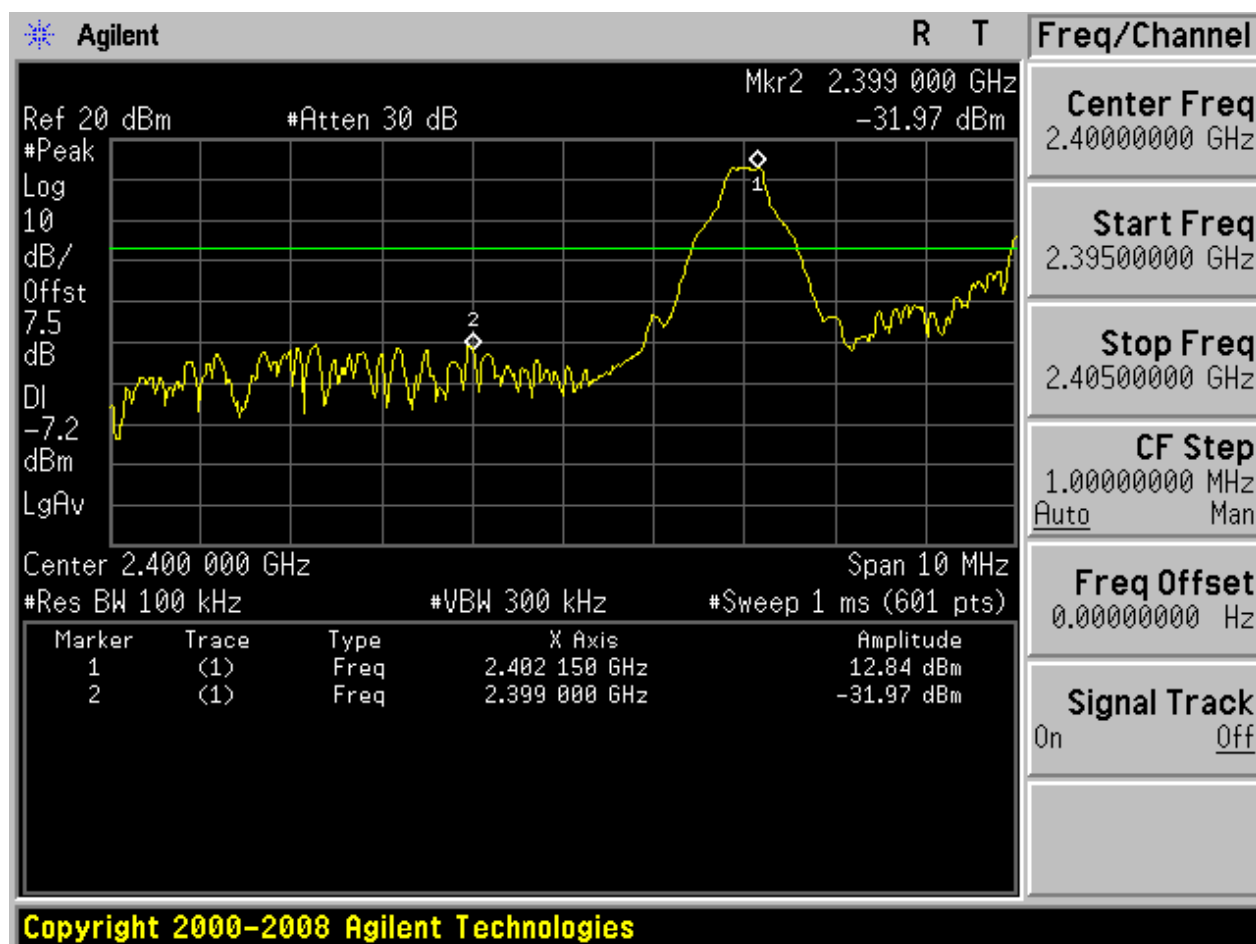
1 Result Table

EUT Conf.	Channel No.	Carrier Frequency [MHz]	Max. Spurious Level [dBm]	Frequency Hopping	Carrier Power [dBm]	Limit [dBm]	Result
TM1_DH5_Ch0	0	2402	-31.97	Off	12.84	-7.16	Pass
	-	-	-52.31	On	12.95	-7.05	Pass
TM1_DH5_Ch78	78	2480	-51.48	Off	11.72	-8.28	Pass
	-	-	-35.15	On	12.04	-7.96	Pass
TM2_2DH5_Ch0	0	2402	-39.5	Off	11.92	-8.08	Pass
	-	-	-37.4	On	9.77	-10.23	Pass
TM2_2DH5_Ch78	78	2480	-50.61	Off	10.86	-9.14	Pass
	-	-	-53.41	On	7.95	-12.05	Pass
TM3_3DH5_Ch0	0	2402	-29.62	Off	11.94	-8.06	Pass
	-	-	-50.92	On	11.64	-8.36	Pass
TM3_3DH5_Ch78	78	2480	-50.98	Off	10.88	-9.12	Pass
	-	-	-53.65	On	10.38	-9.62	Pass

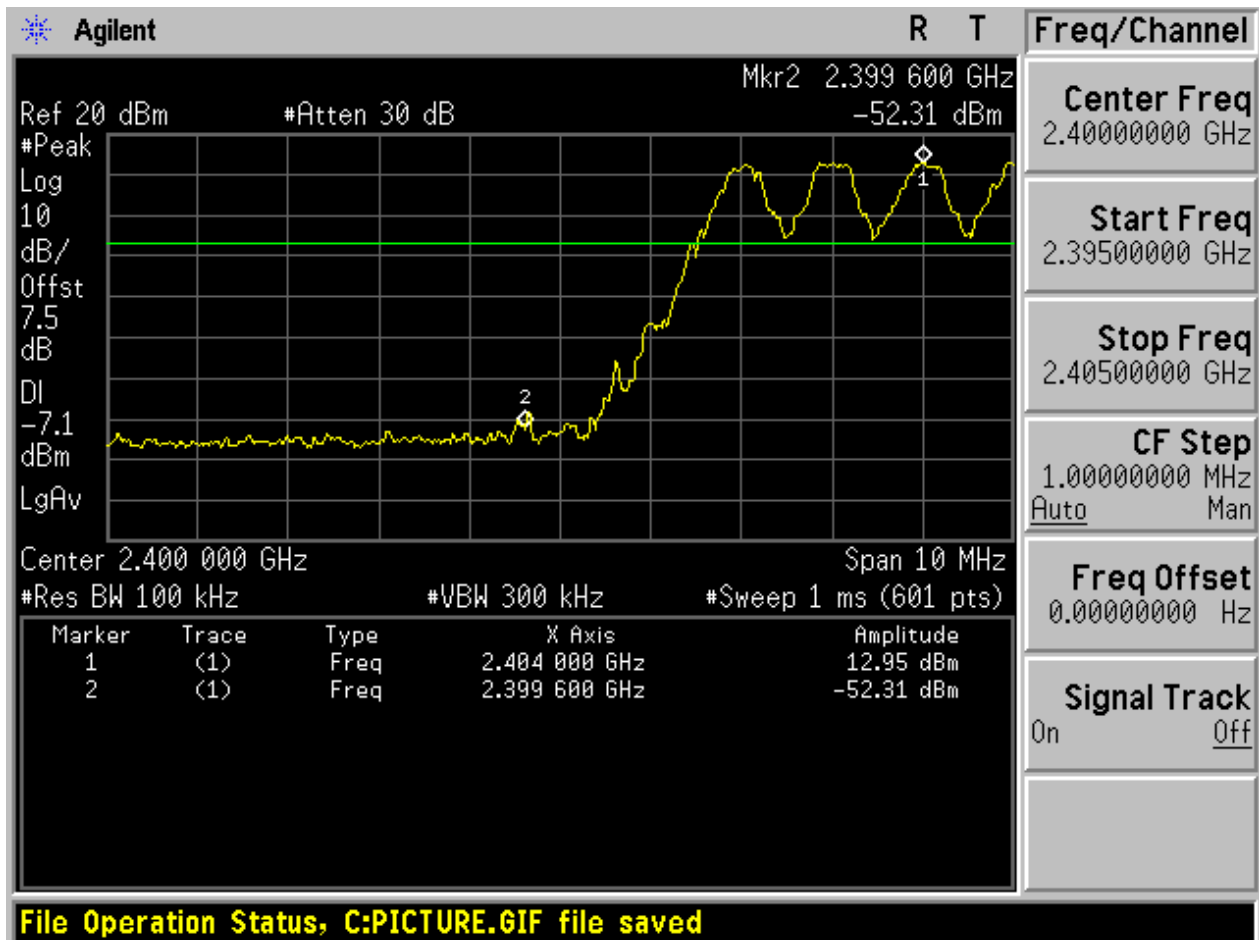
2 Test Plot

2.1 TM1_DH5_Ch0

No hopping

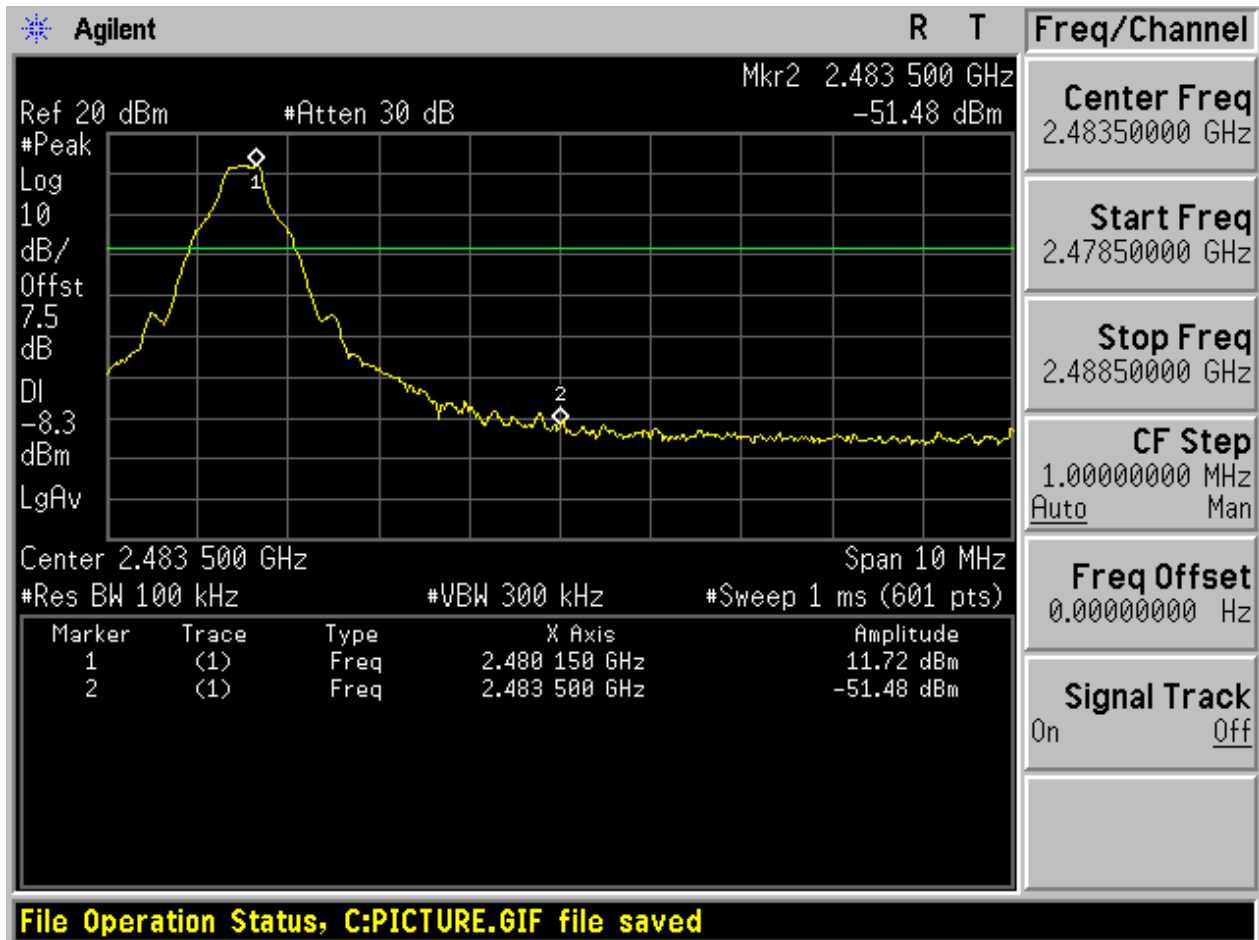


With hopping

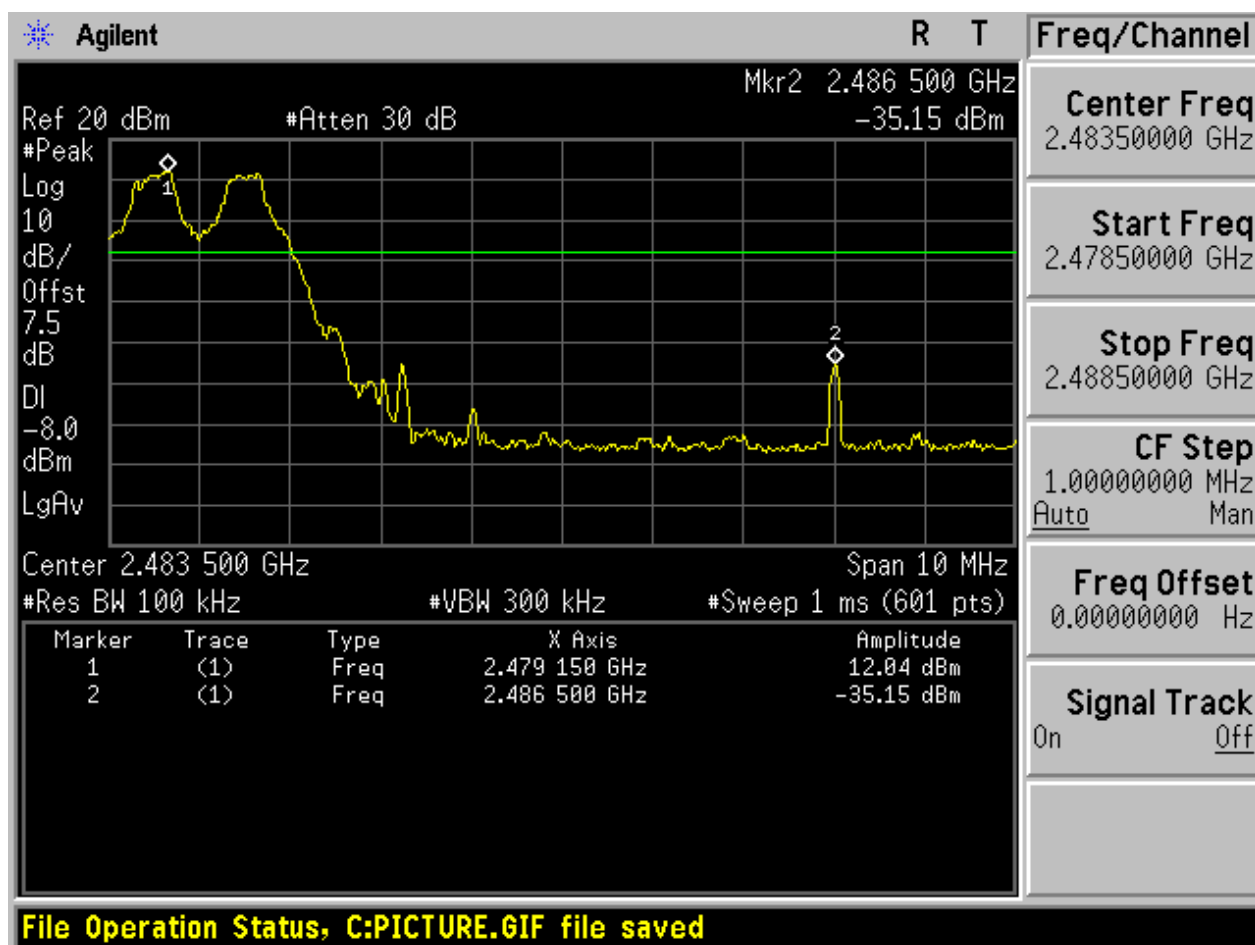


2.2 TM1_DH5_Ch78

No hopping

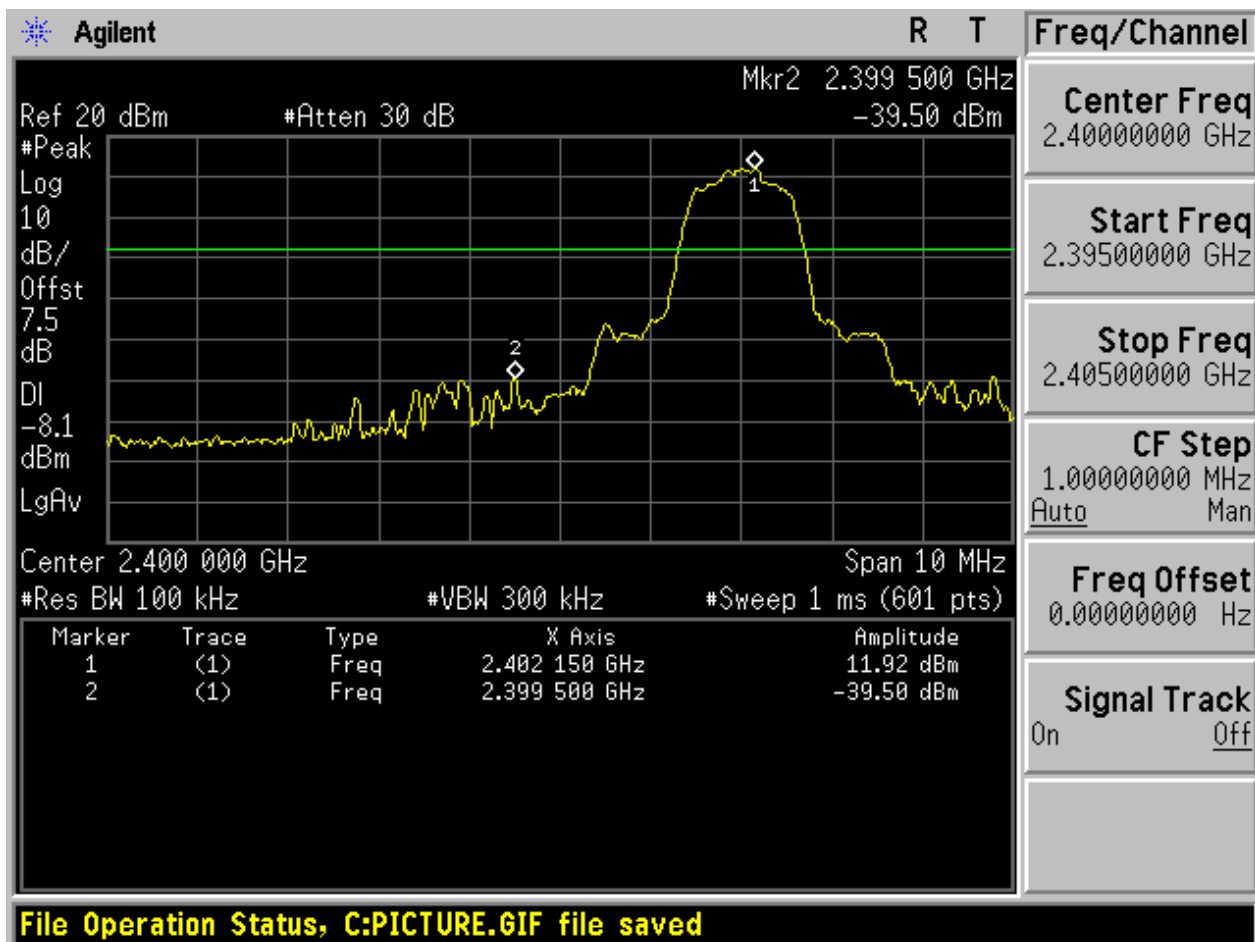


With hopping

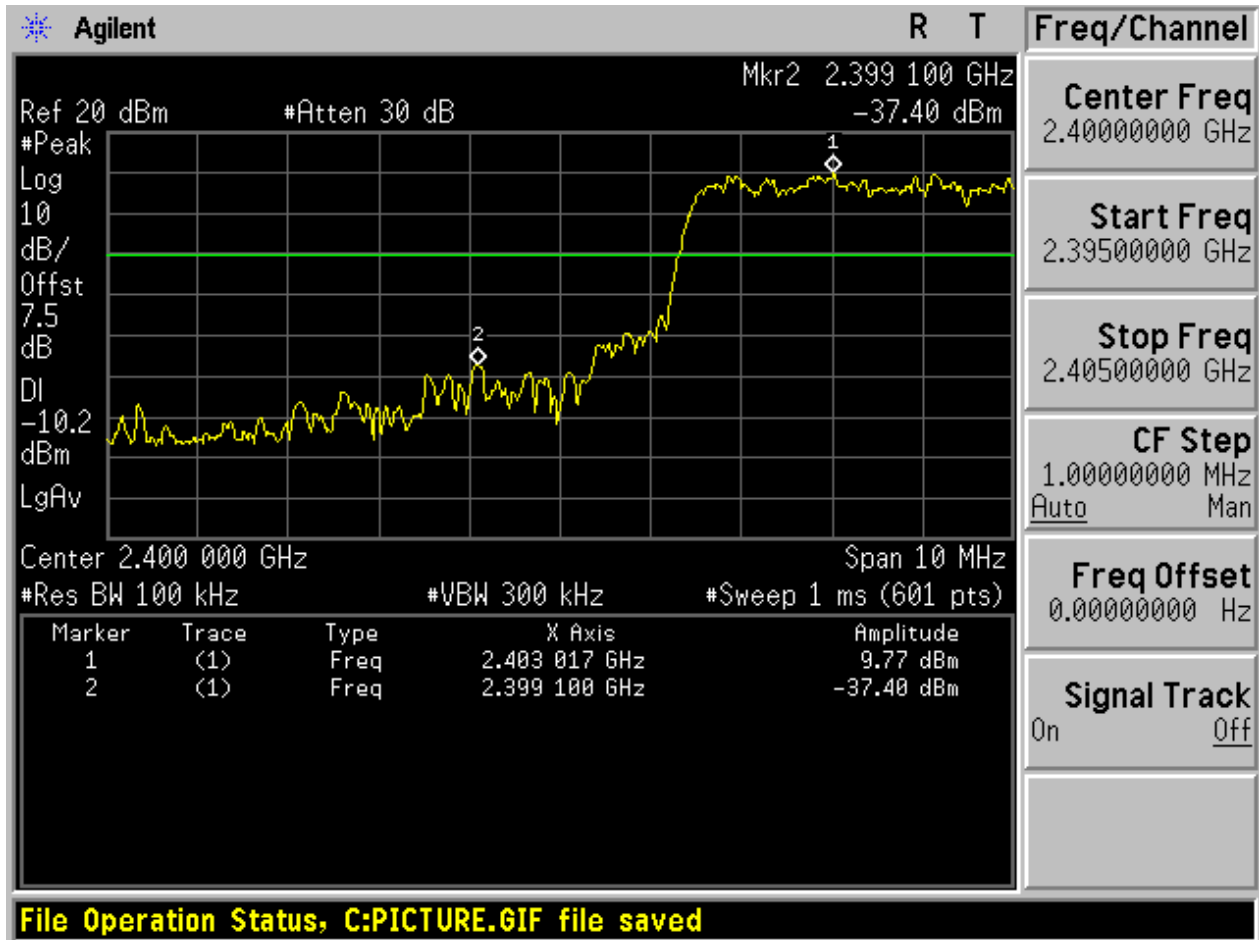


2.3 TM2_2DH5_Ch0

No hopping



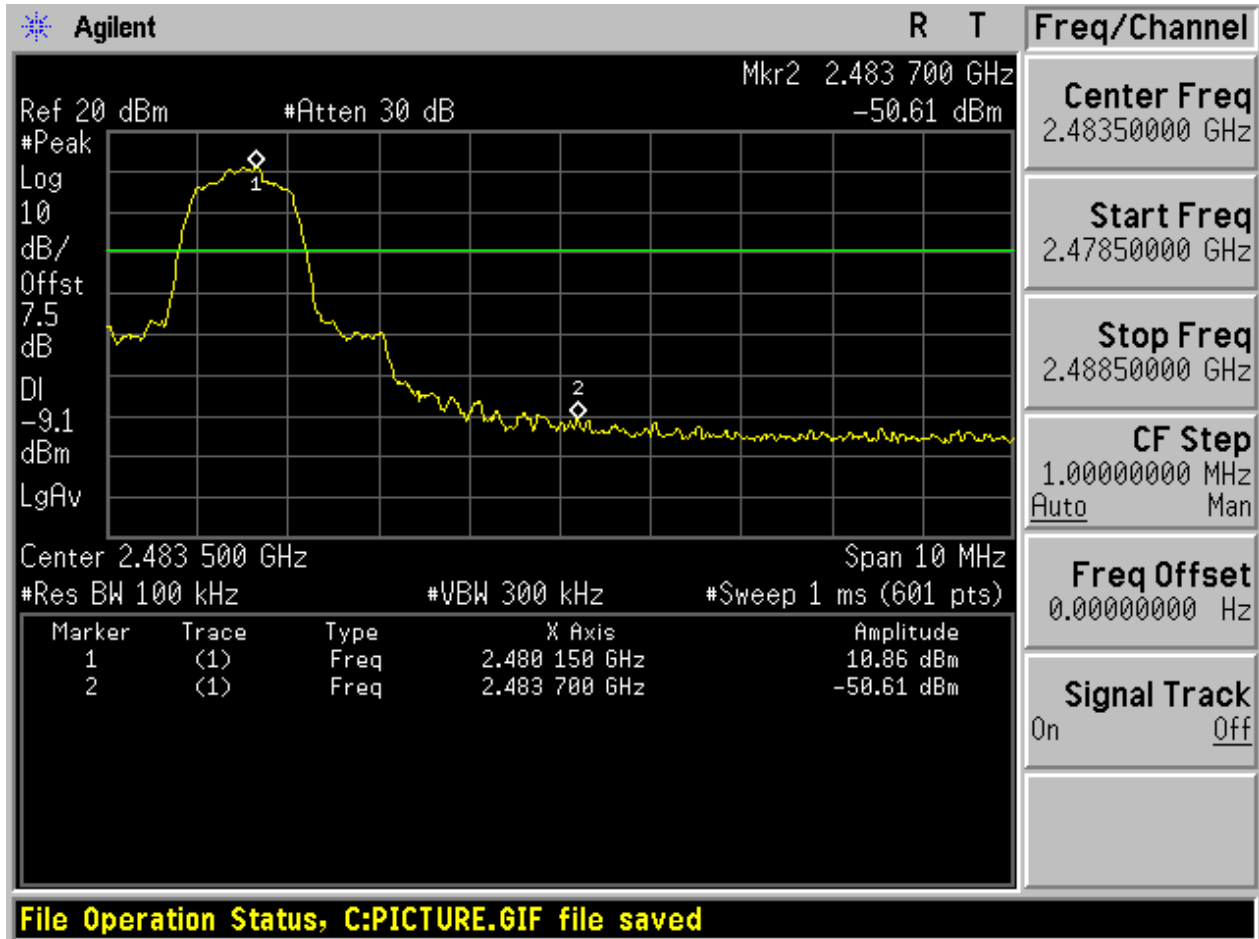
With hopping



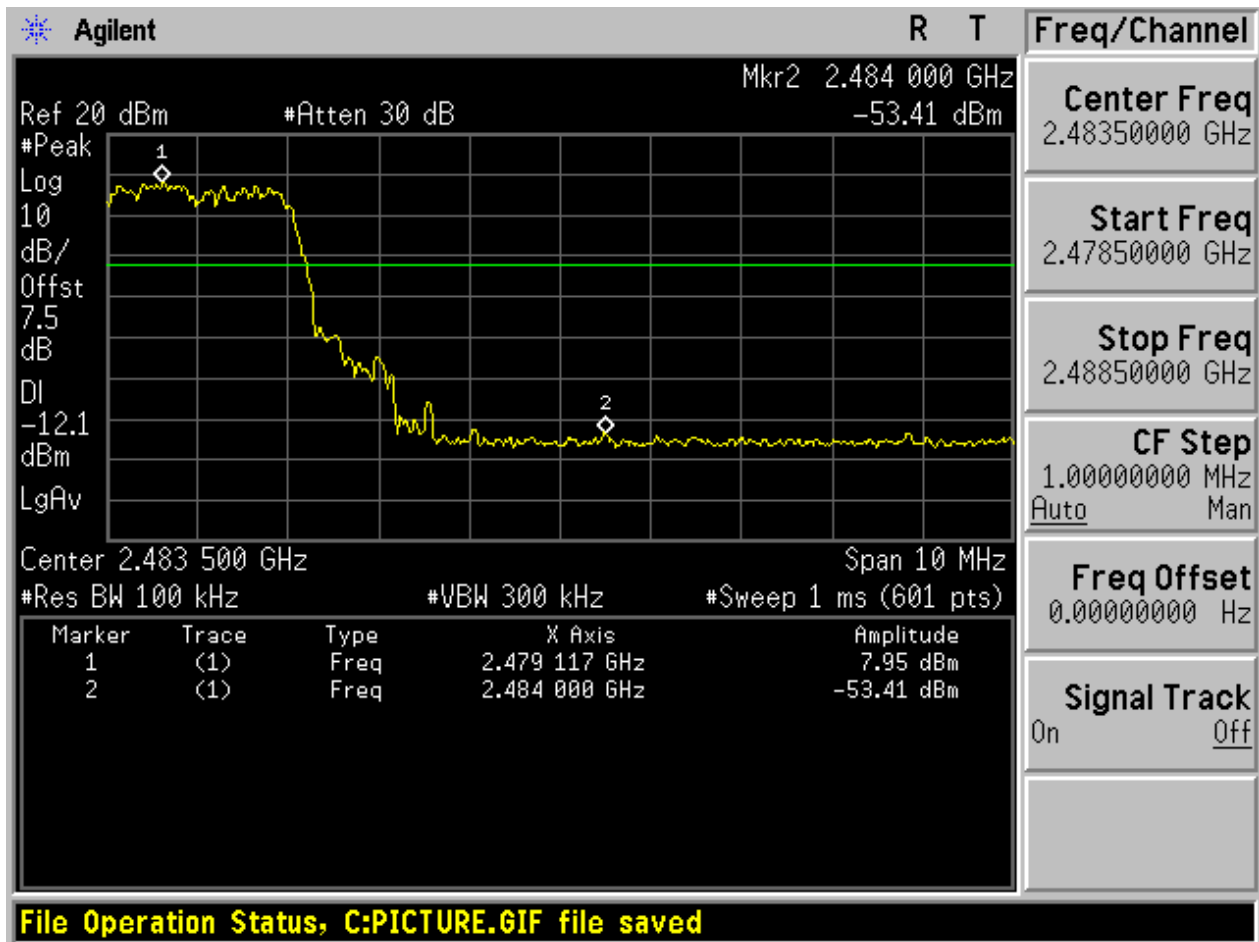


2.4 TM2_2DH5_Ch78

No hopping

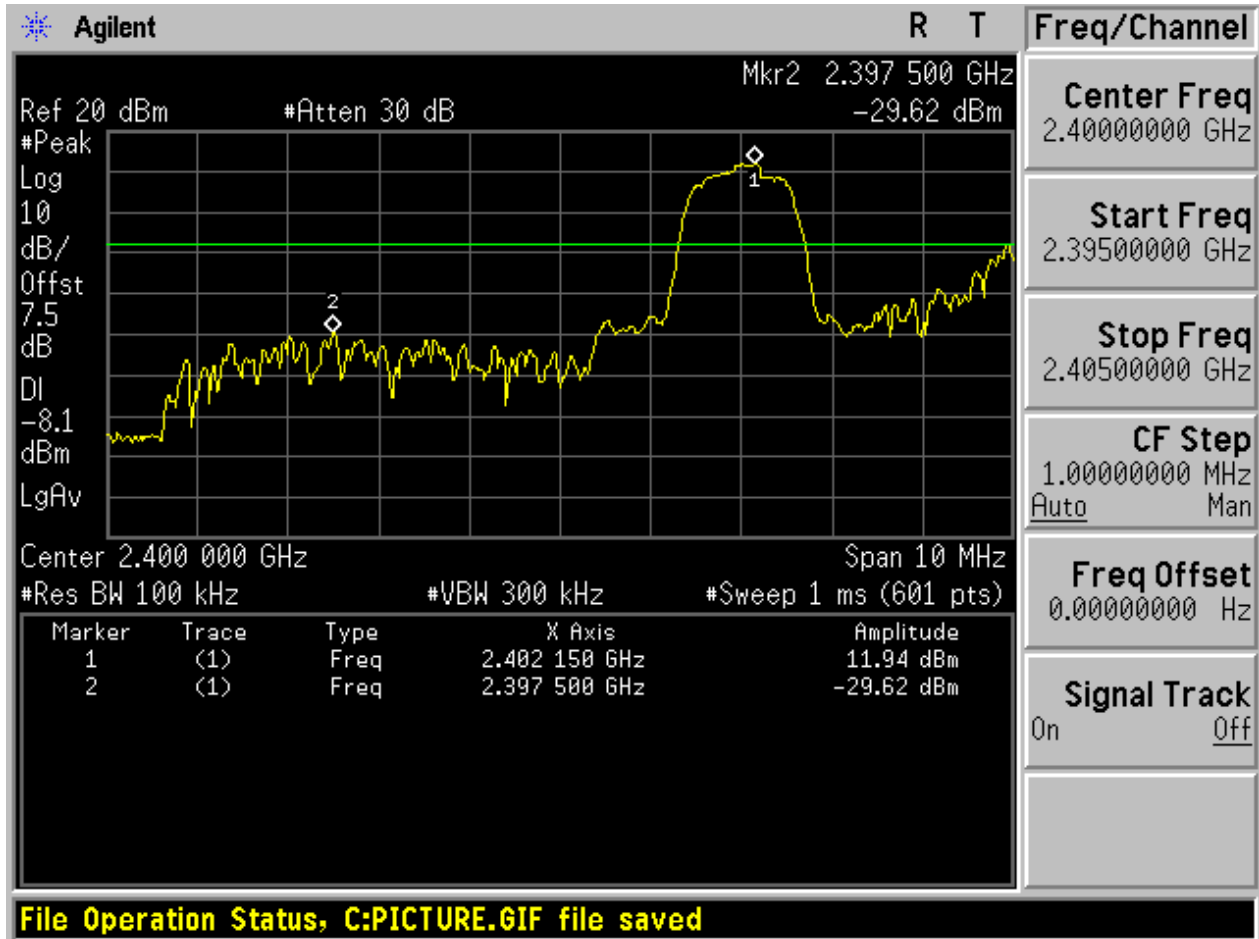


With hopping

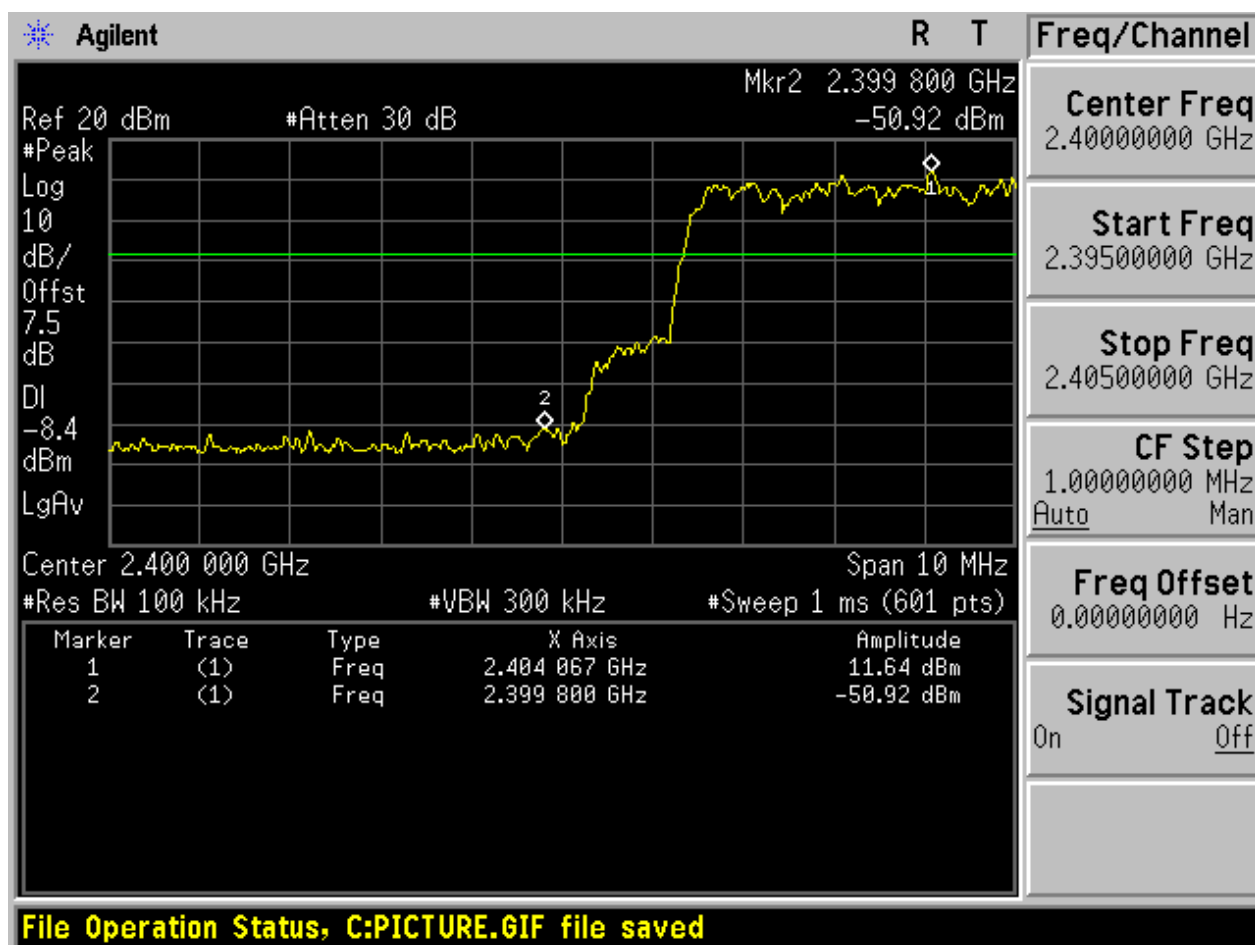


2.5 TM3_3DH5_Ch0

No hopping

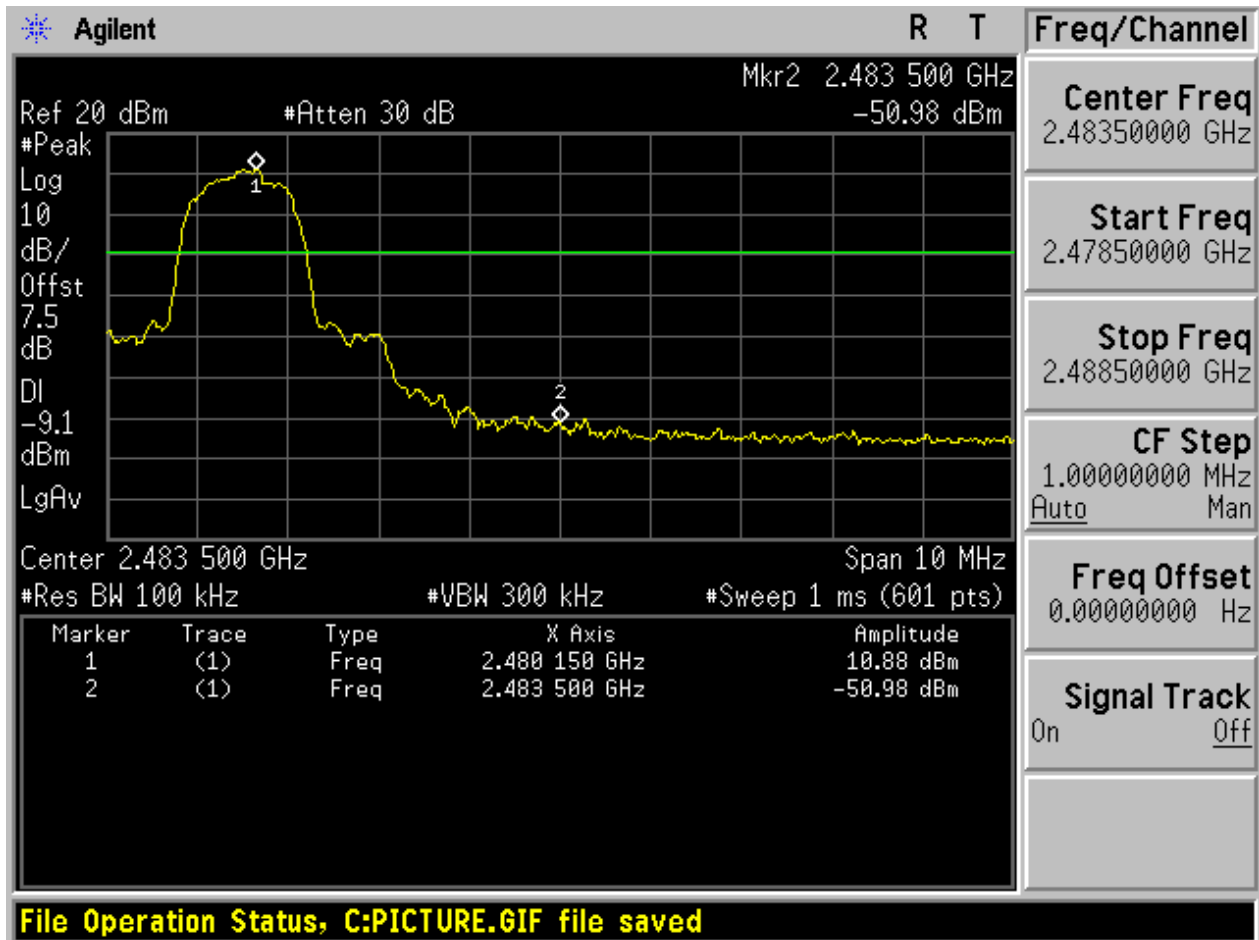


With hopping



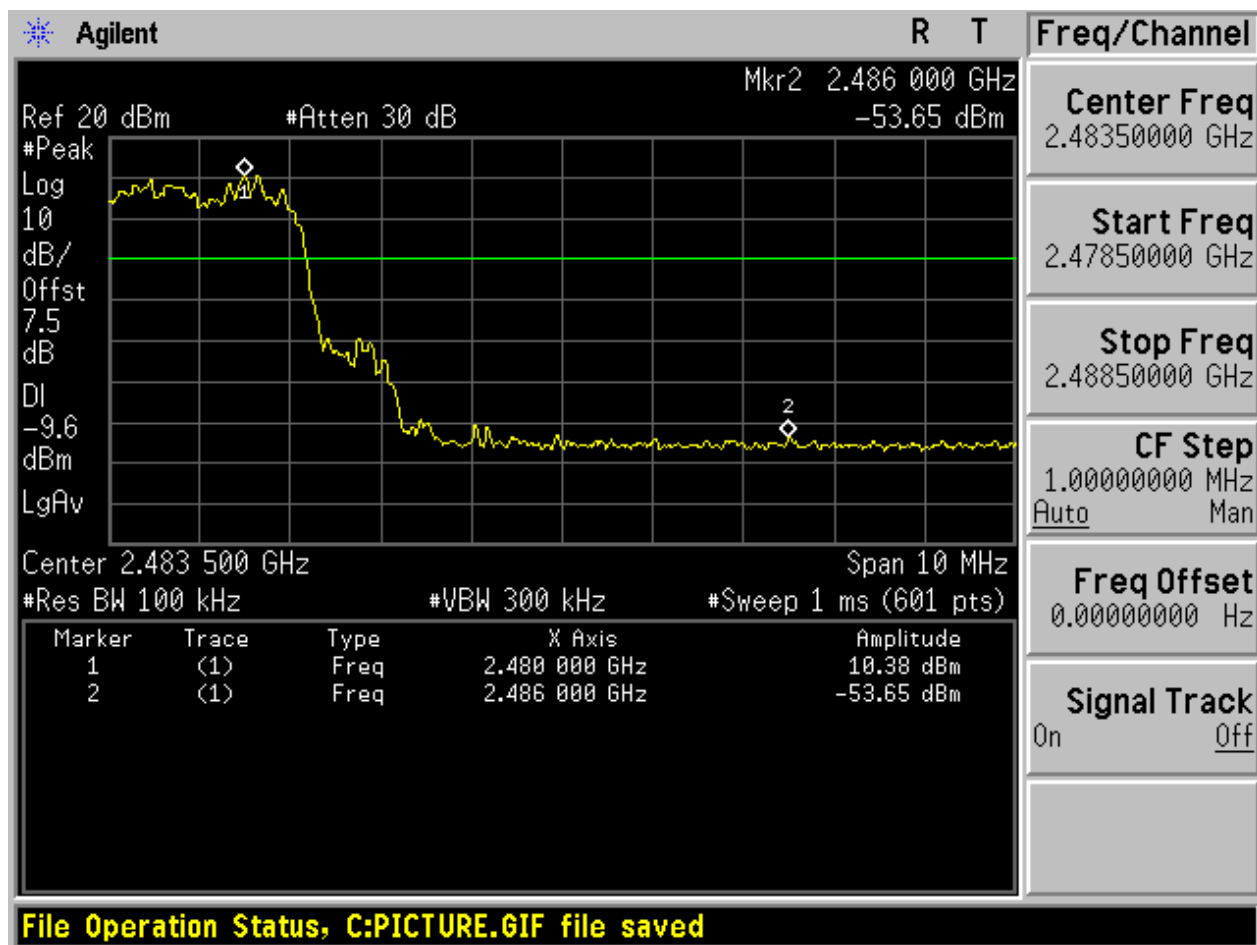
2.6 TM3_3DH5_Ch78

No hopping





With hopping





Appendix G: Conducted RF Spurious Emission

1 Result Table

In this Appendix, the “Pref” refers to the peak power level in any 100 kHz bandwidth within the fundamental emission which is used as the reference level, the “Puw” refers to the maximum emission power in 100 kHz band segments outside of the authorized frequency band.

Considering that the higher ratio of RBW to the span for the frequency ranges below 30 MHz makes the results determination be complicated, a narrower RBW other than 100 kHz is used for these ranges. The measured value should add a RBW correction factor (RBWCF) where $RBWCF [dB] = 10 \times \lg(100 [kHz]/\text{narrower RBW} [kHz])$. As to this Appendix, the narrower RBW is 1 kHz and RBWCF is 20 dB for the frequency 9 kHz to 150 kHz, and the narrower RBW is 10 kHz and RBWCF is 10 dB for the frequency 150 kHz to 30 MHz.

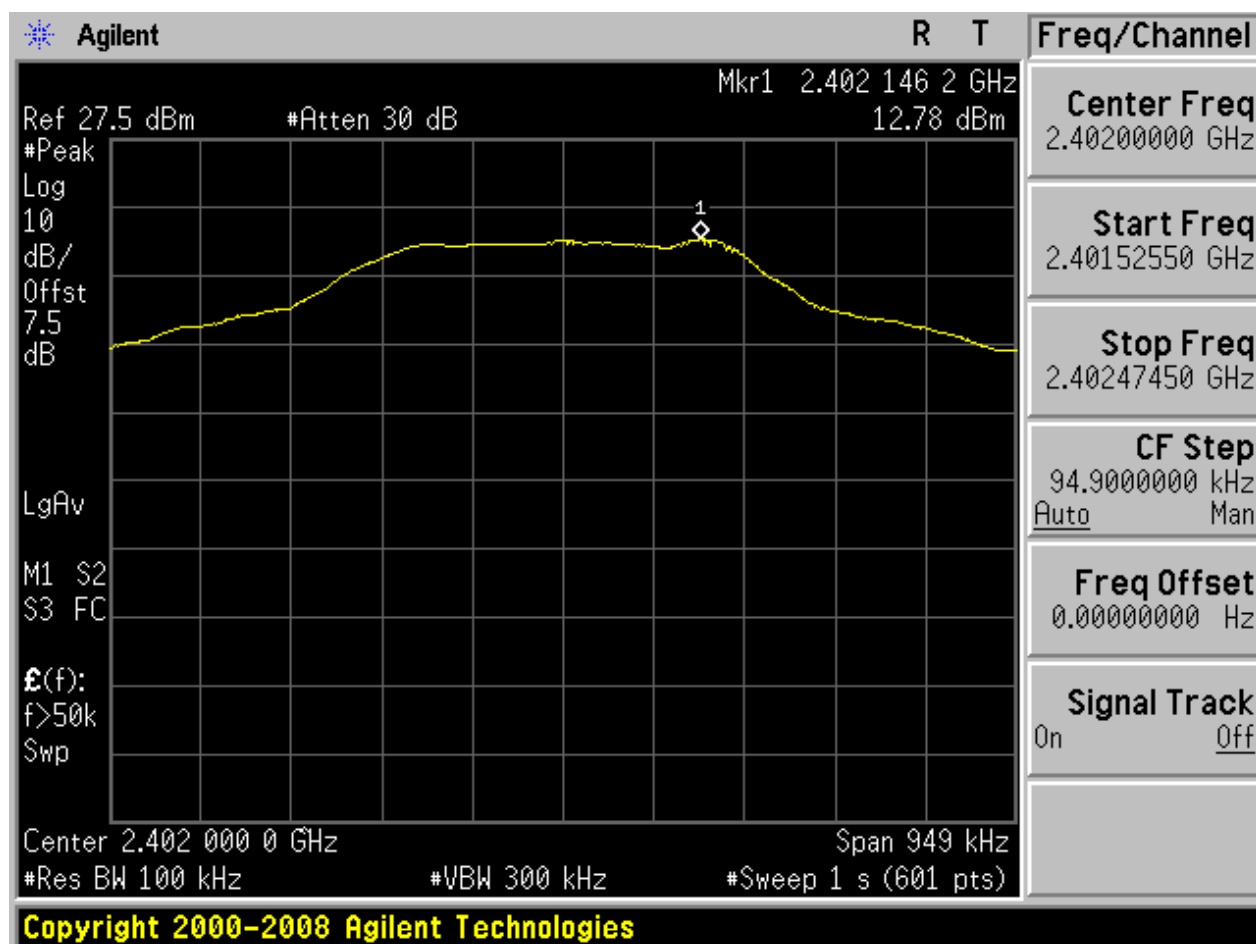
In the result table, the “< Limit” denotes that “The Puw [dBm] is less than Pref [dBm] - 20 [dB], see test plots for detailed”.

EUT Conf.	Pref [dBm/100 kHz]	Puw [dBm/100 kHz]	Verdict
TM1_DH5_Ch0	12.78	< Limit	Pass
TM1_DH5_Ch39	12.98	< Limit	Pass
TM1_DH5_Ch78	11.75	< Limit	Pass
TM2_2DH5_Ch0	11.87	< Limit	Pass
TM2_2DH5_Ch39	12.17	< Limit	Pass
TM2_2DH5_Ch78	10.85	< Limit	Pass
TM3_3DH5_Ch0	11.87	< Limit	Pass
TM3_3DH5_Ch39	12.17	< Limit	Pass
TM3_3DH5_Ch78	10.86	< Limit	Pass

2 Test Plot

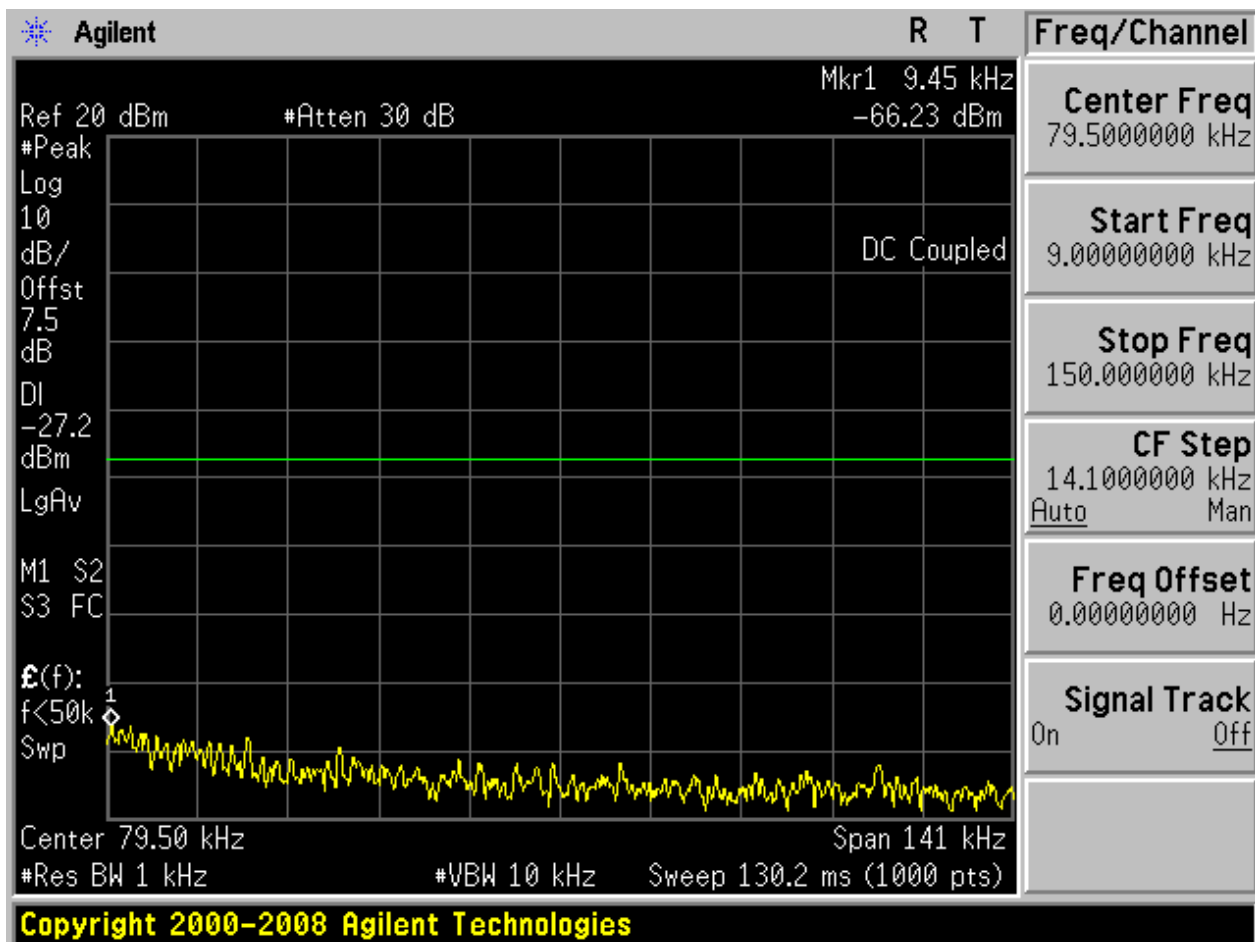
2.1 TM1_DH5_Ch0

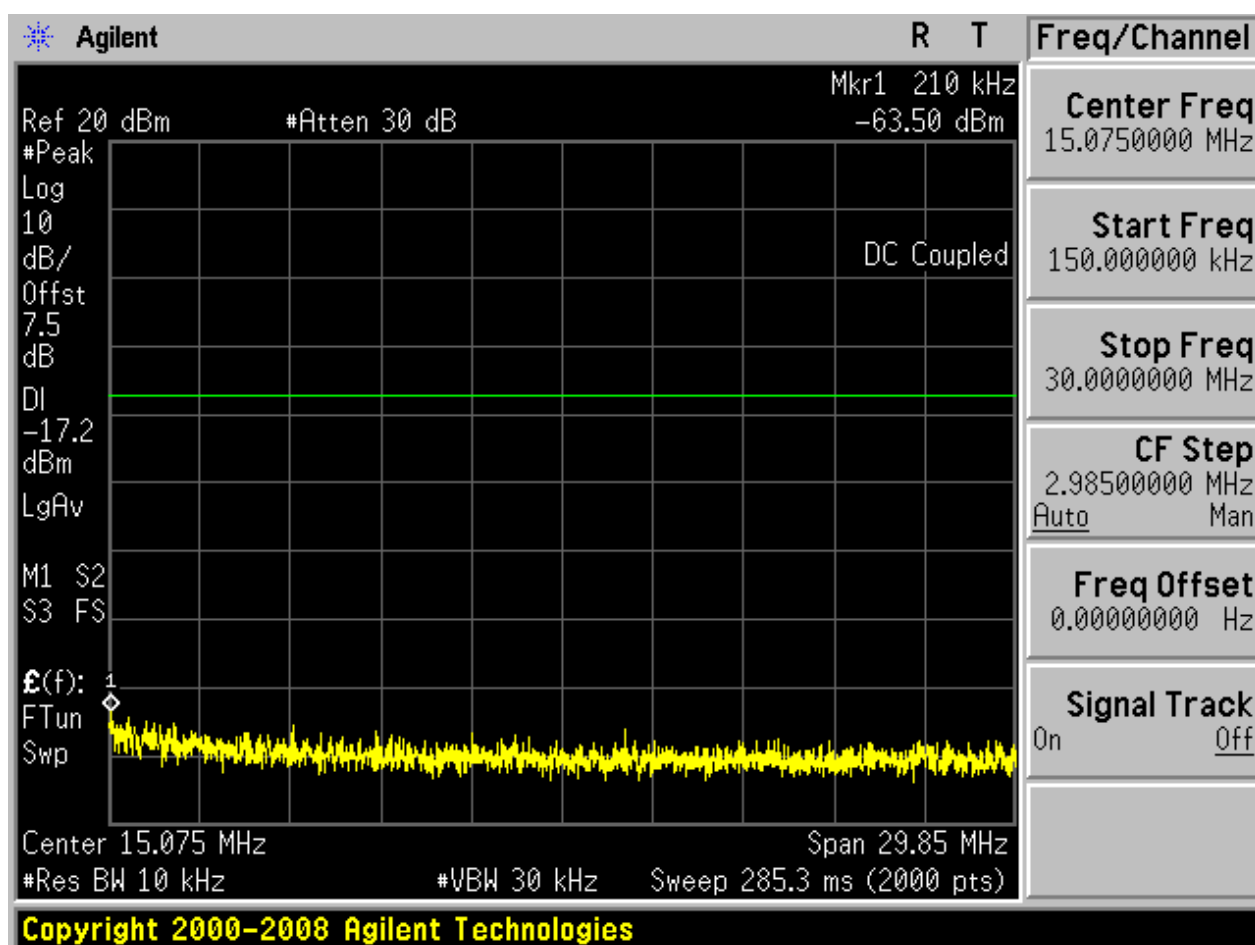
2.1.1 Pref

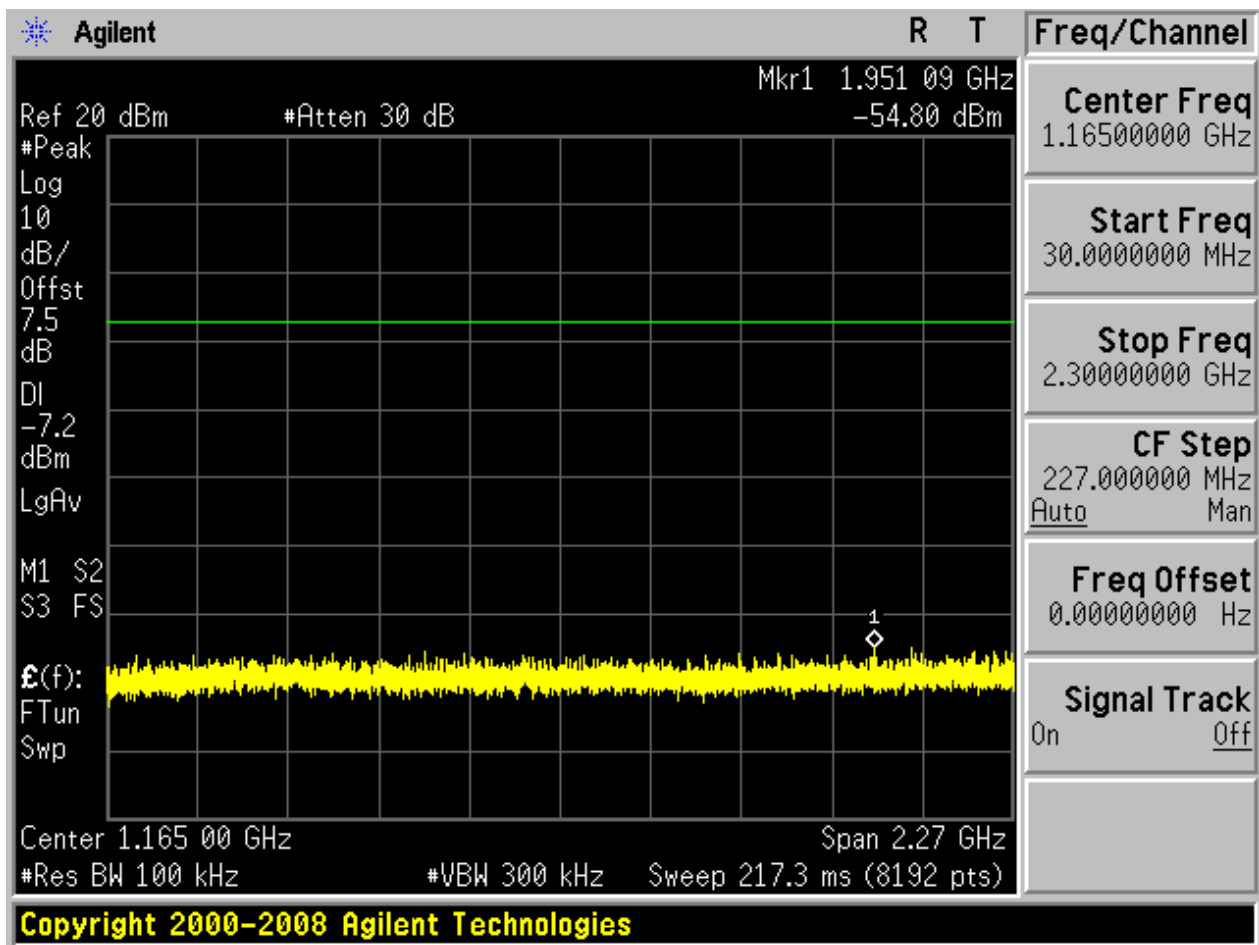


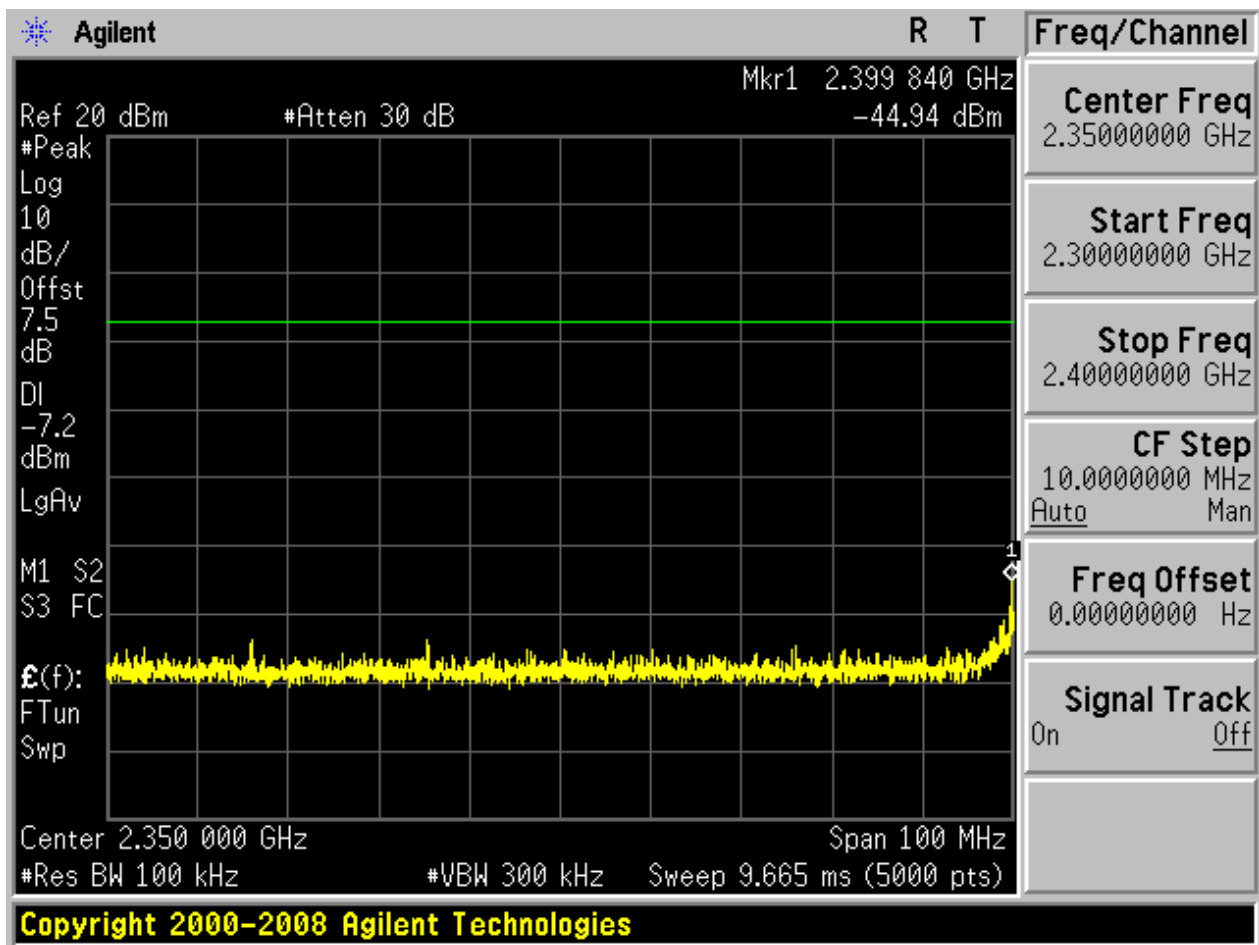


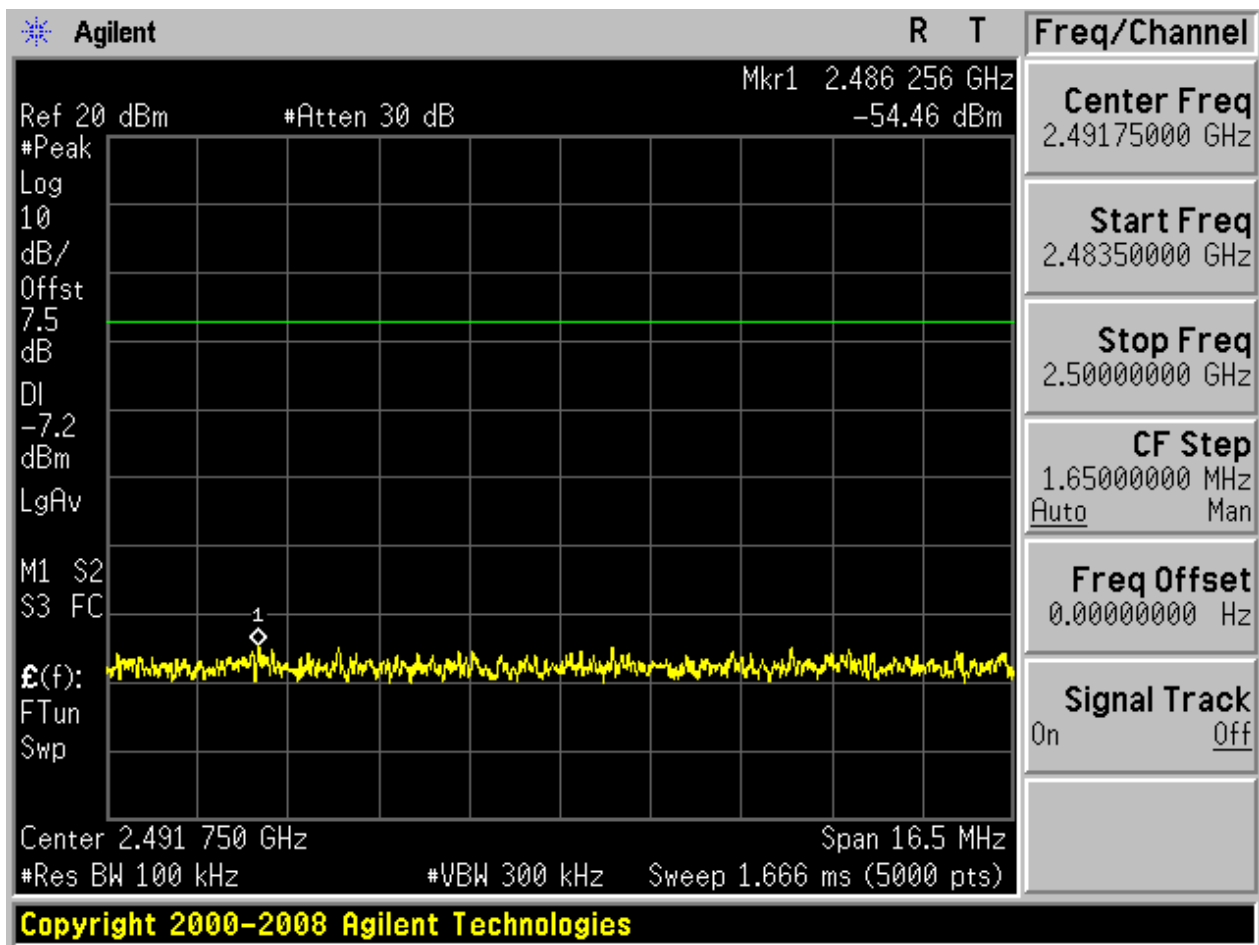
2.1.2 Puw

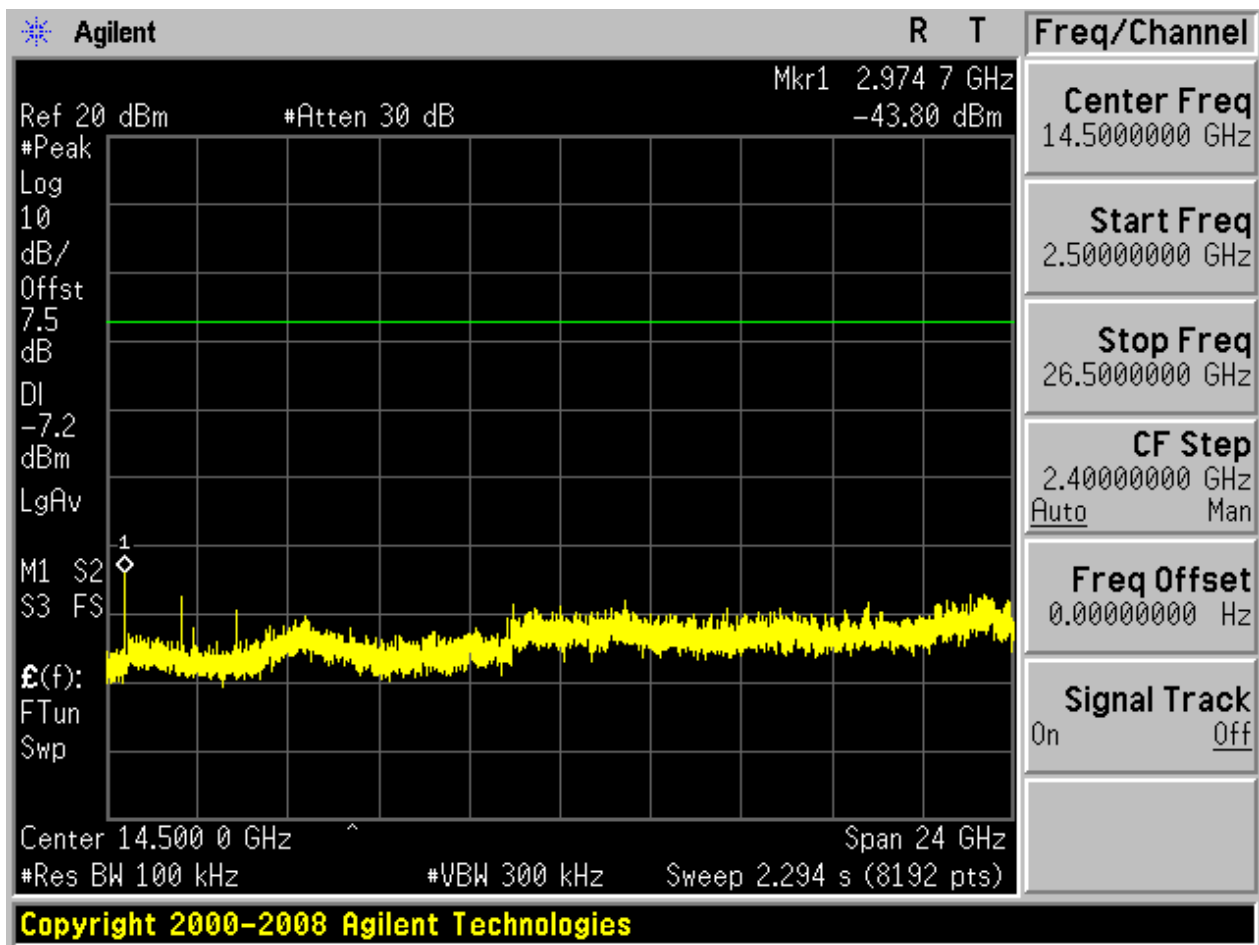








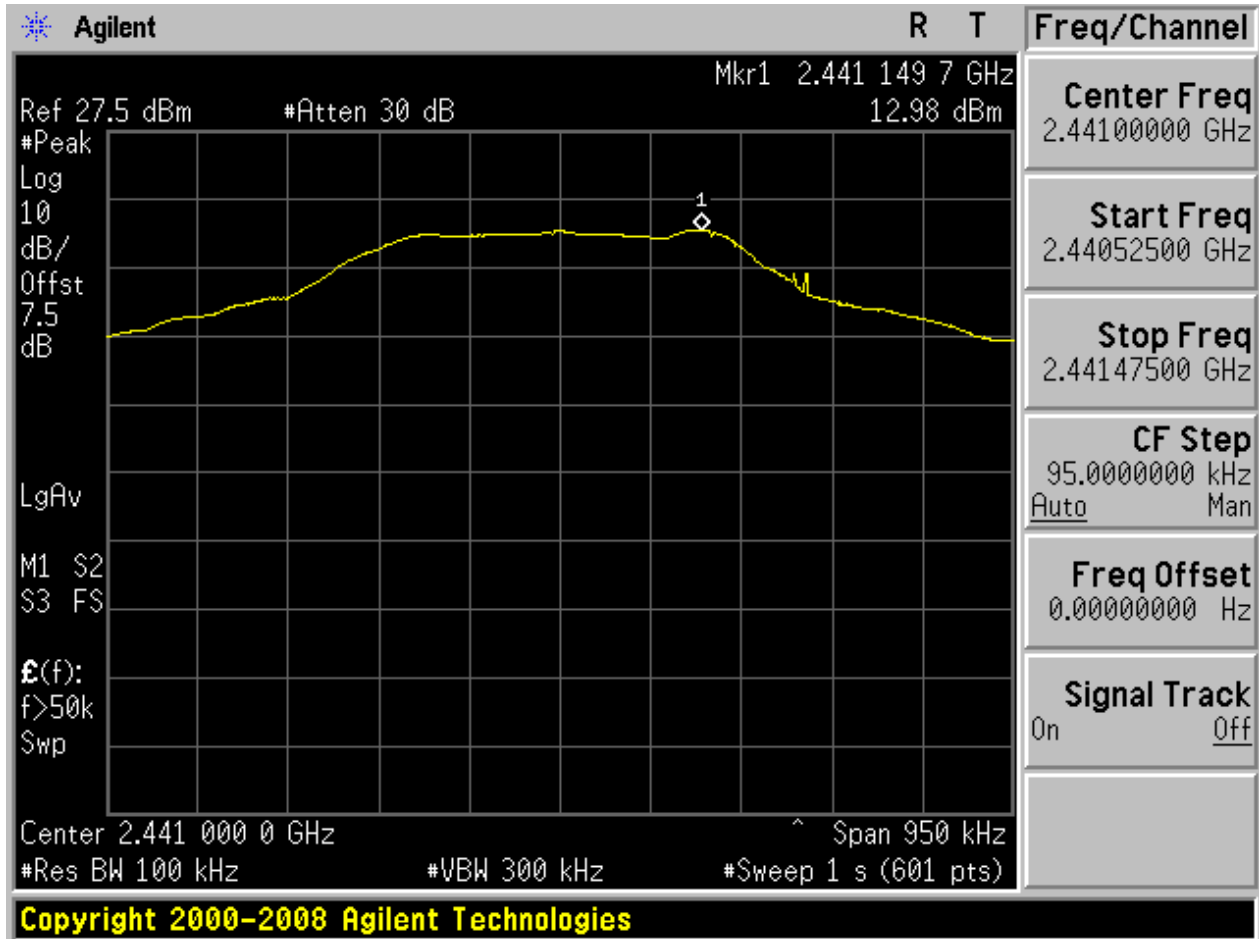






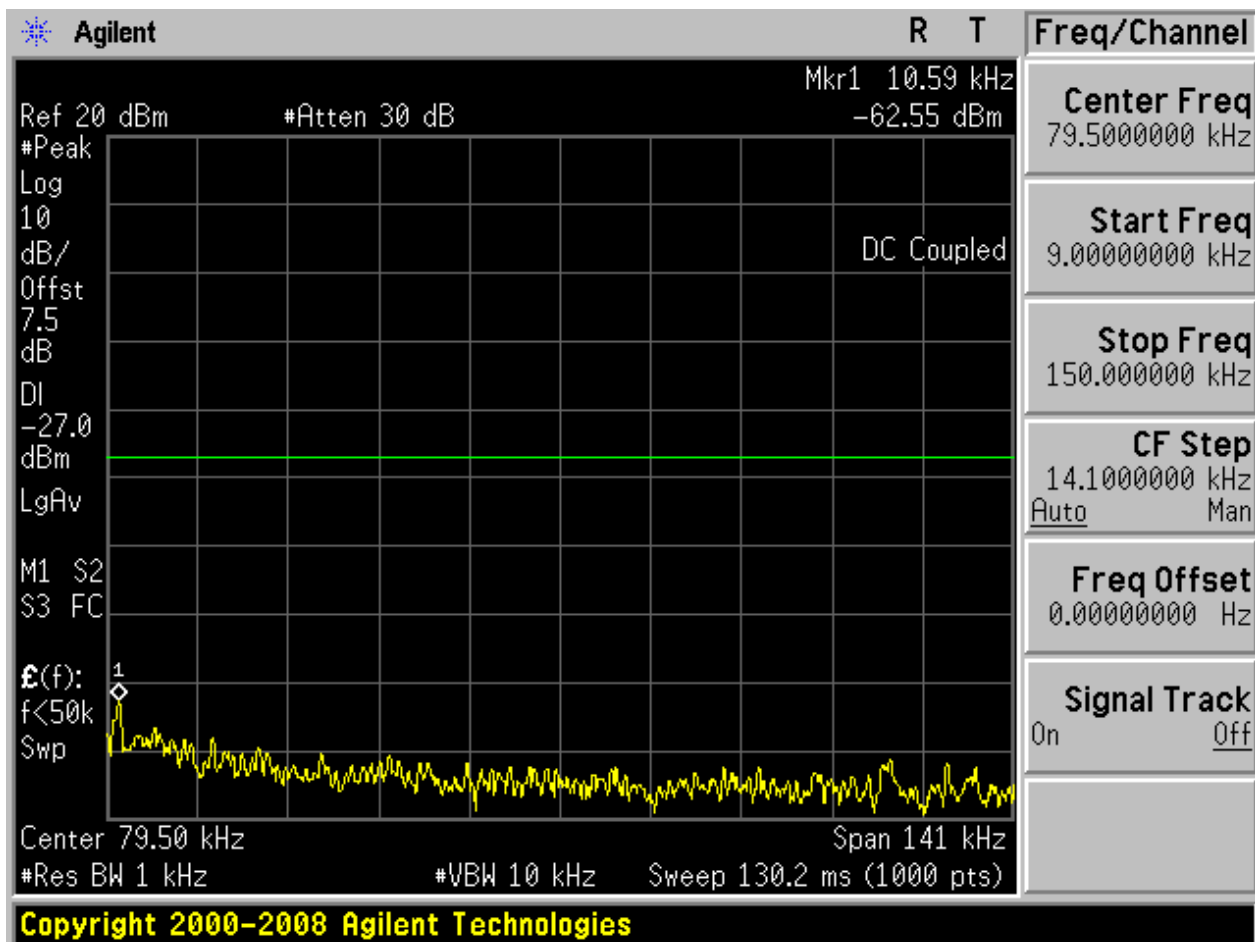
2.2 TM1_DH5_Ch39

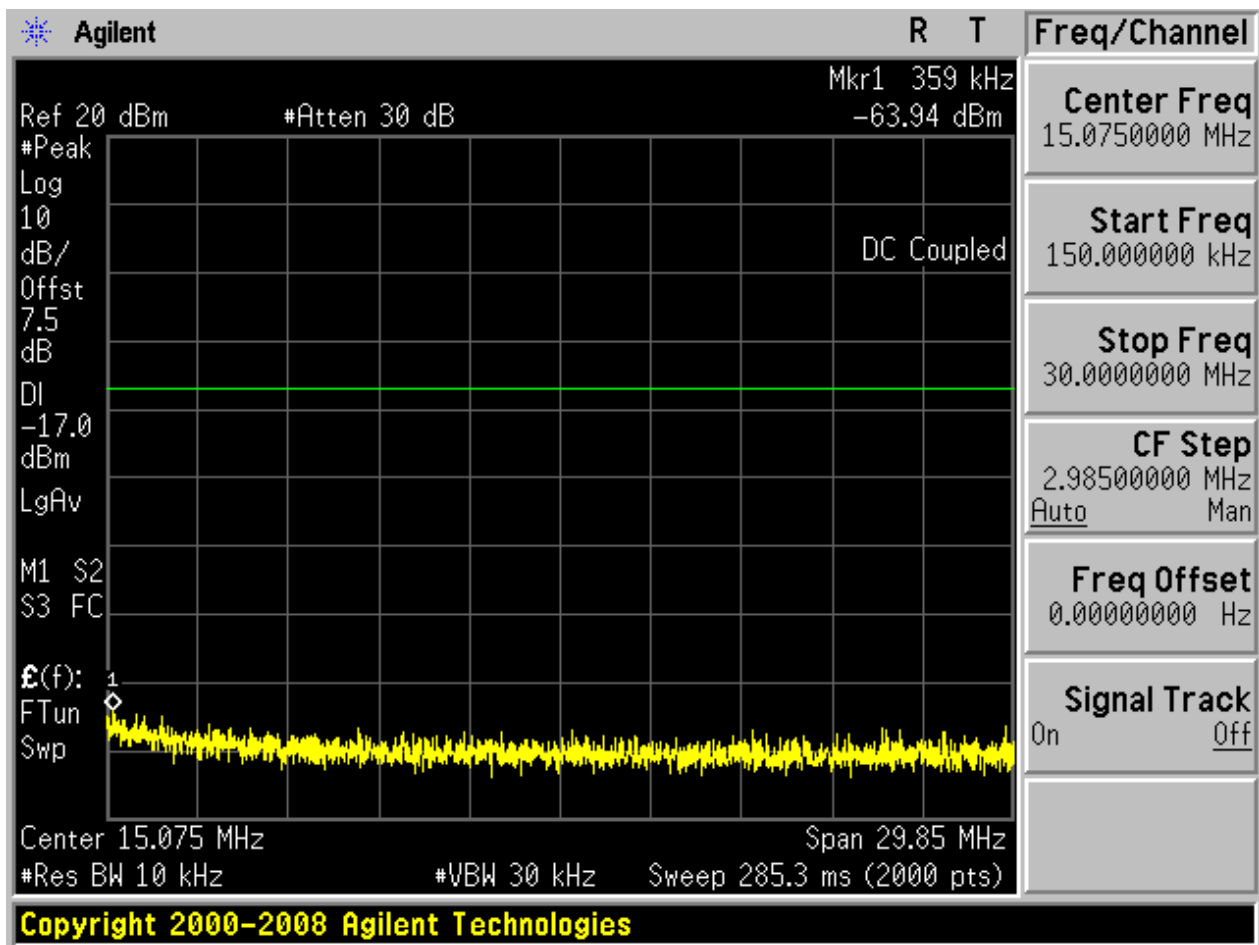
2.2.1 Pref

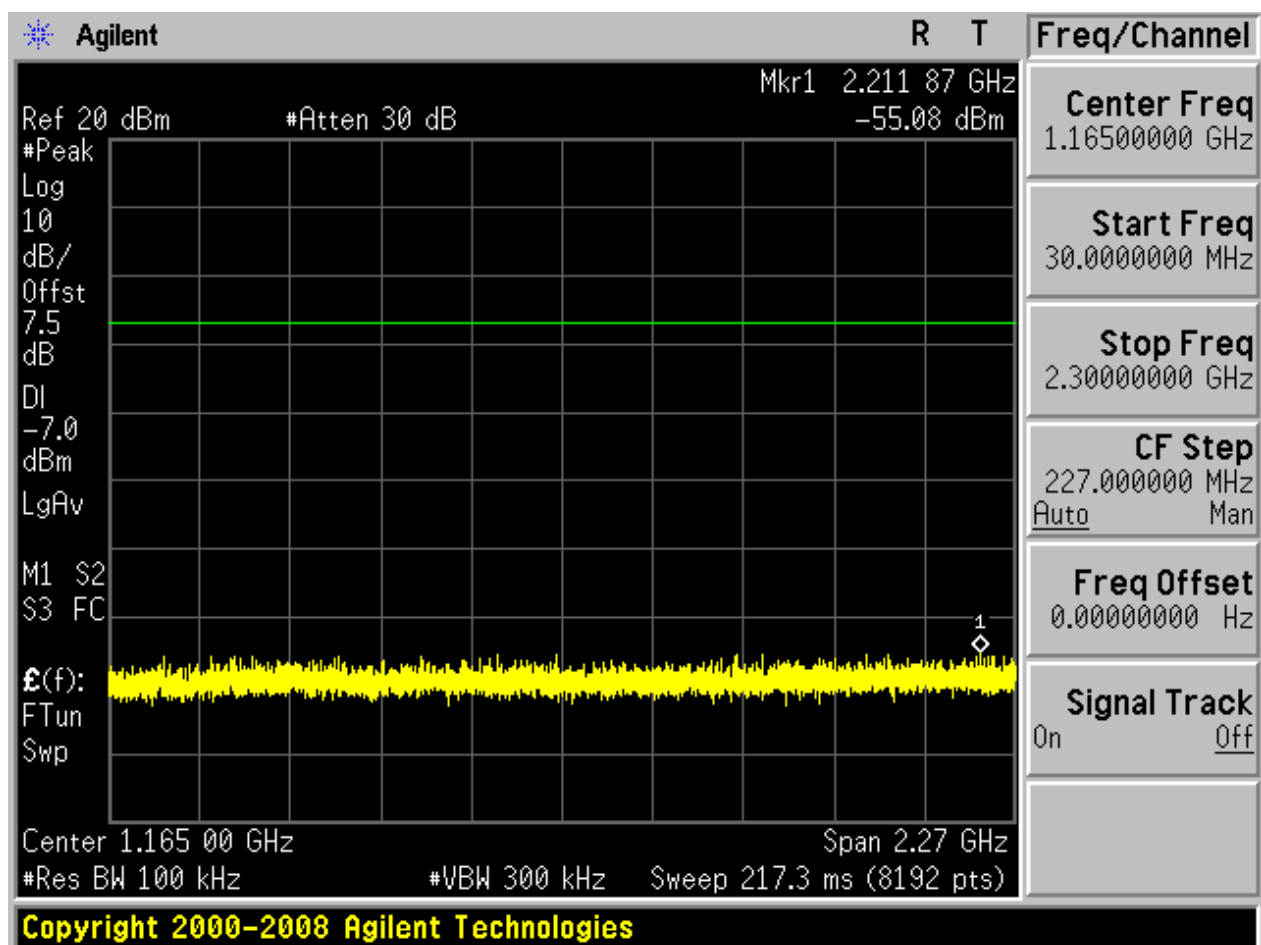


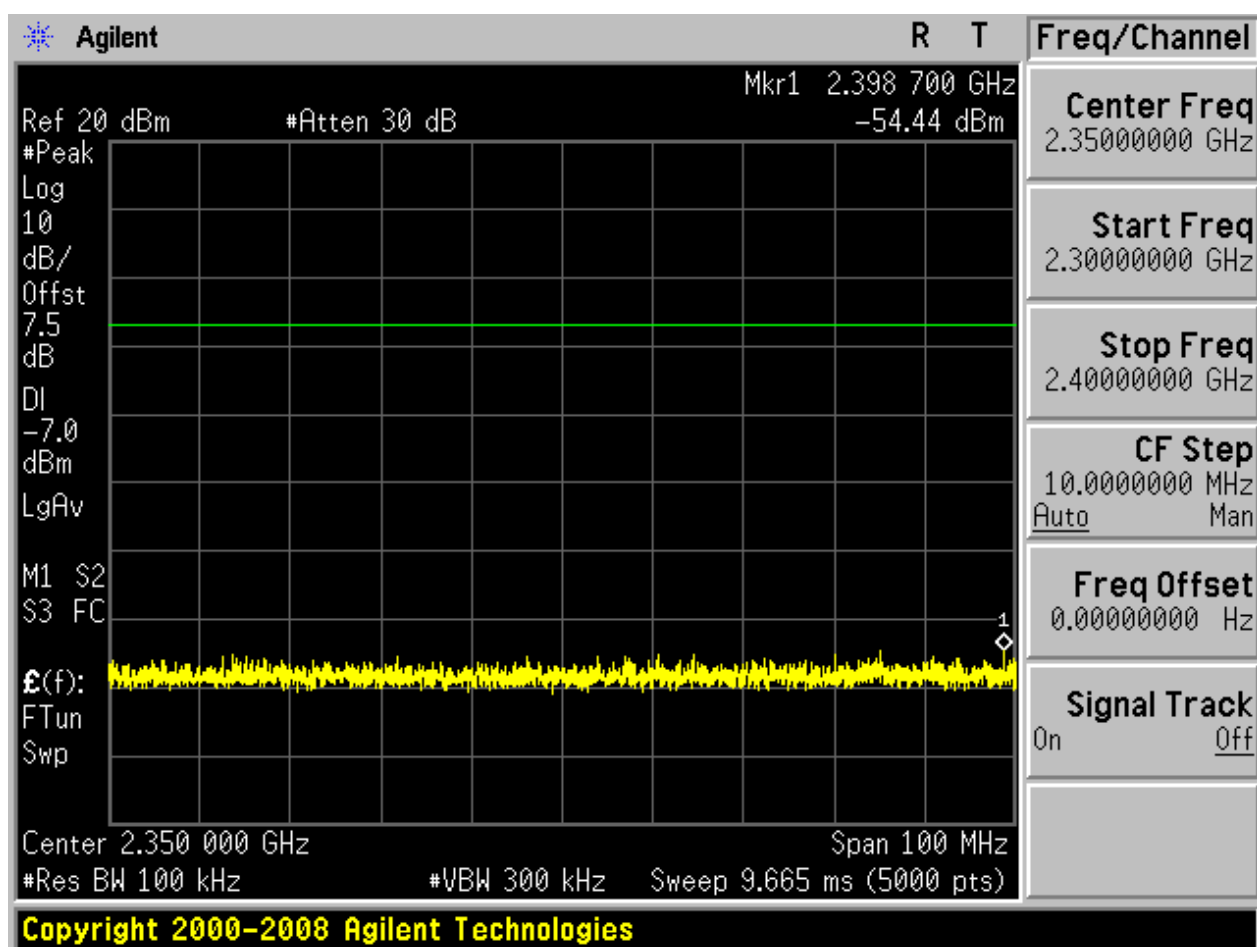


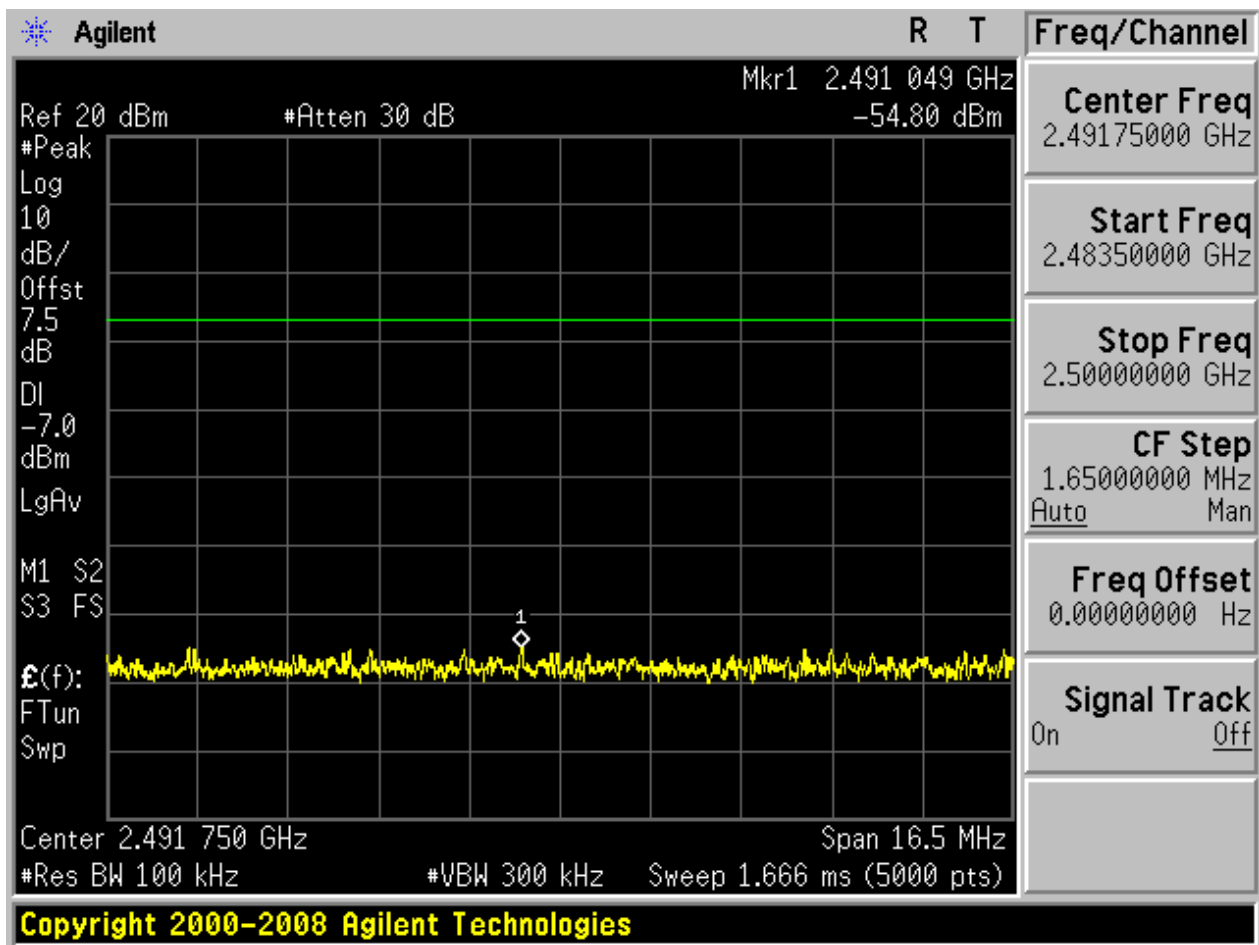
2.2.2 Puw

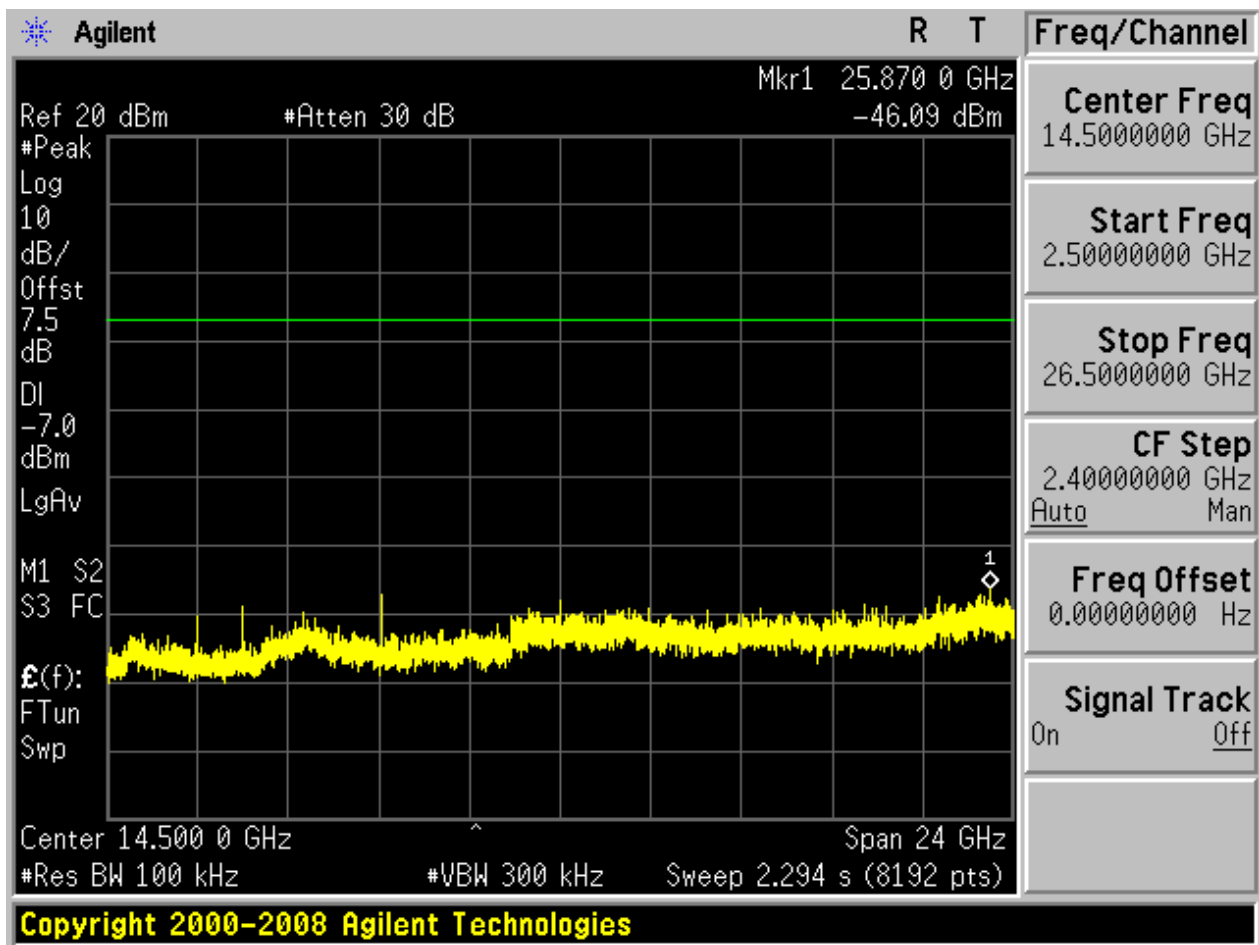








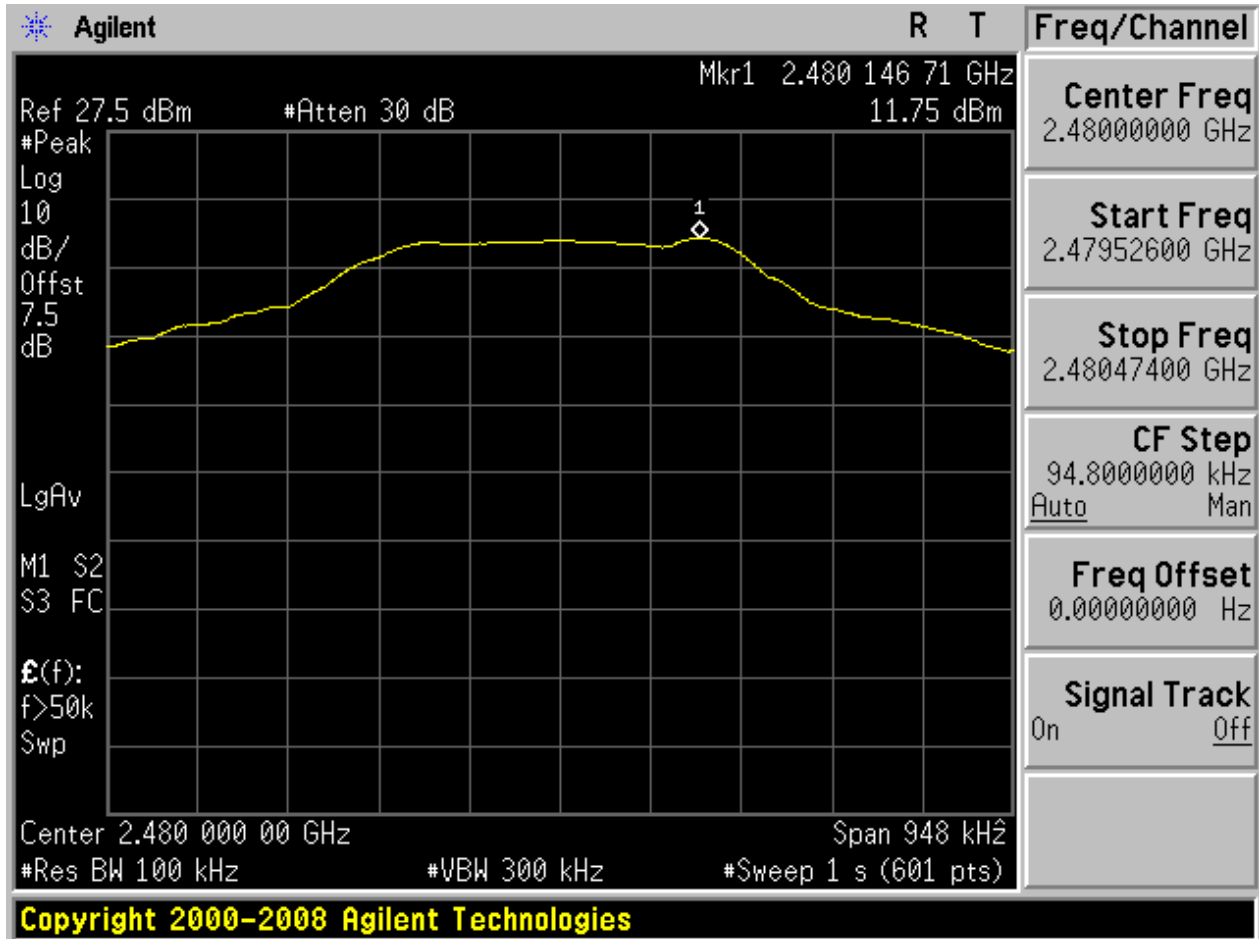






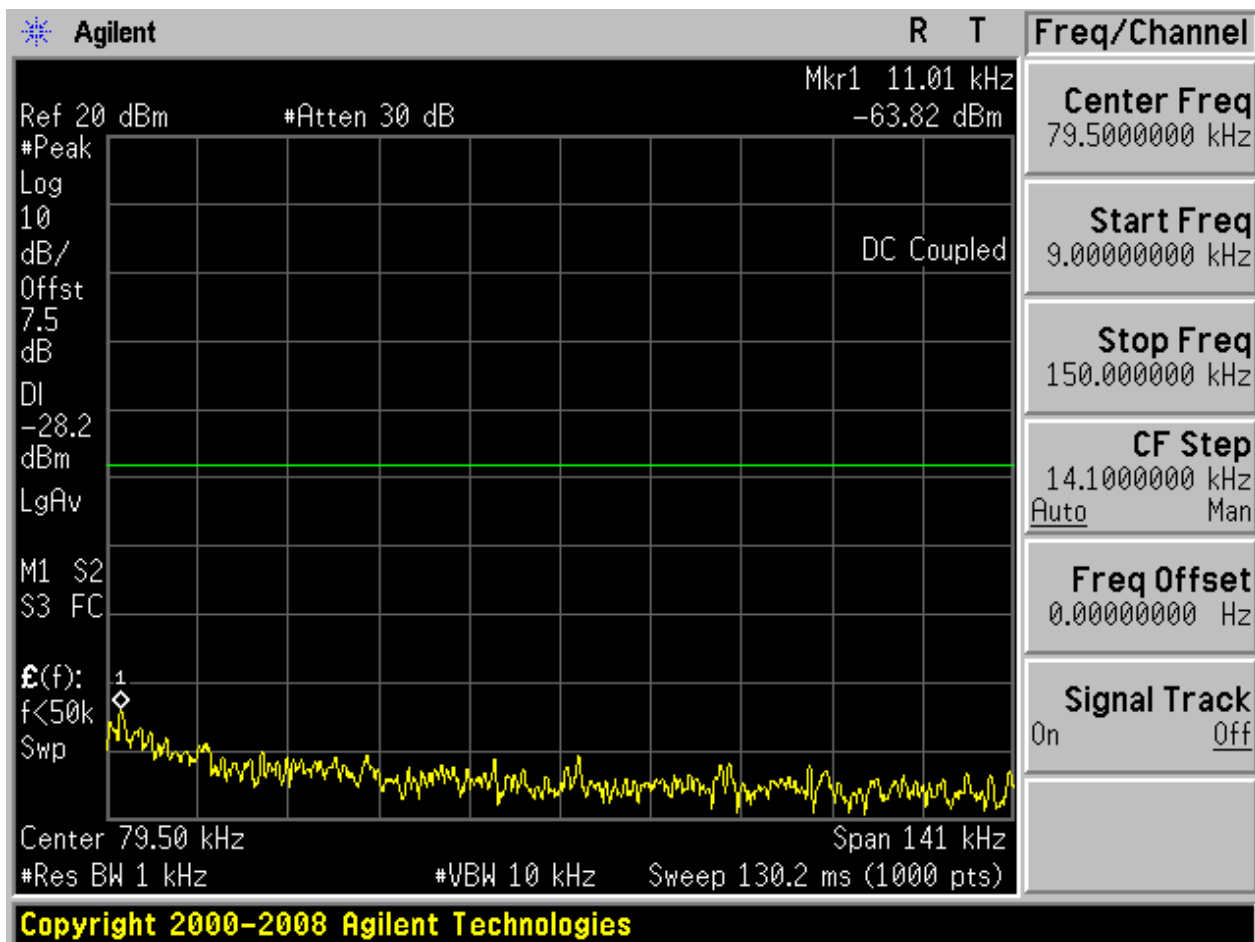
2.3 TM1_DH5_Ch78

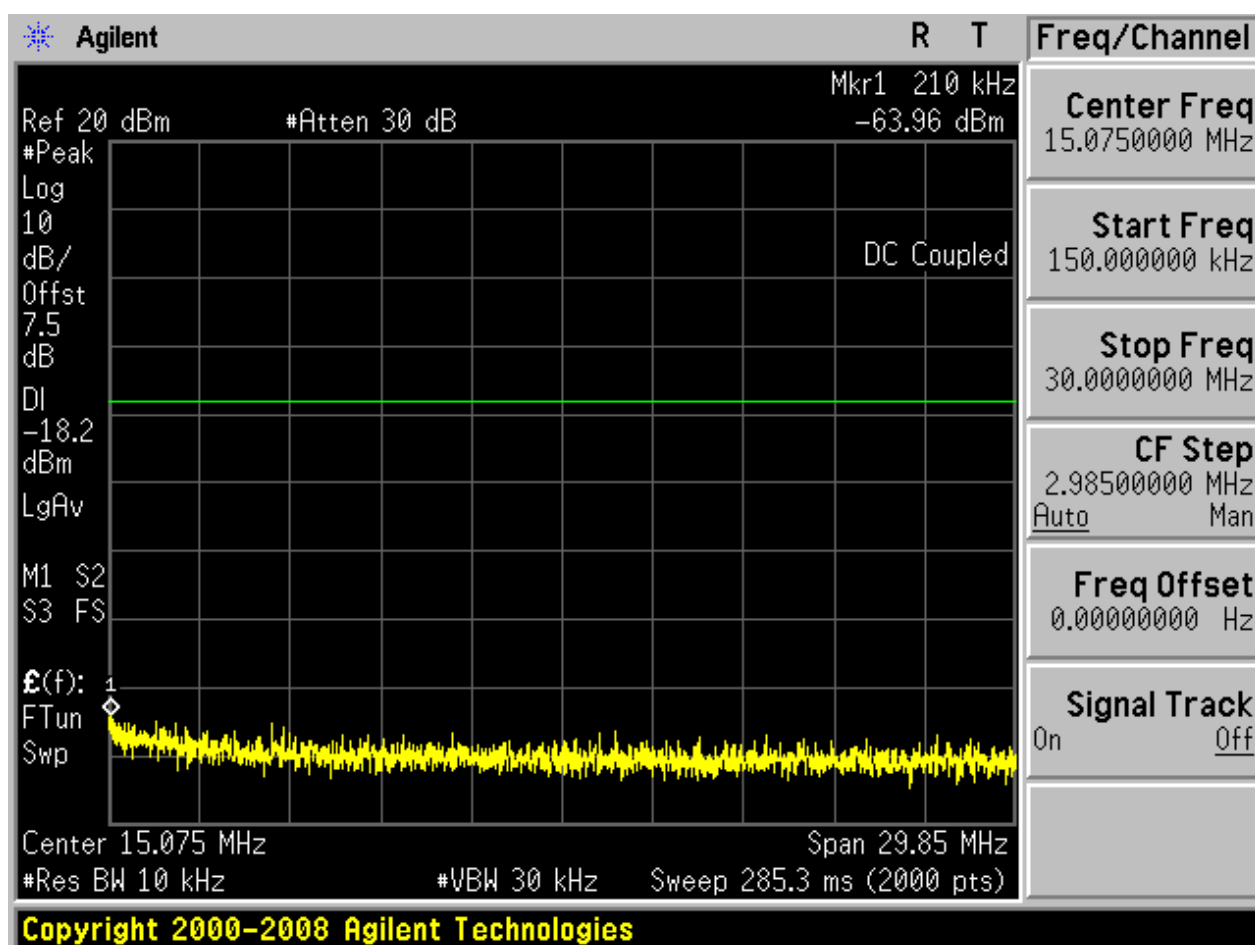
2.3.1 Pref

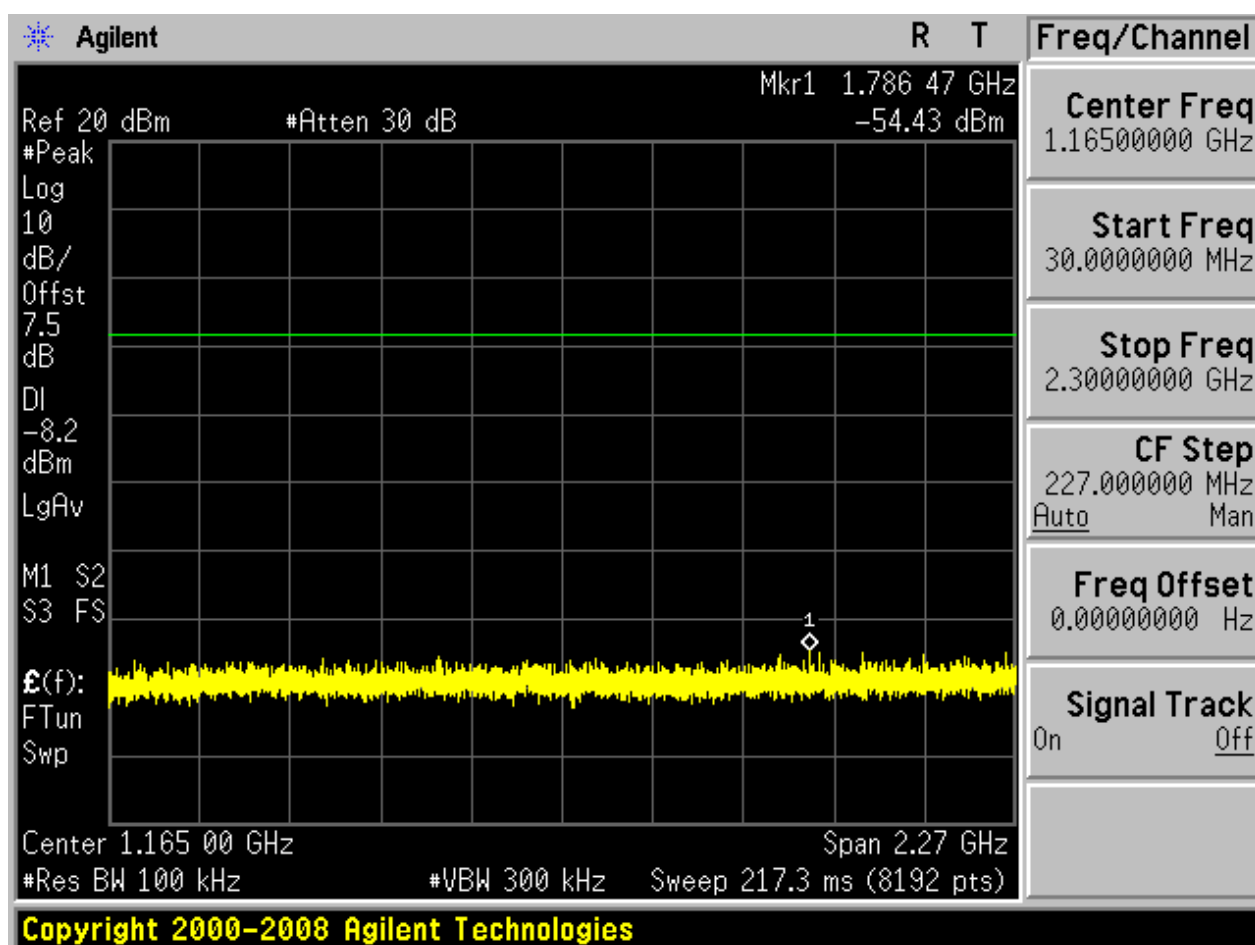


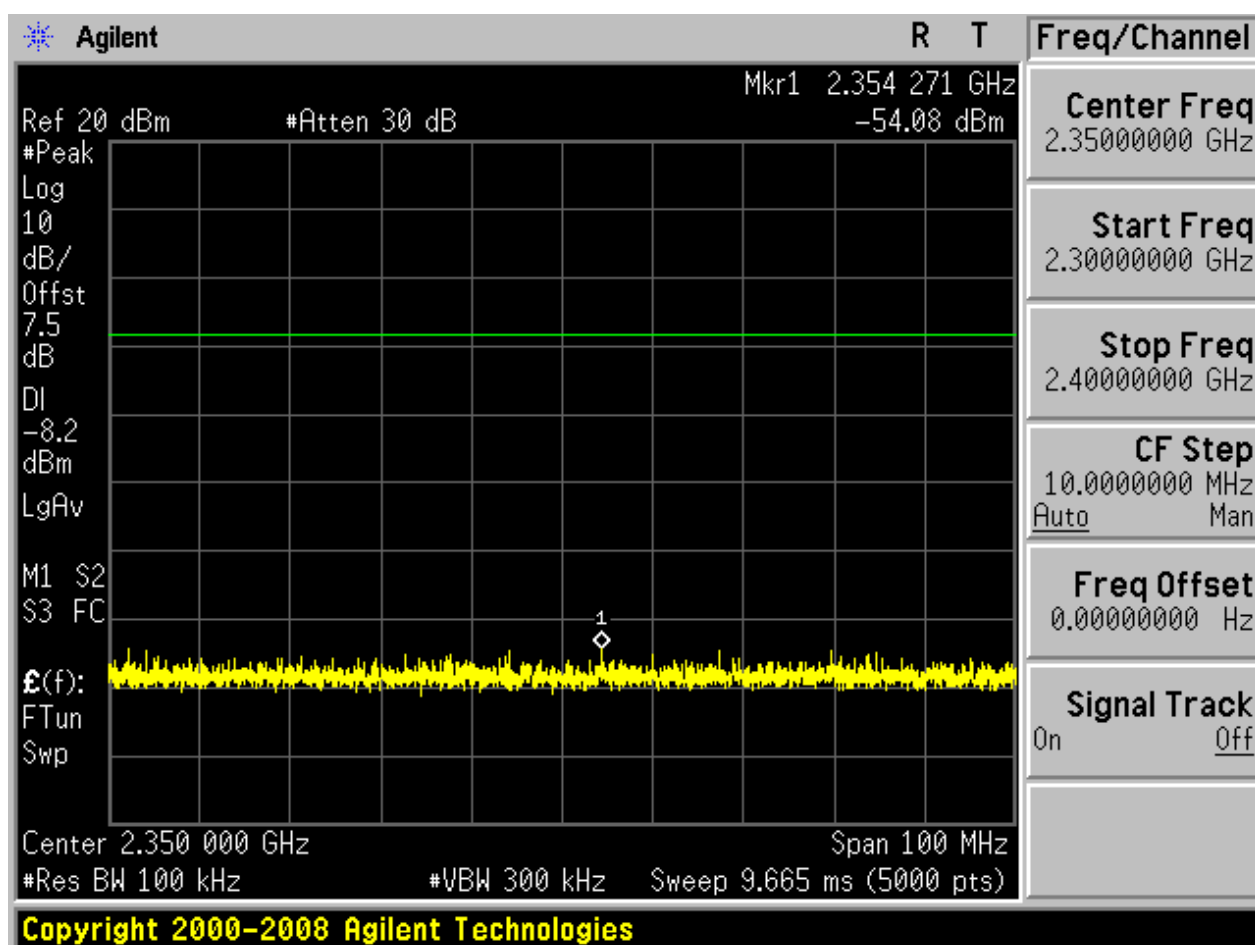


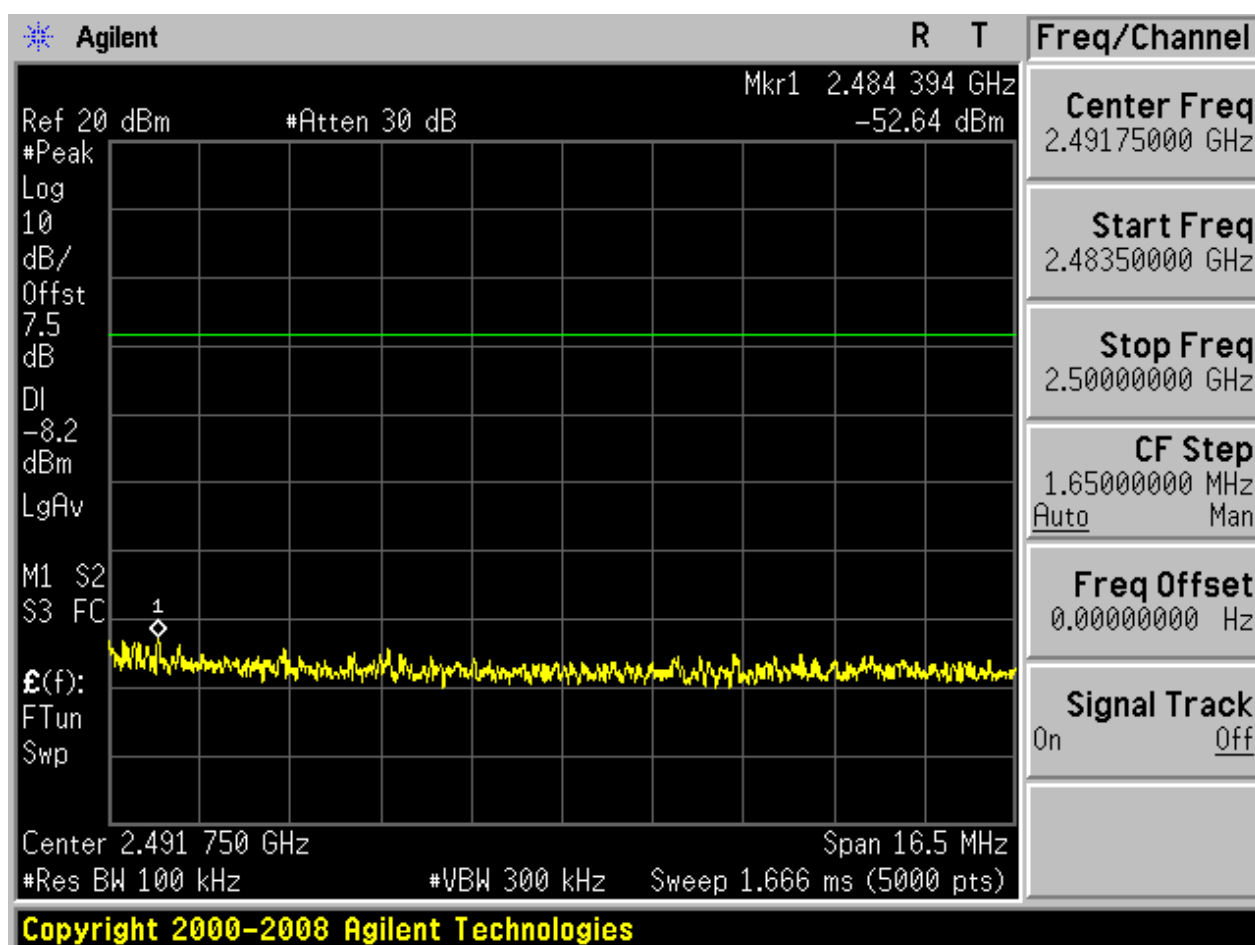
2.3.2 Puw

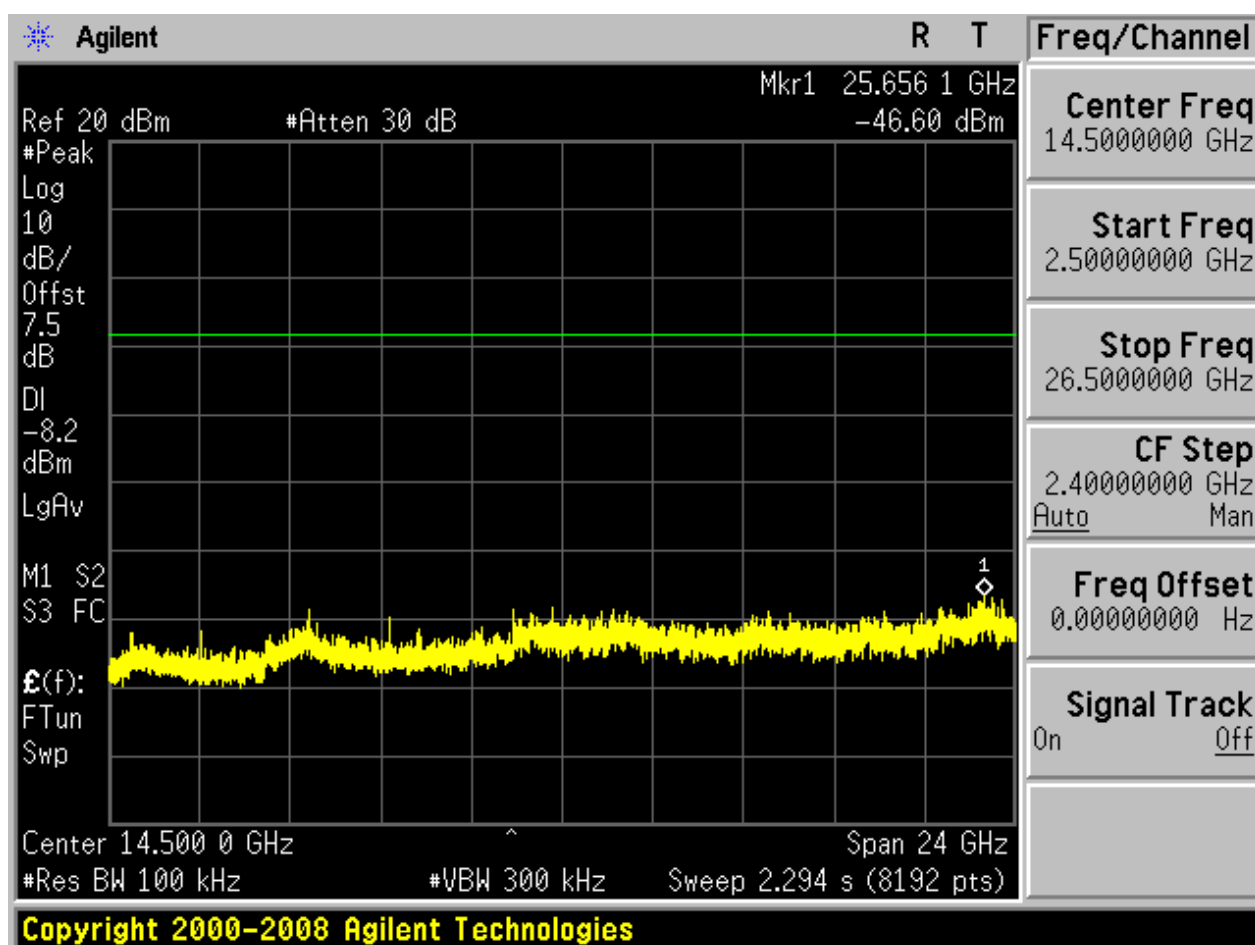








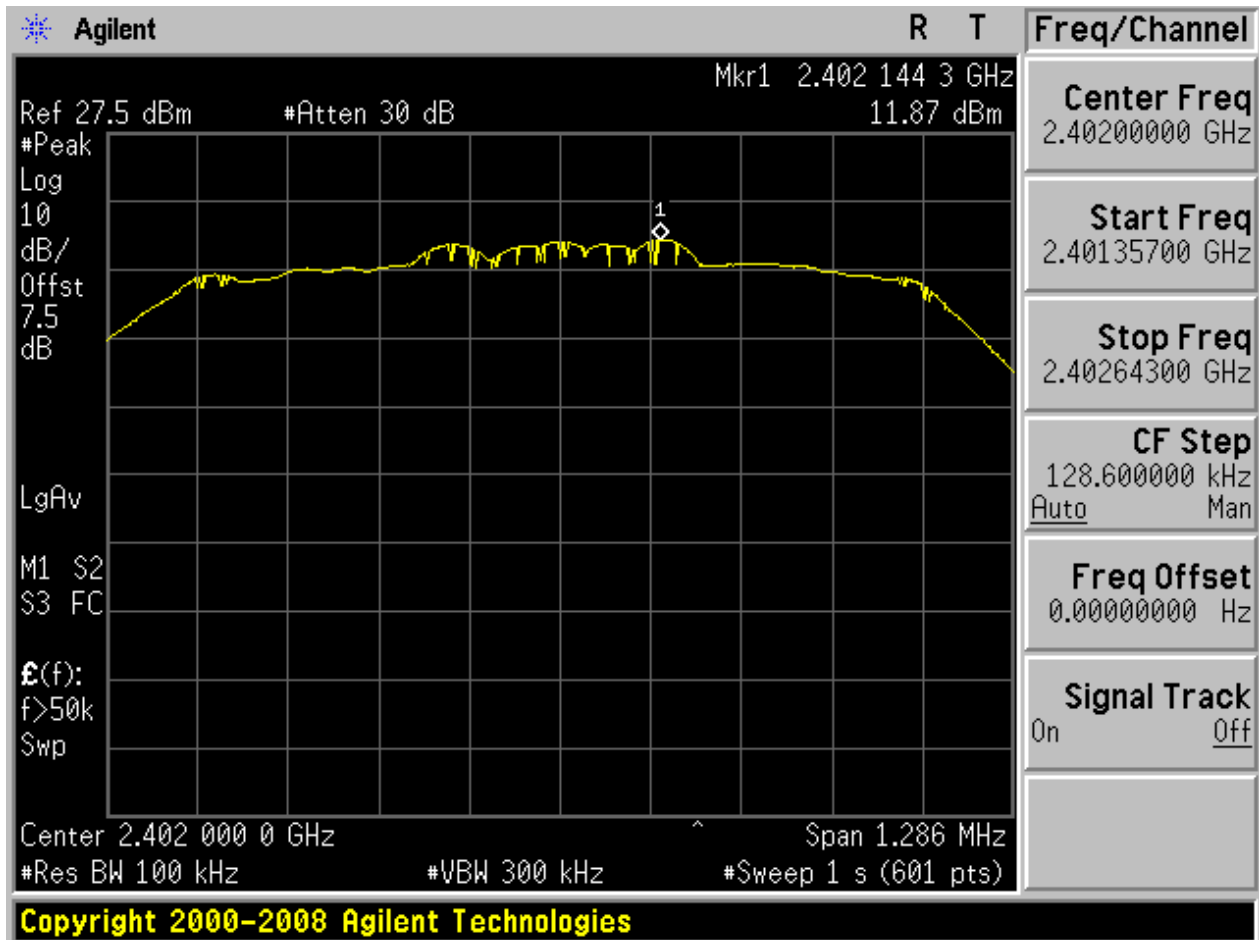




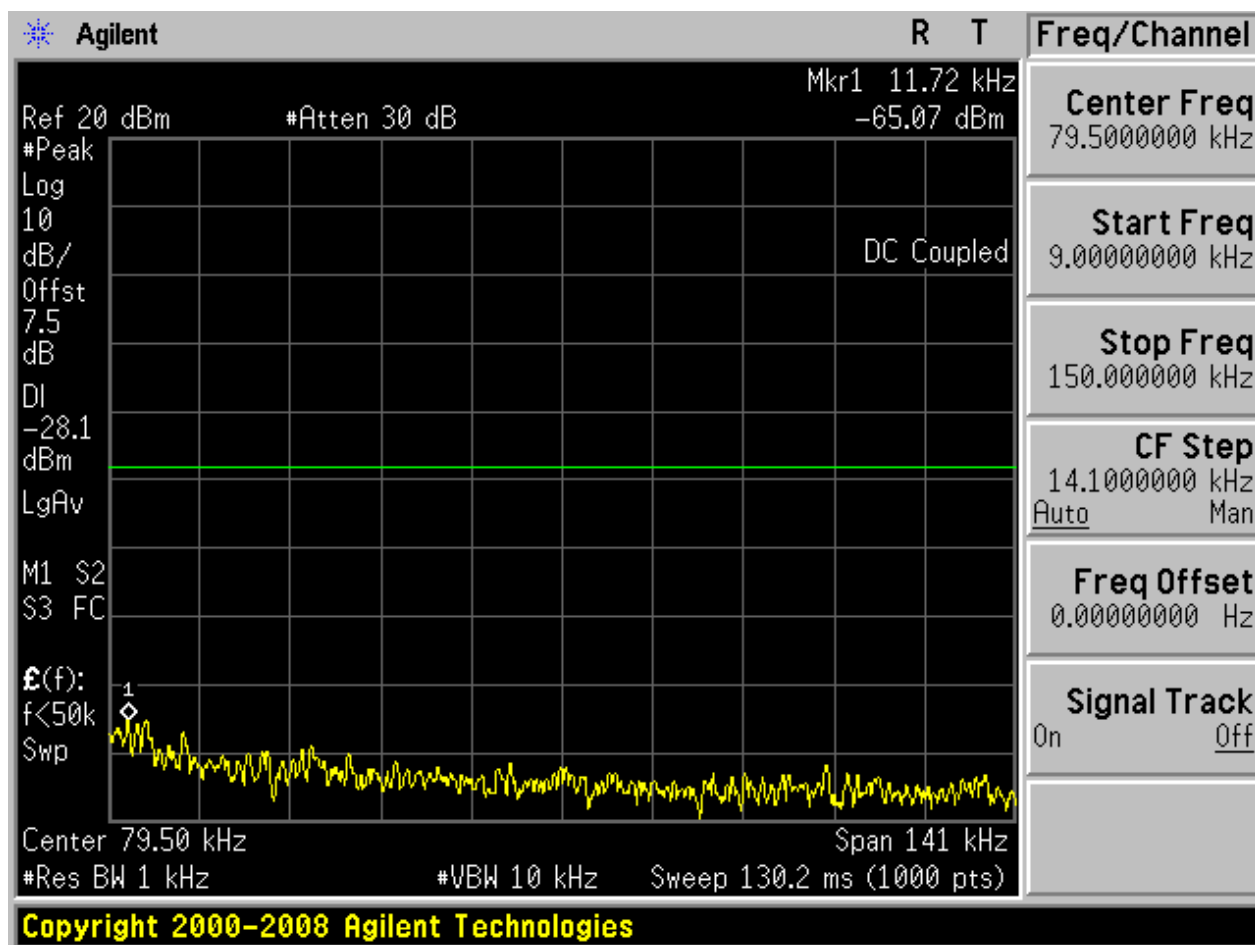


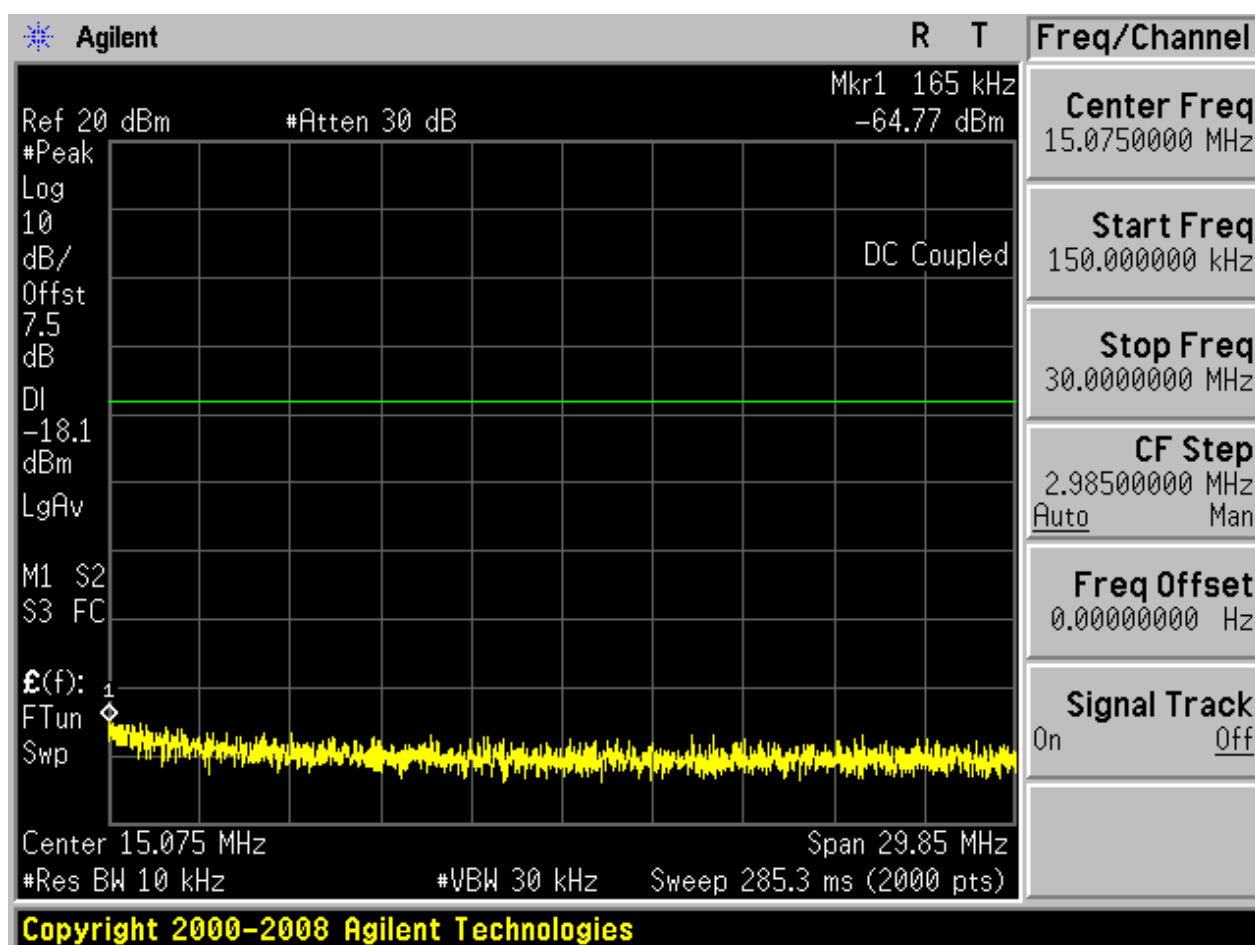
2.4 TM2_2DH5_Ch0

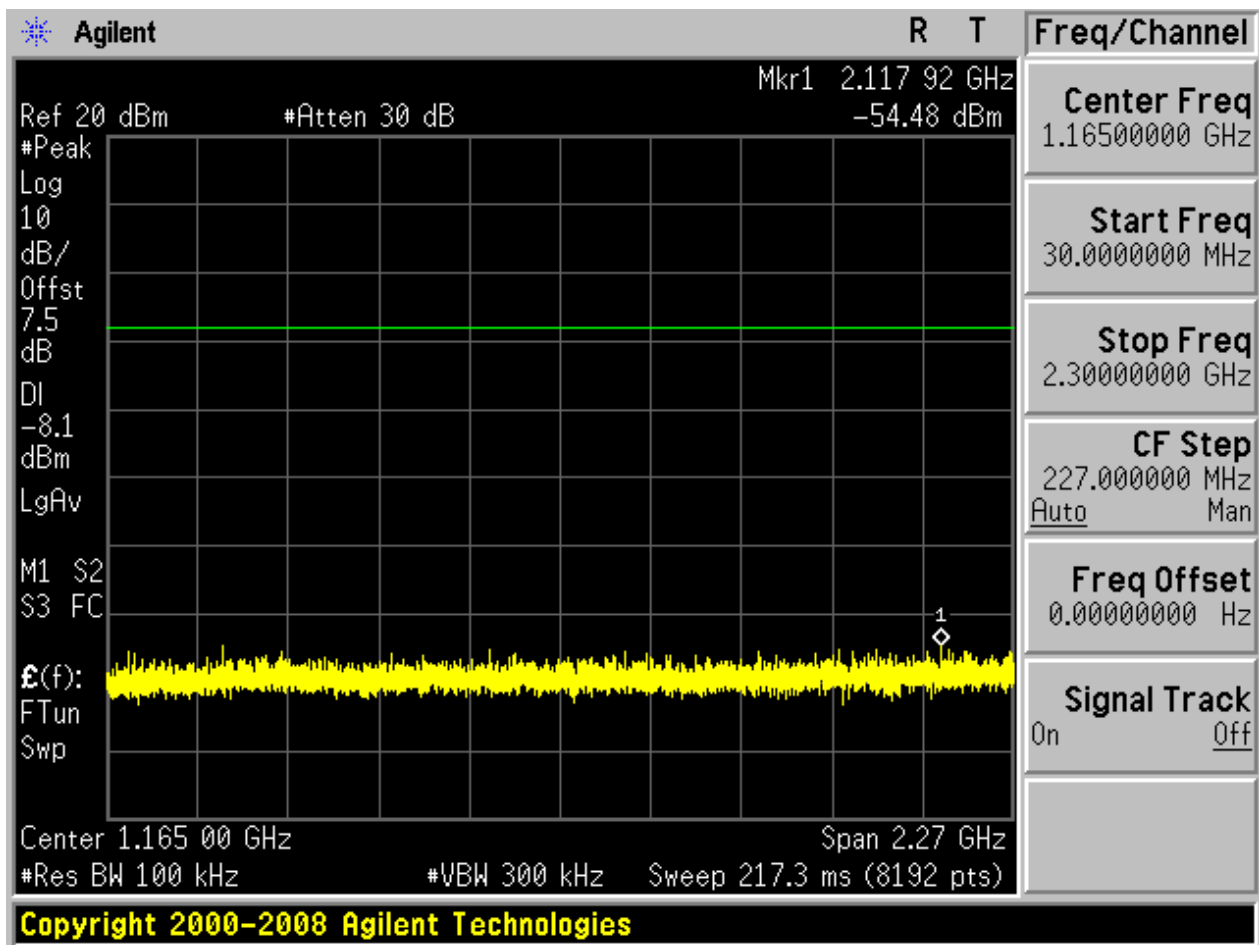
2.4.1 Pref

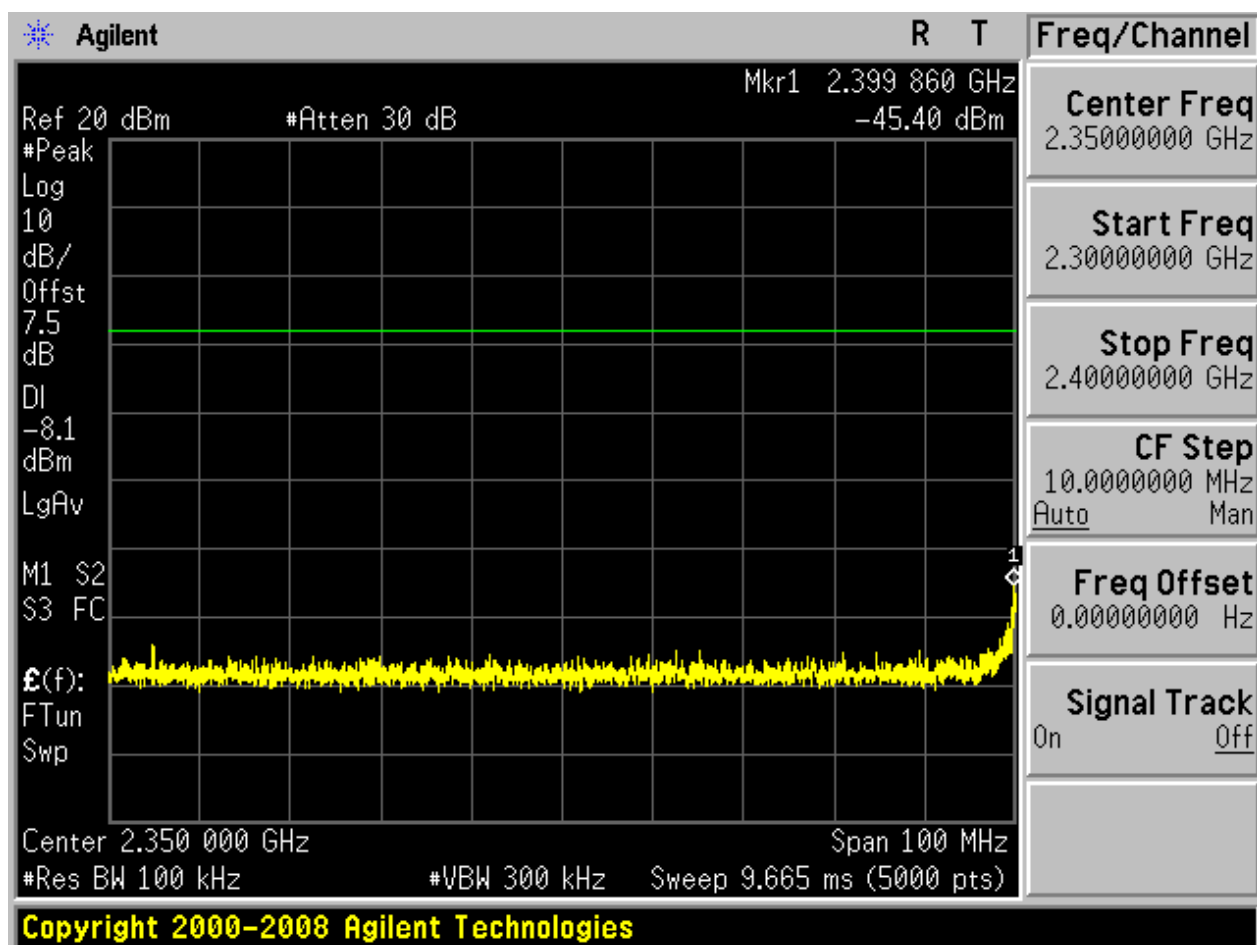


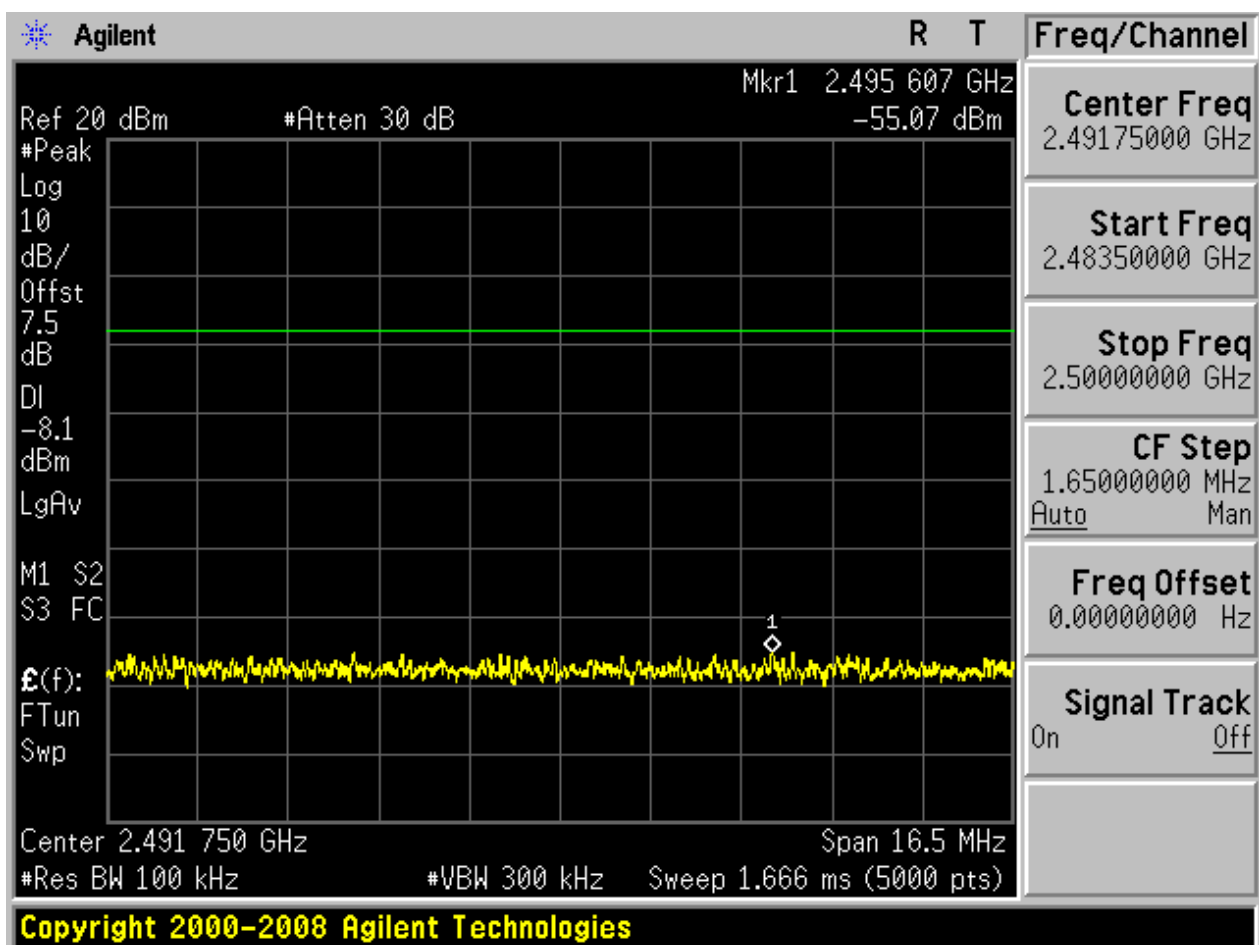
2.4.2 Puw

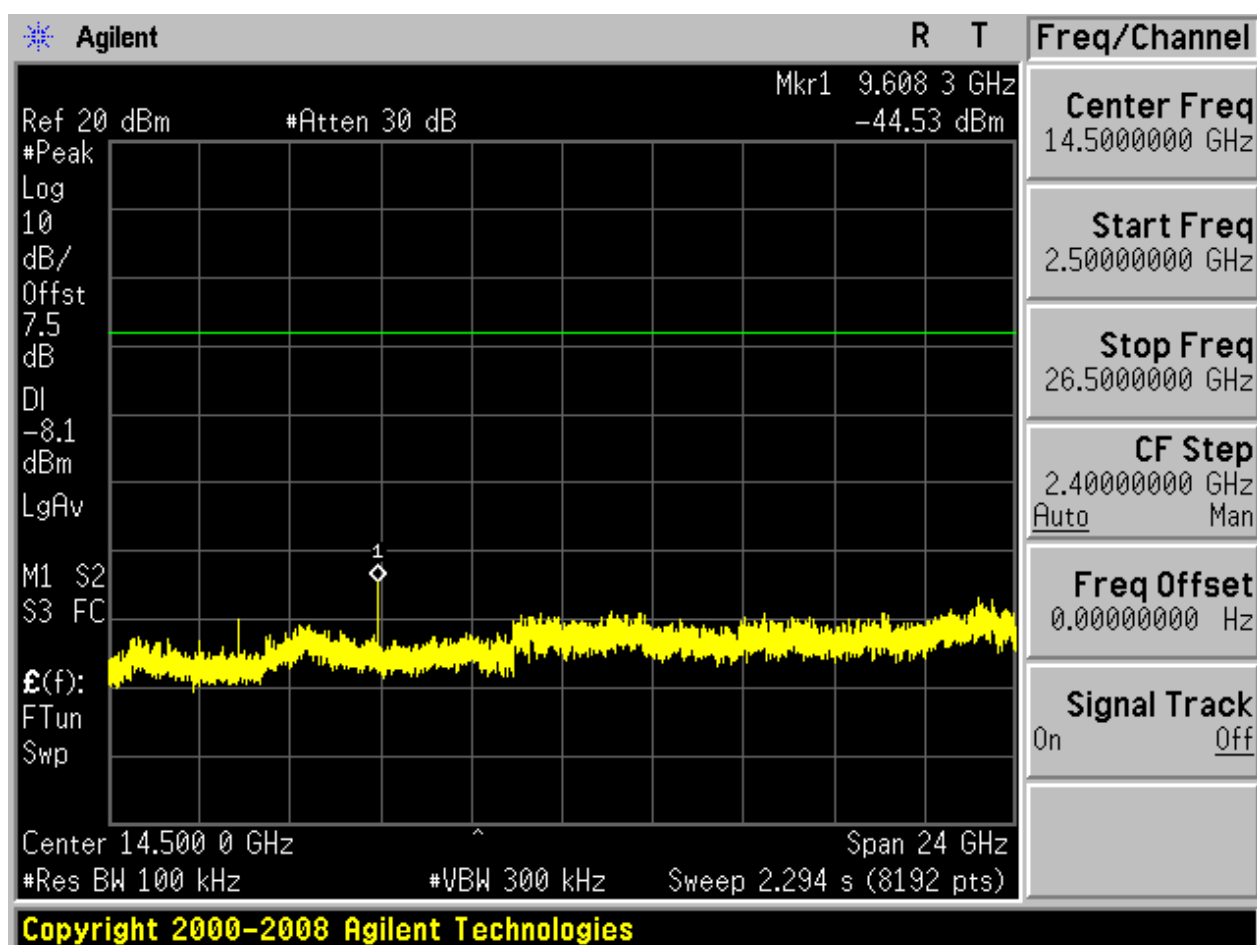








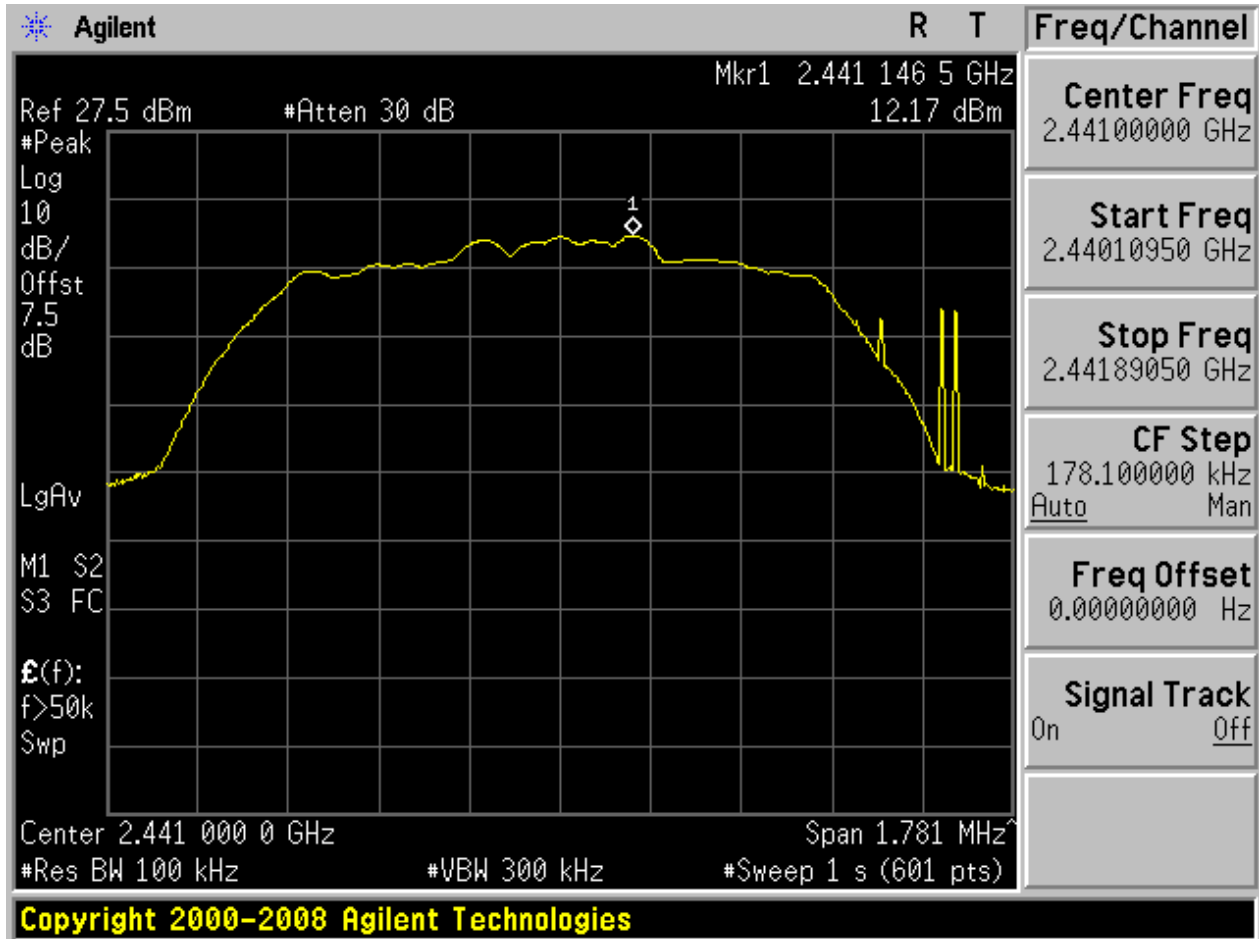






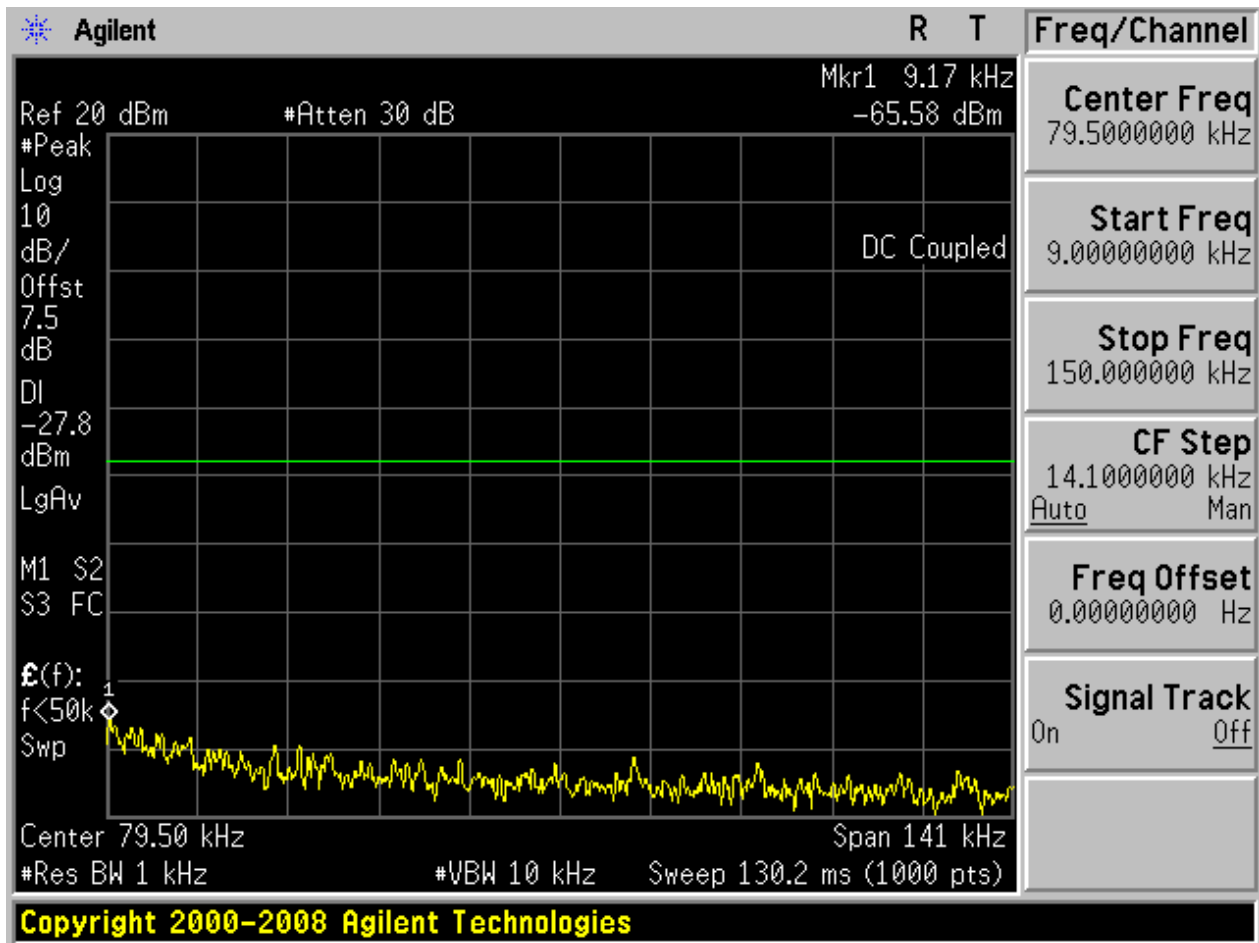
2.5 TM2_2DH5_Ch39

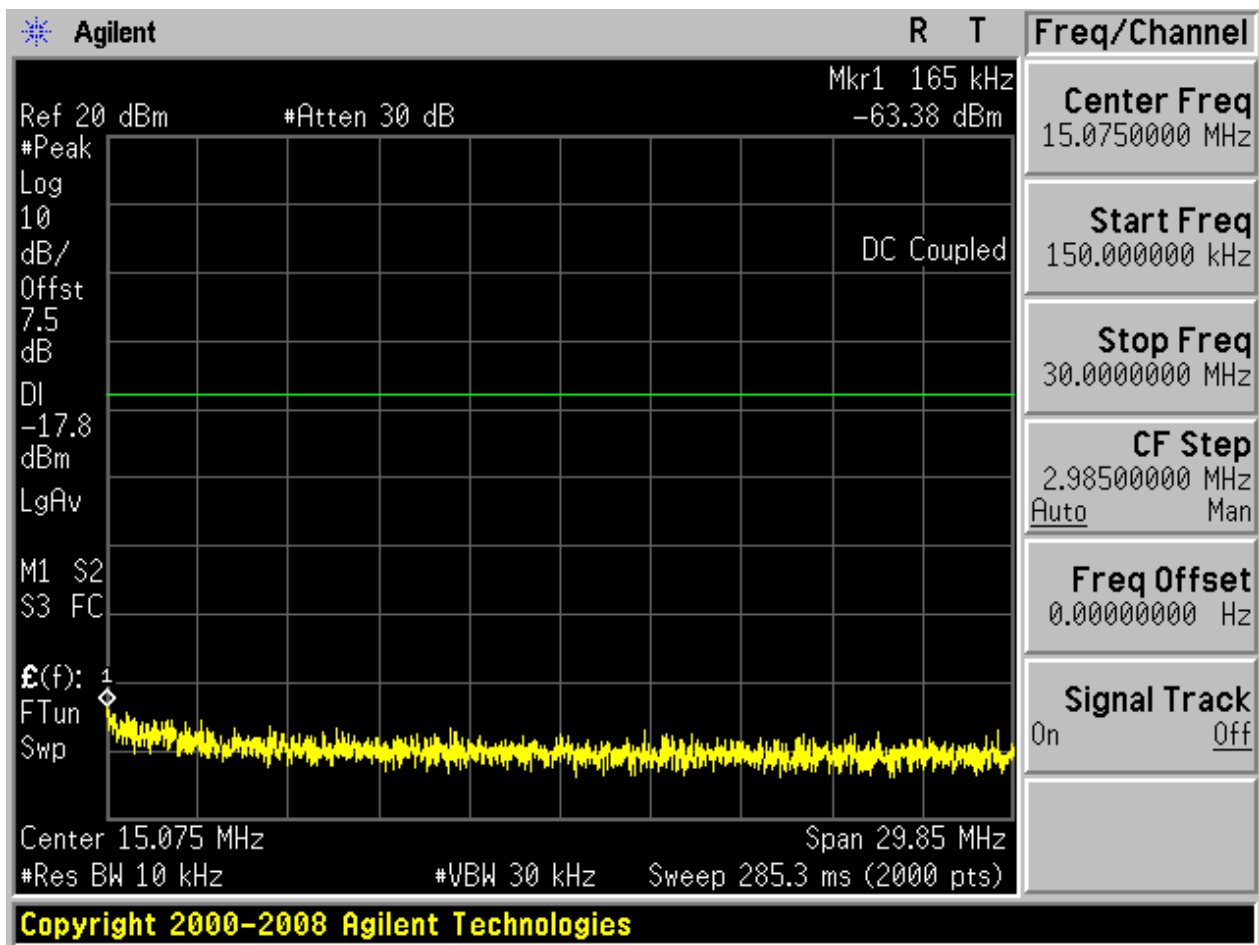
2.5.1 Pref

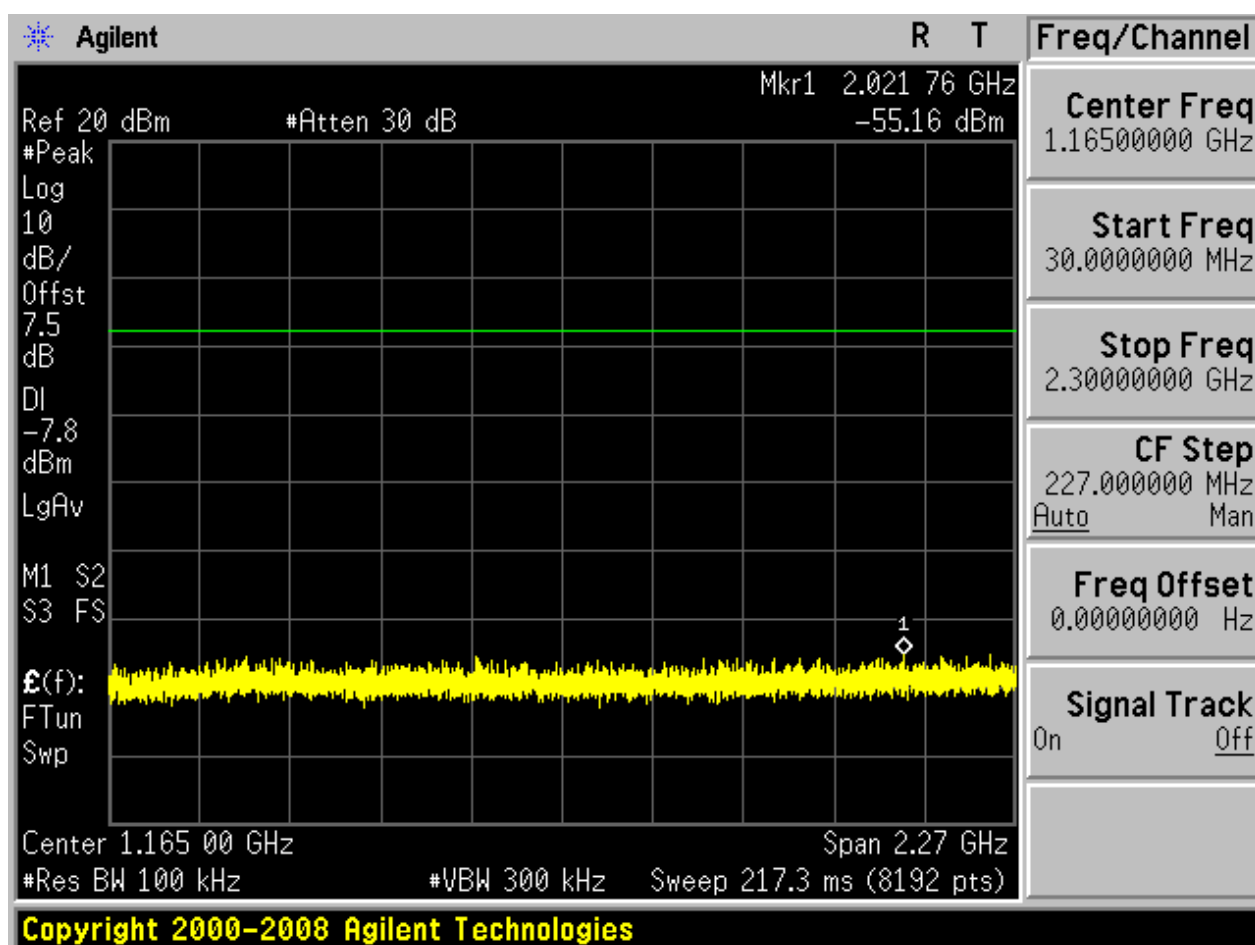


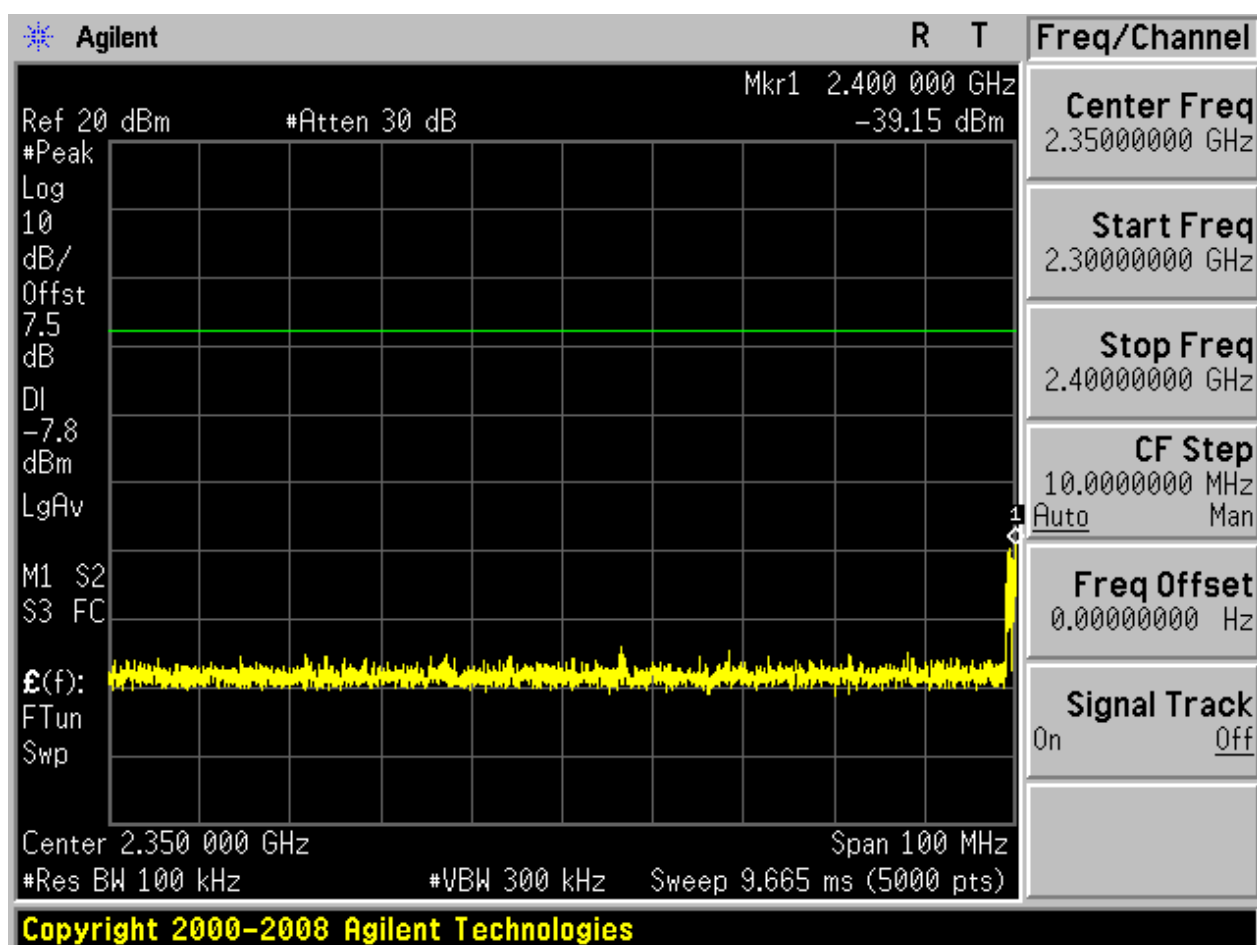


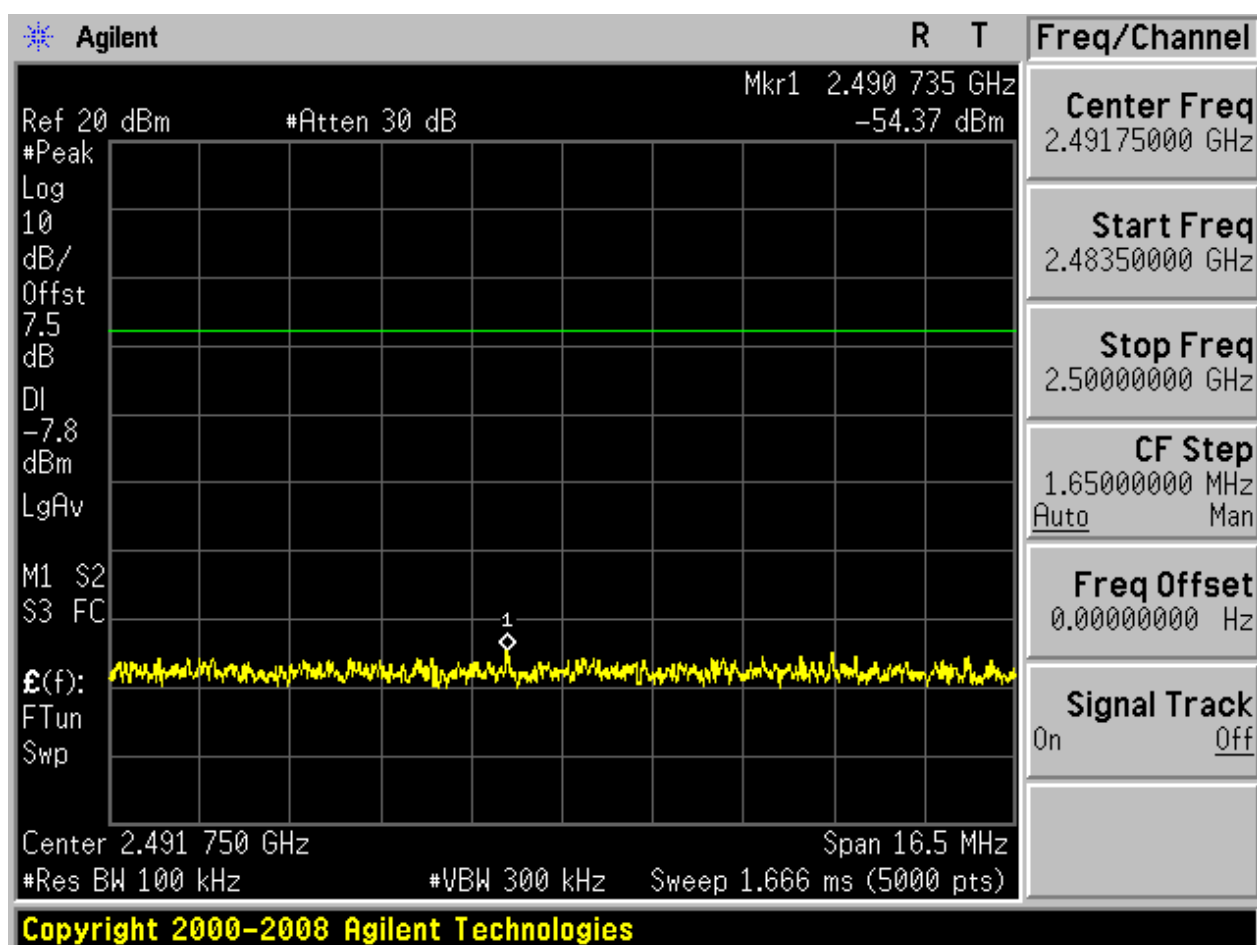
2.5.2 Puw

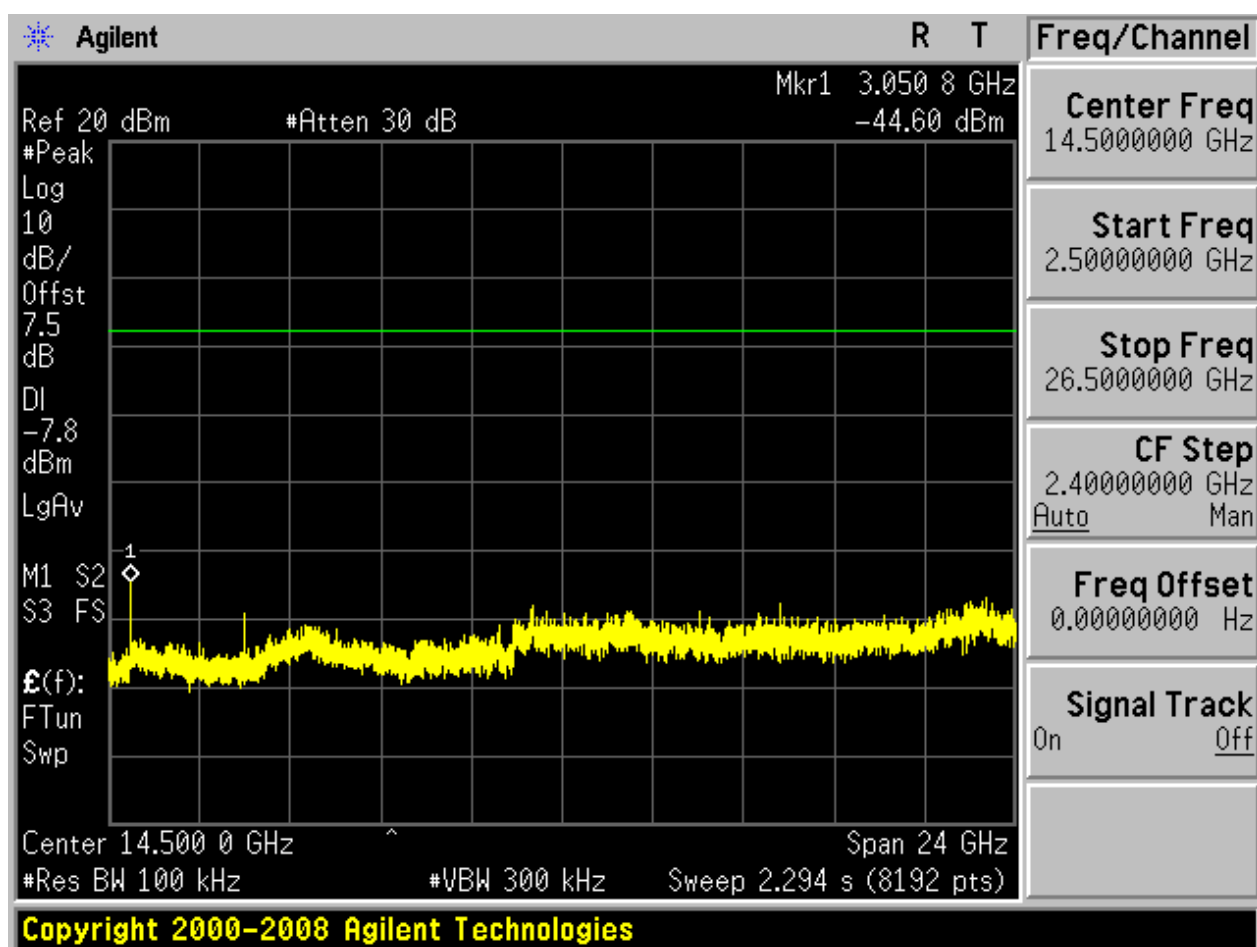








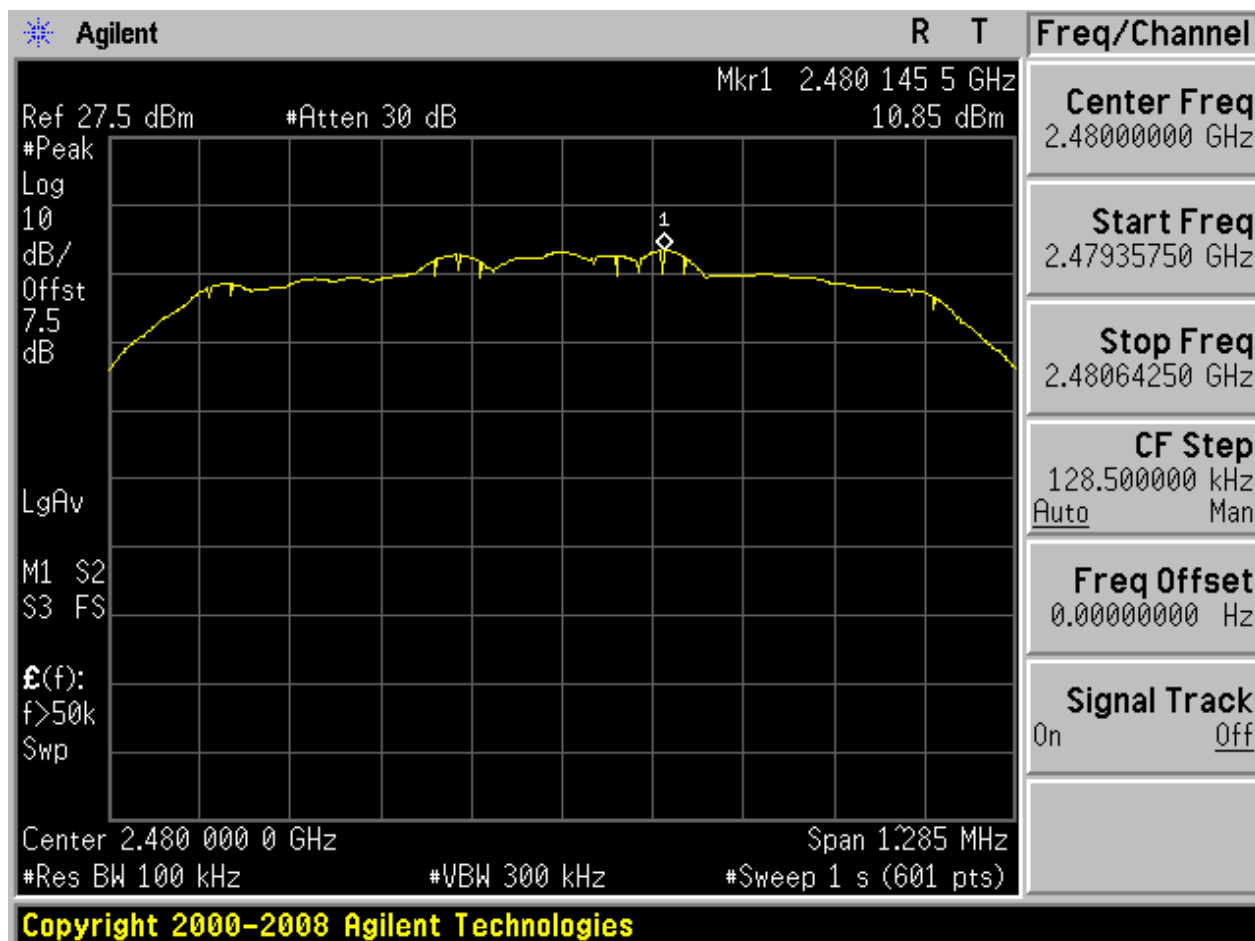




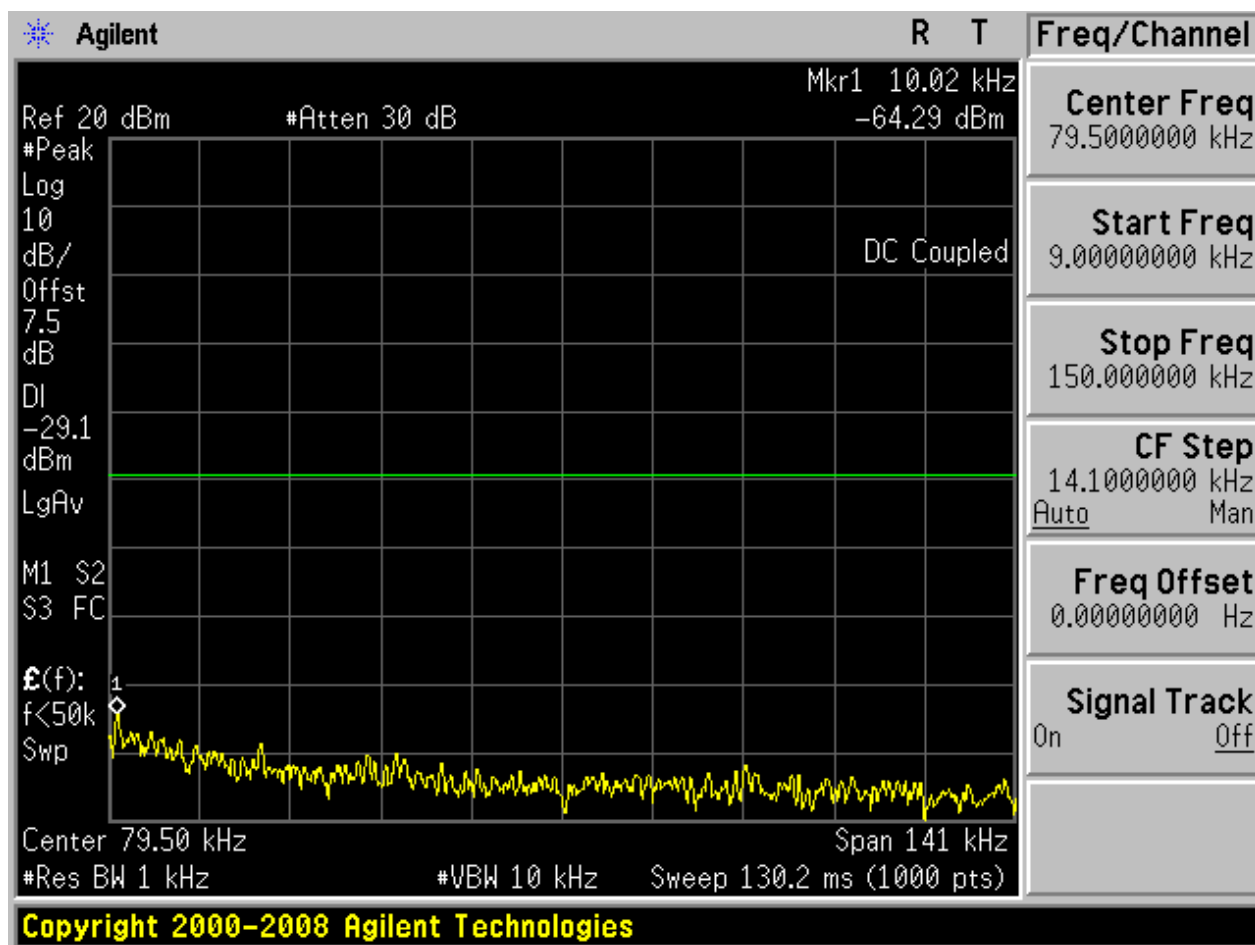


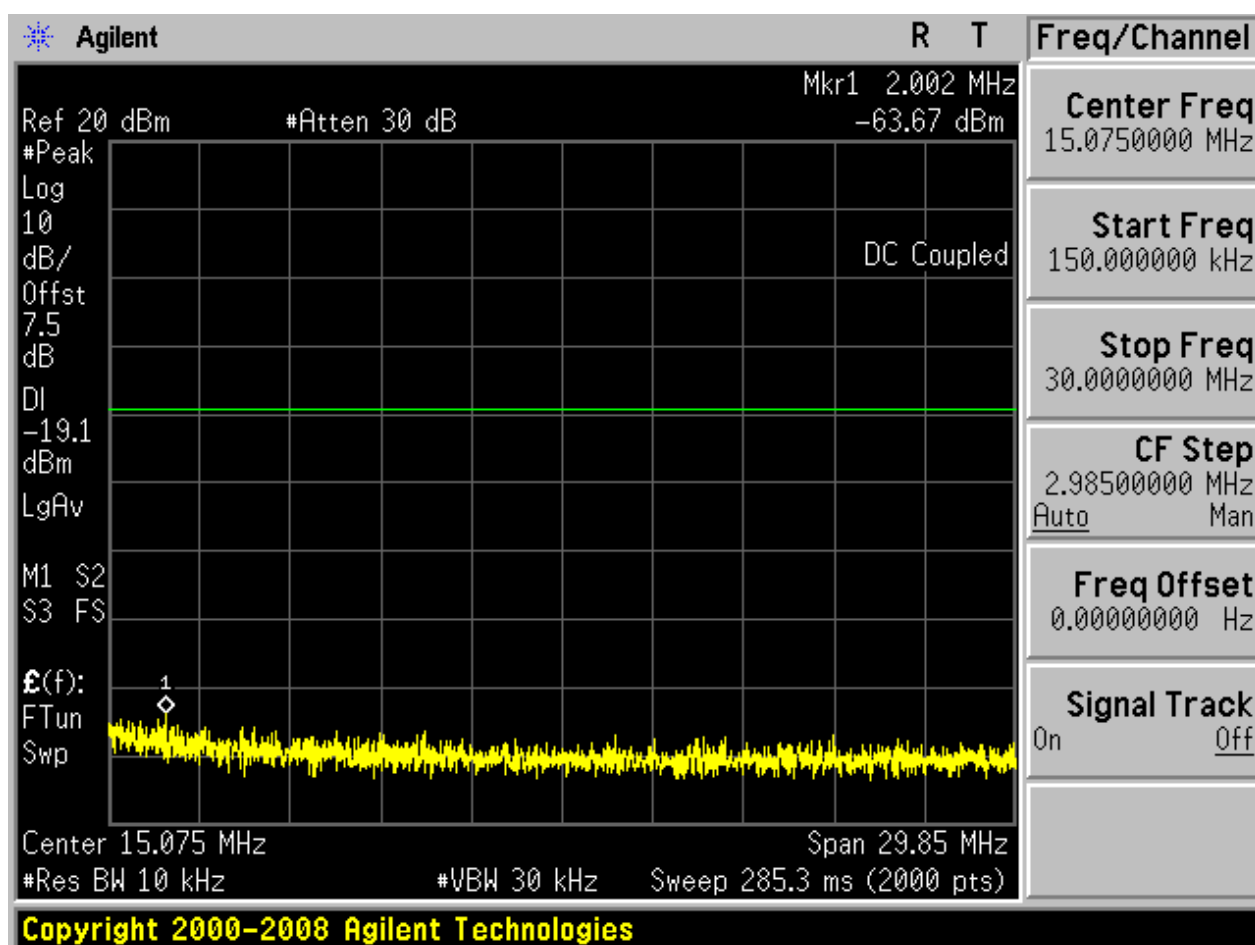
2.6 TM2_2DH5_Ch78

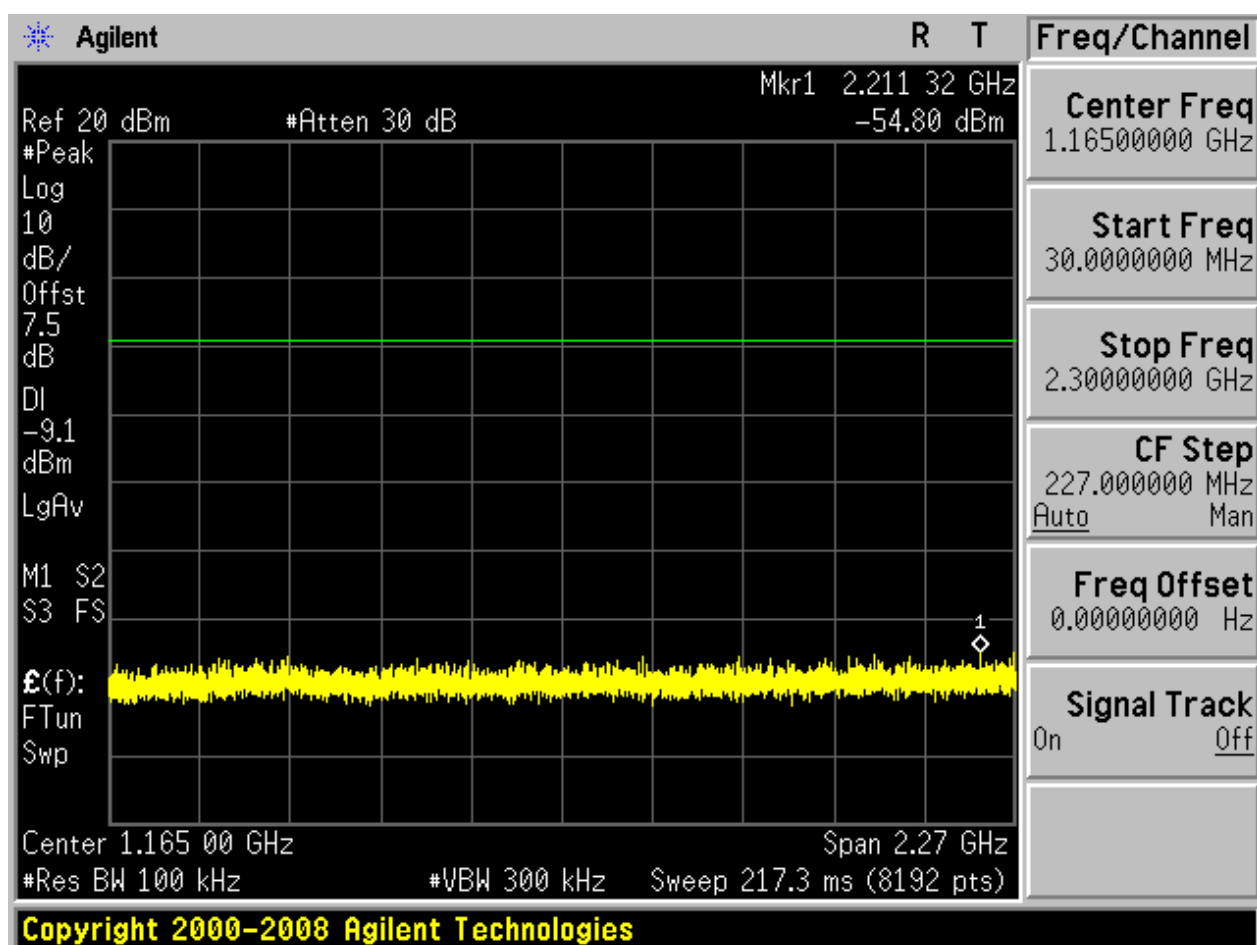
2.6.1 Pref

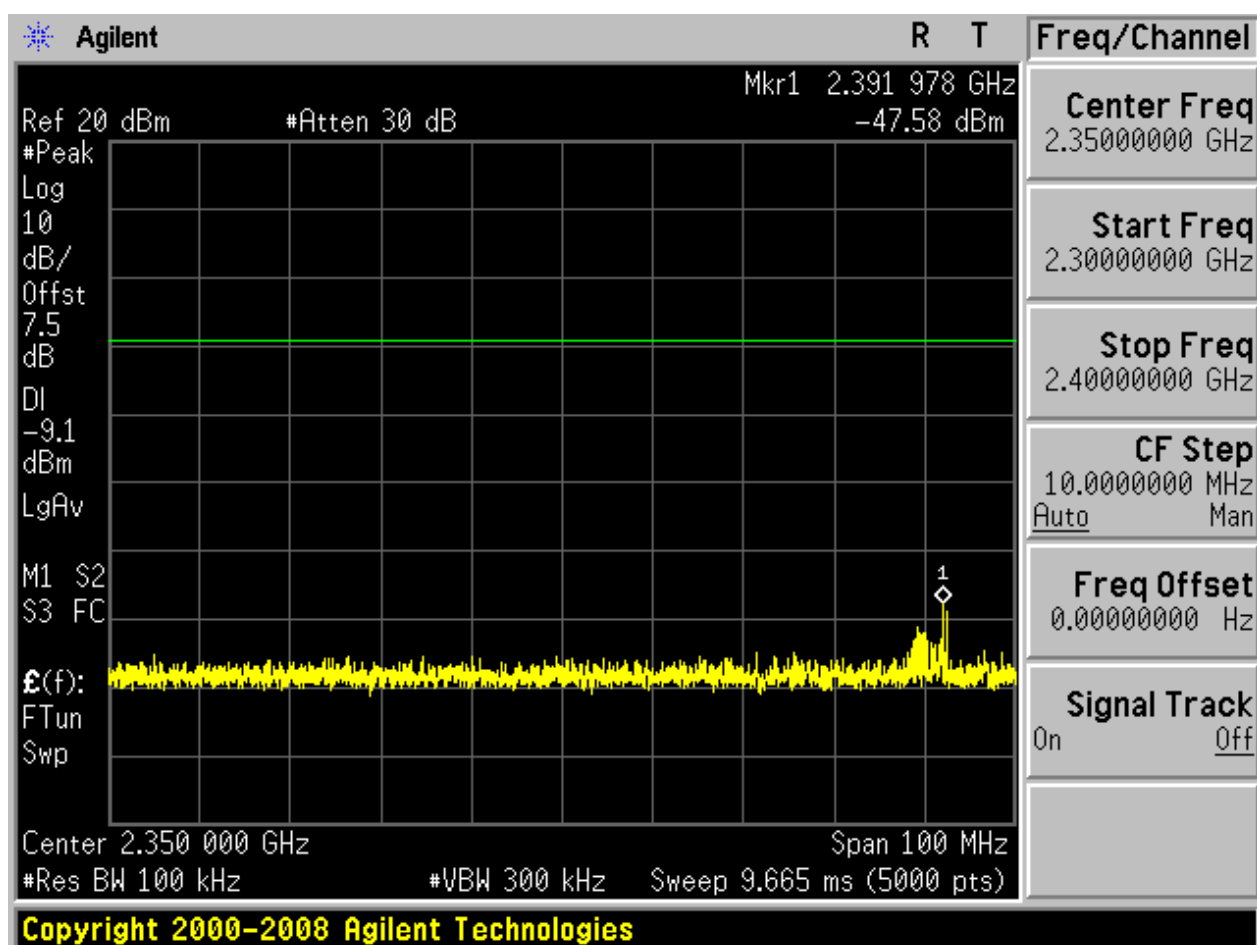


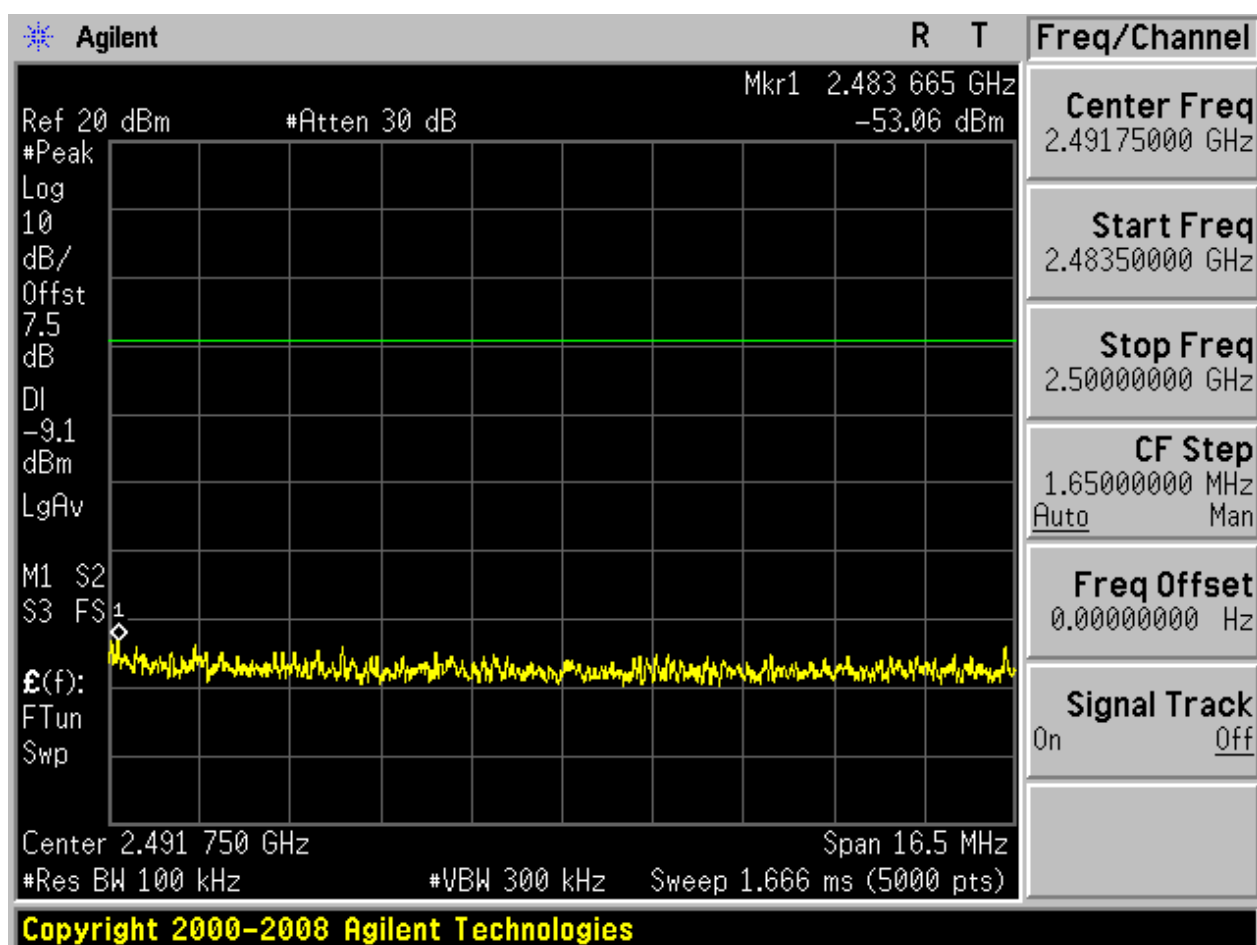
2.6.2 Puw

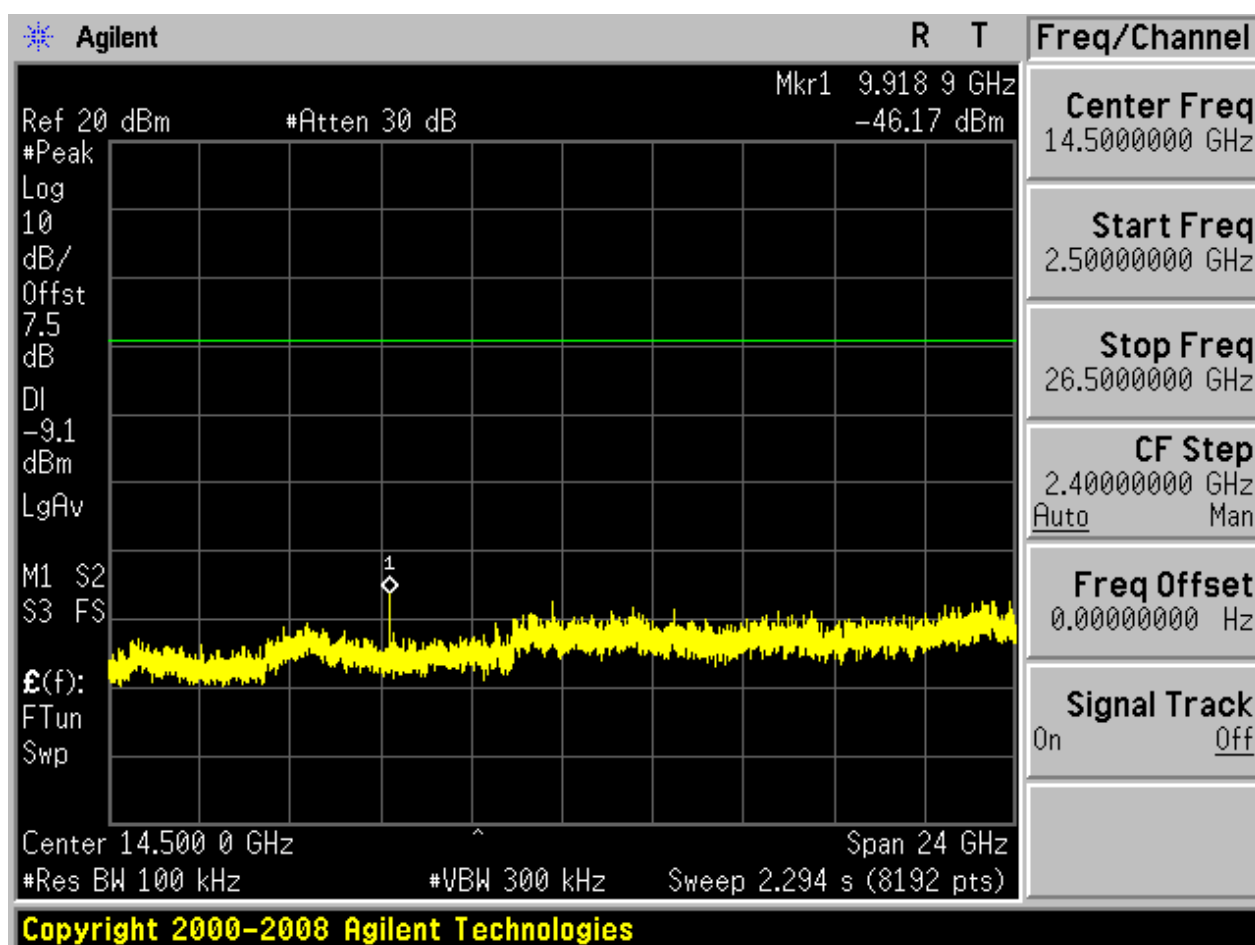






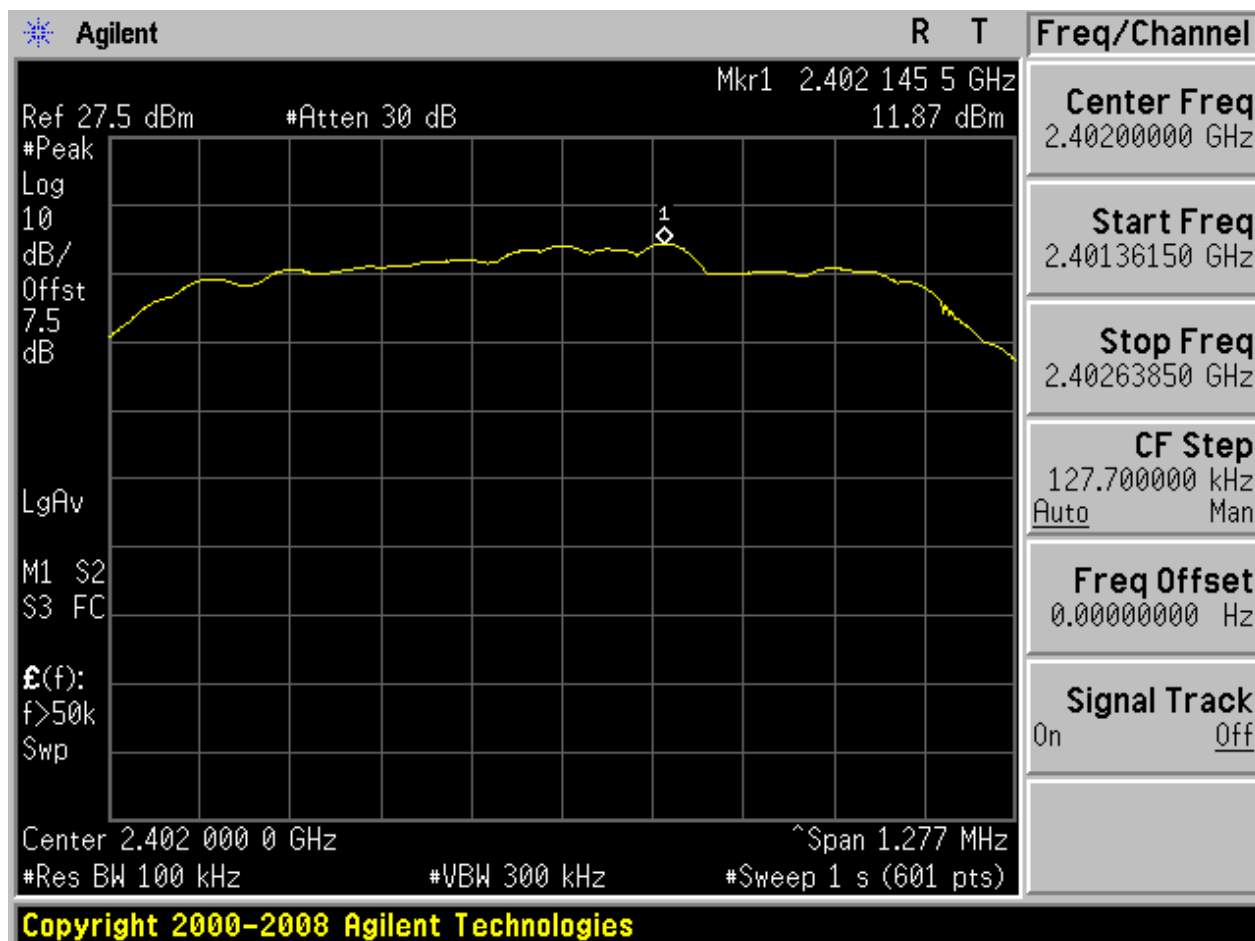




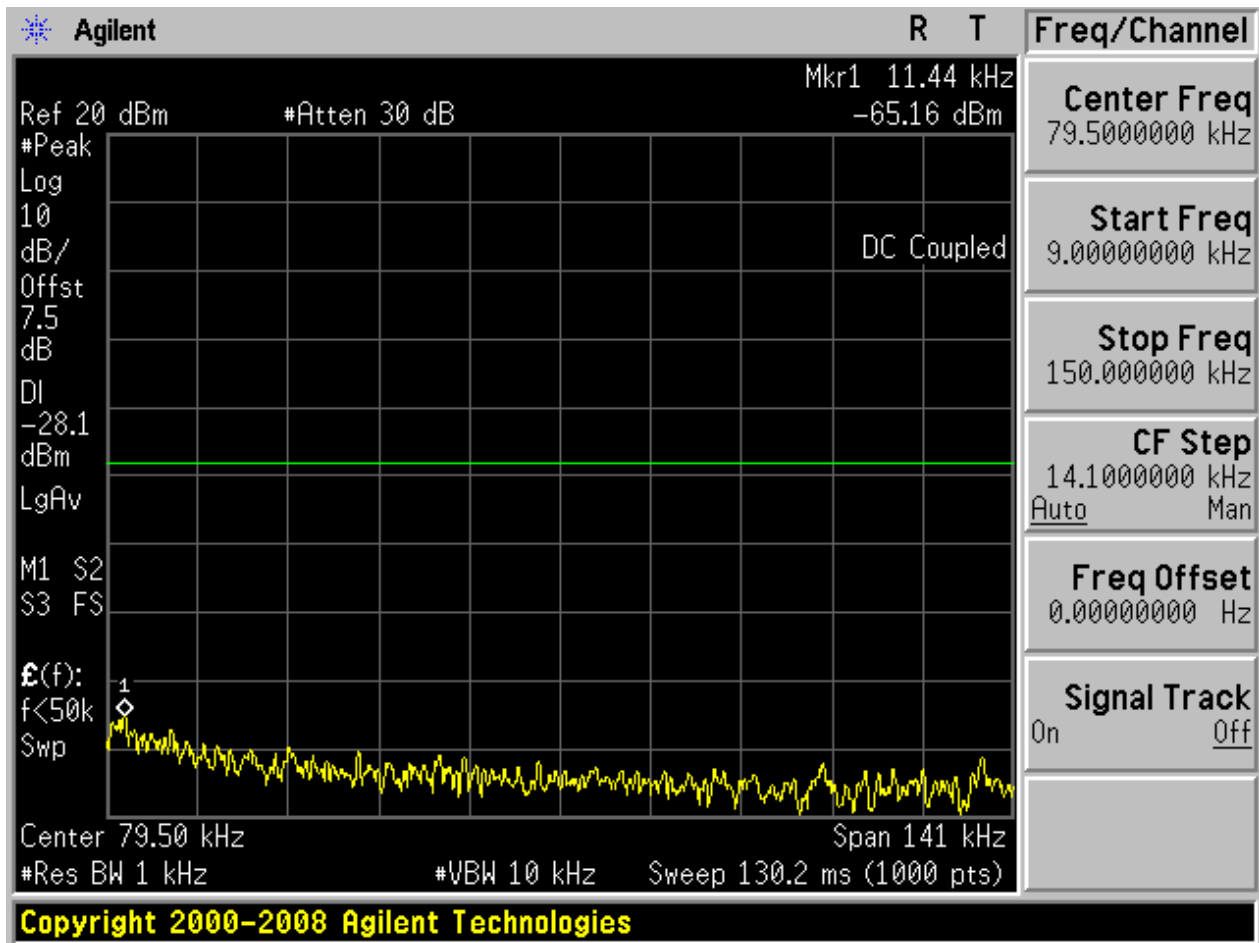


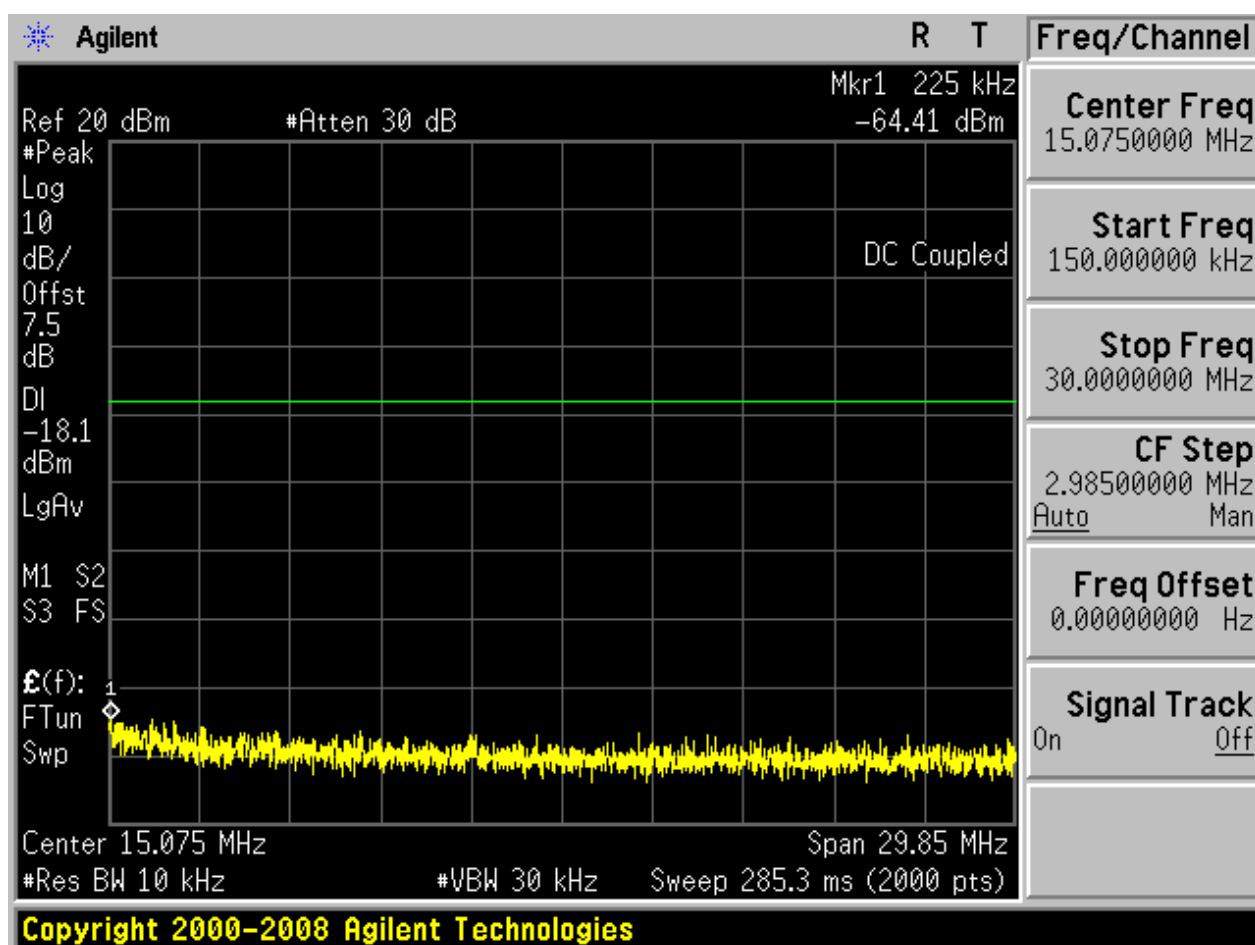
2.7 TM3_3DH5_Ch0

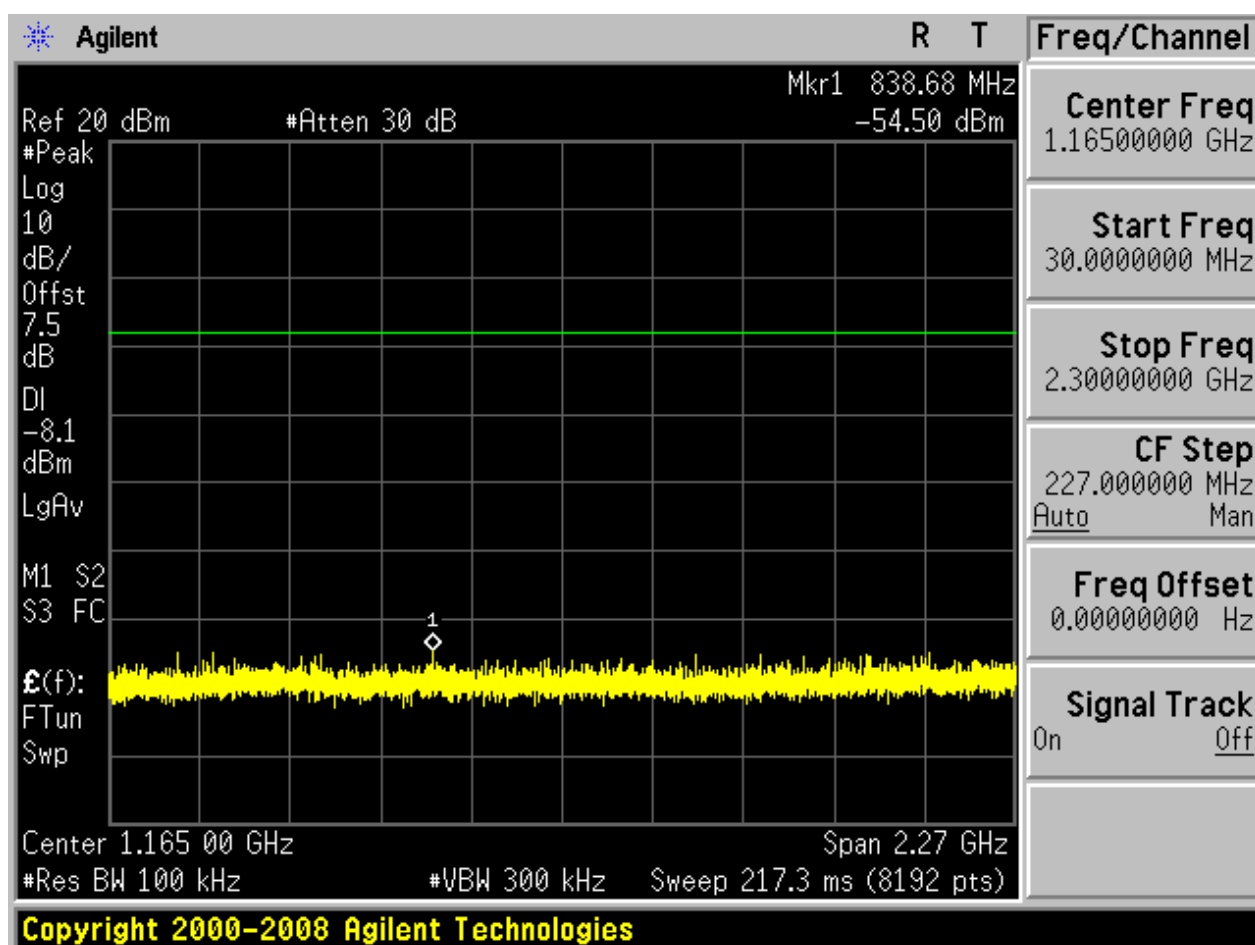
2.7.1 Pref

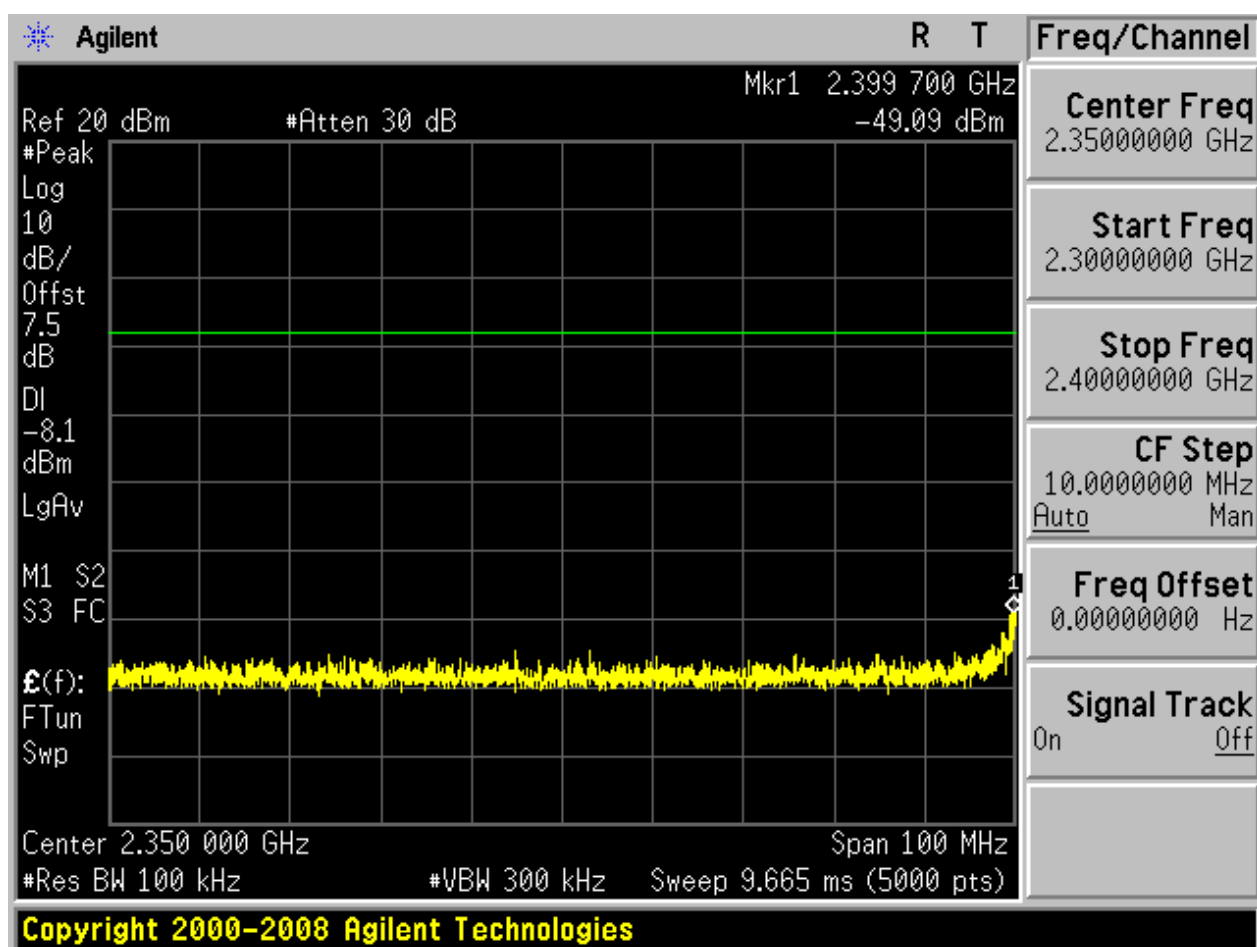


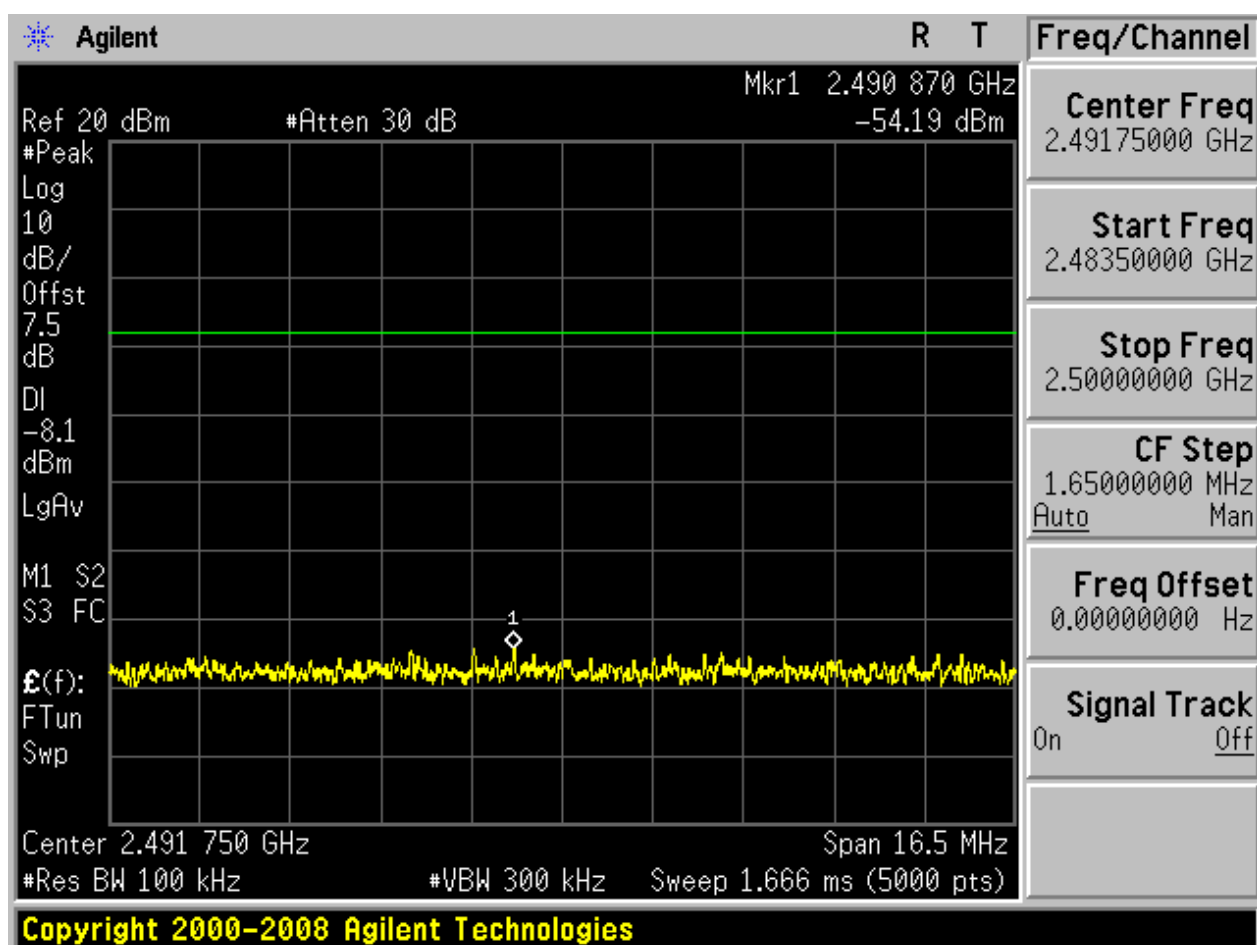
2.7.2 Puw

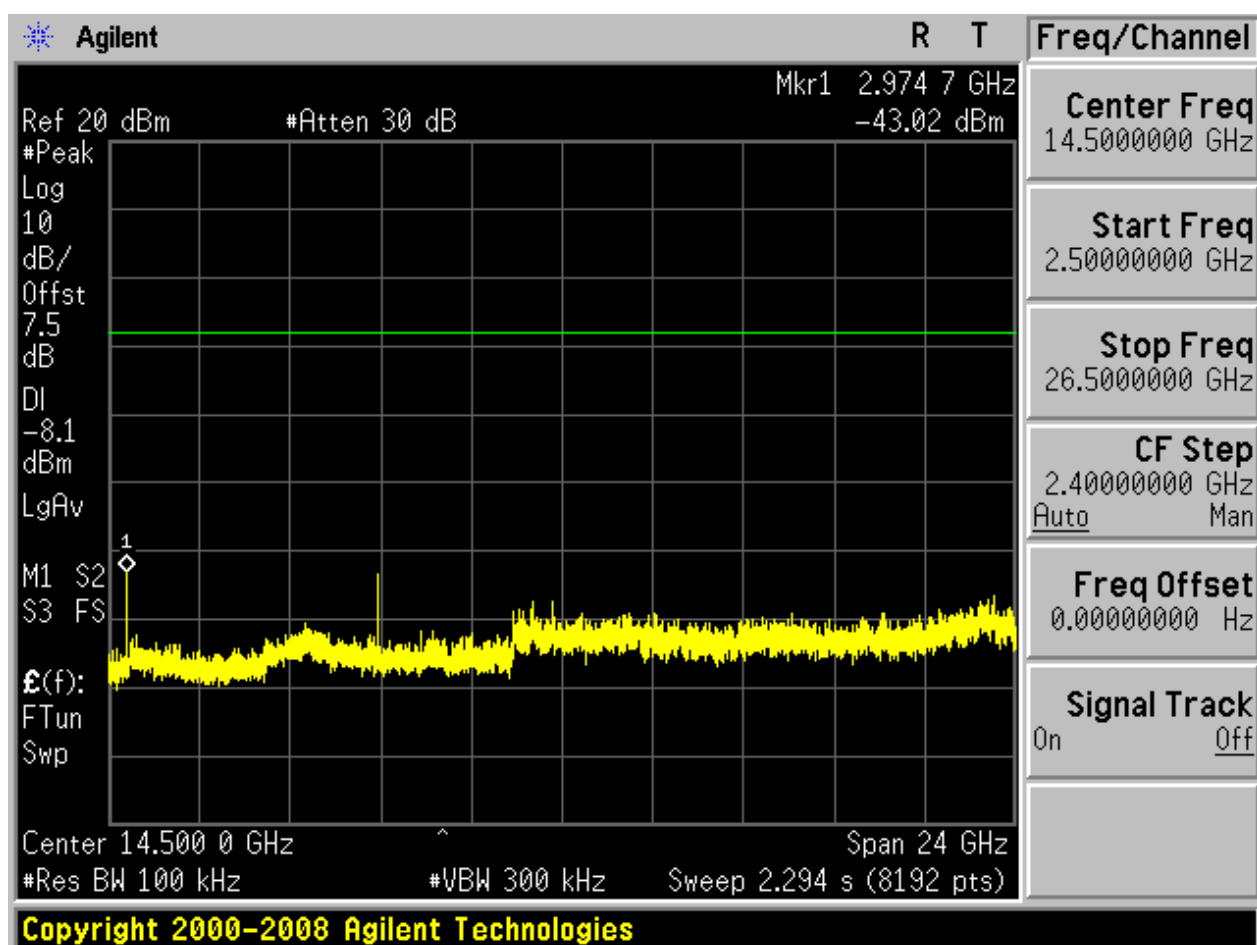








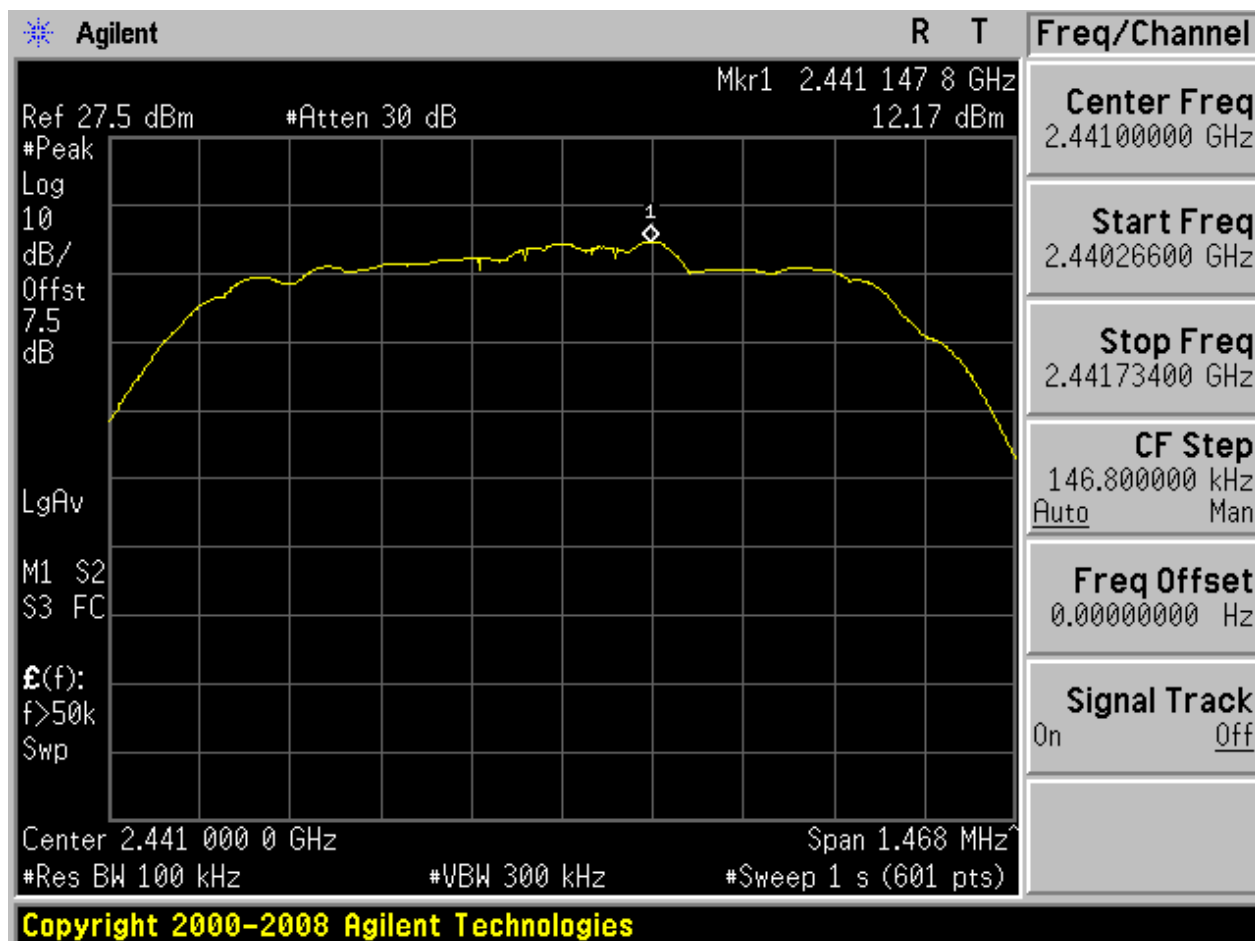




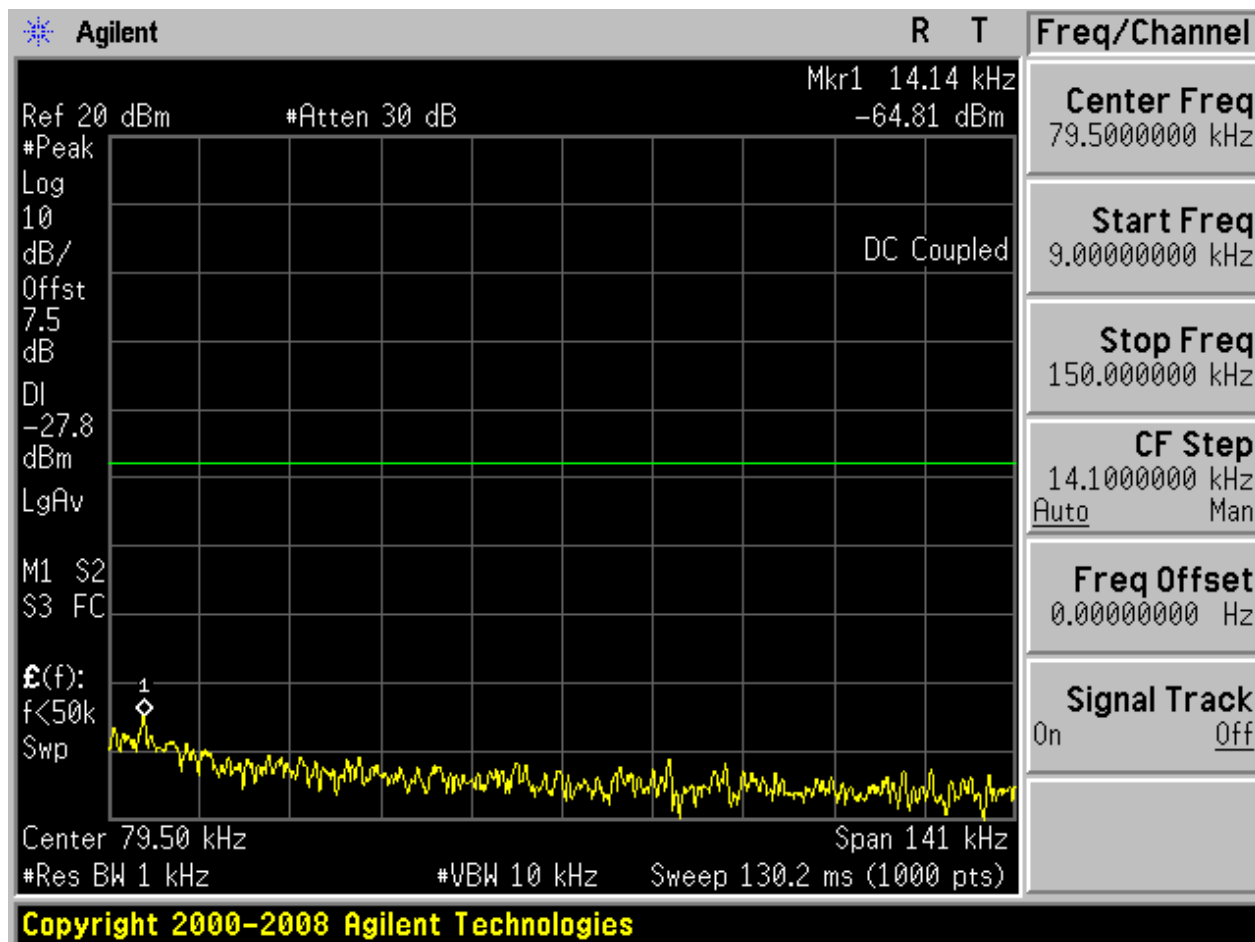


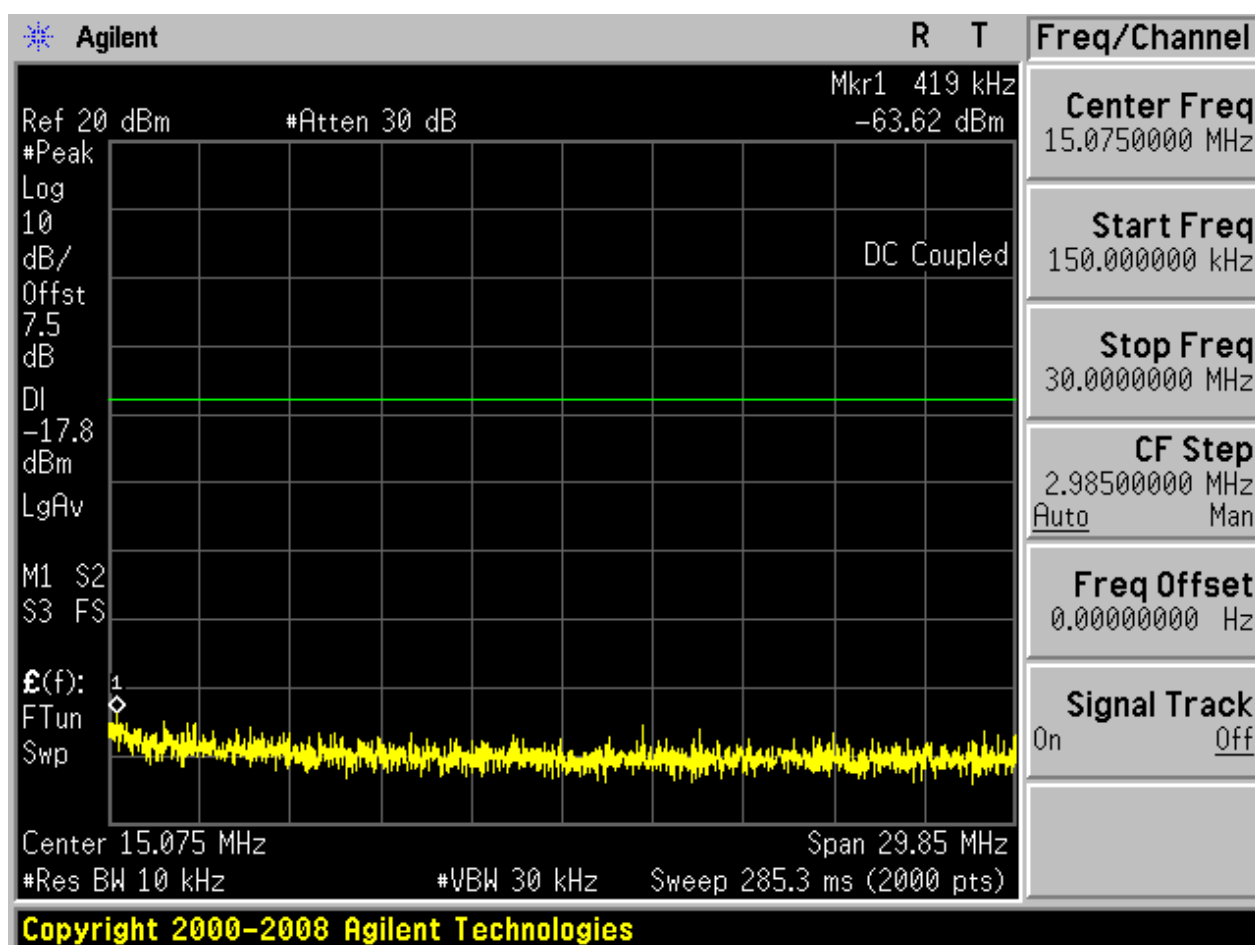
2.8 TM3_3DH5_Ch39

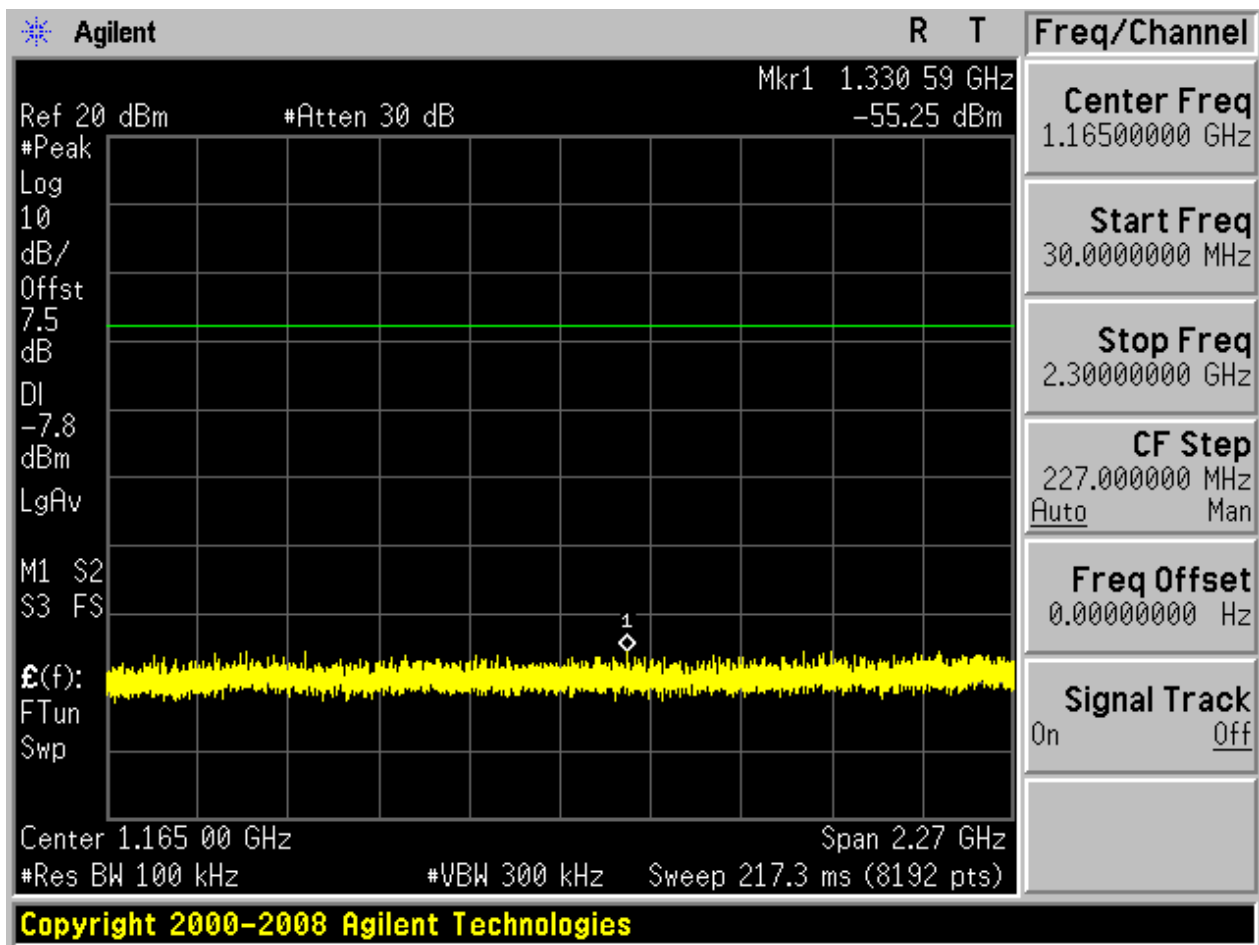
2.8.1 Pref

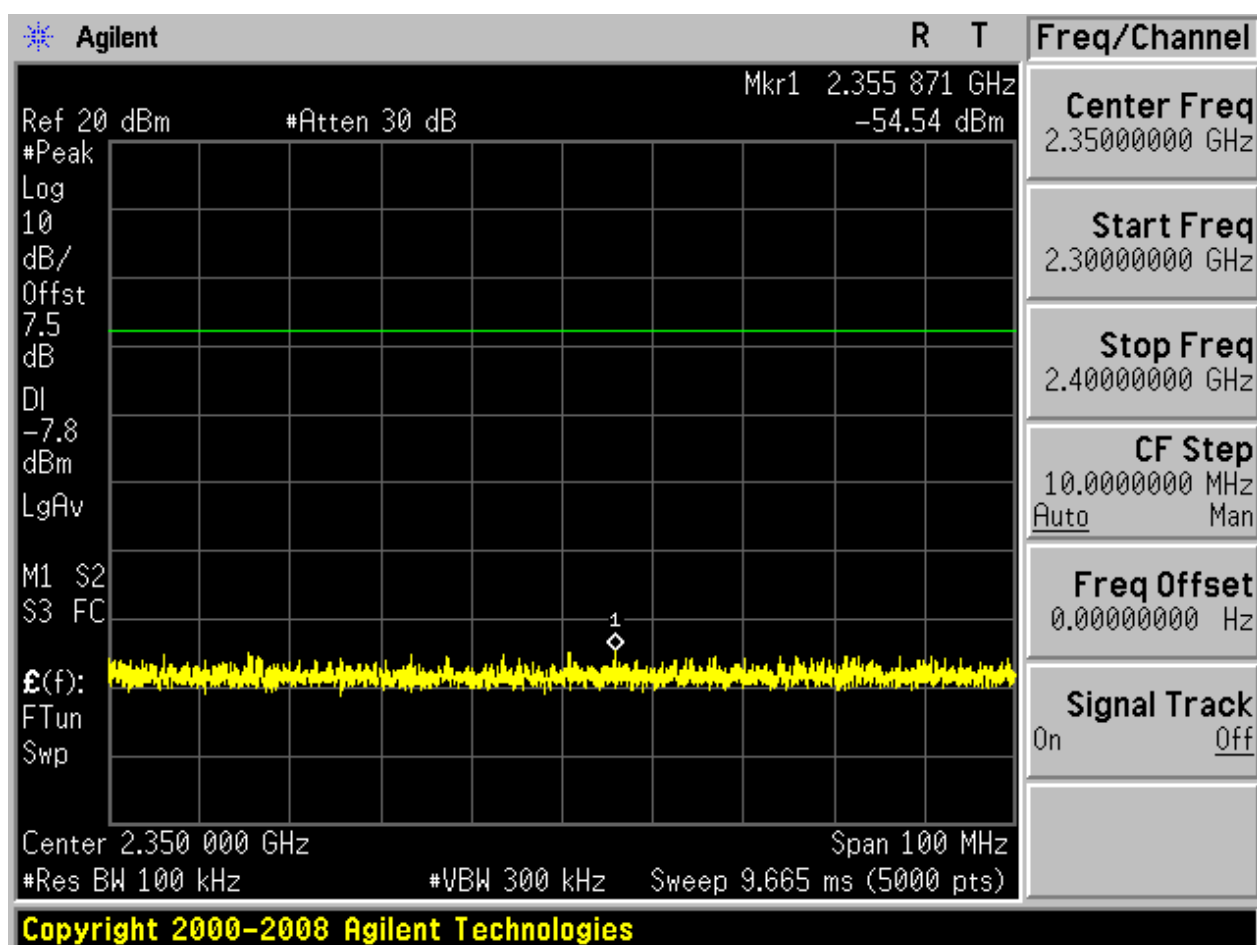


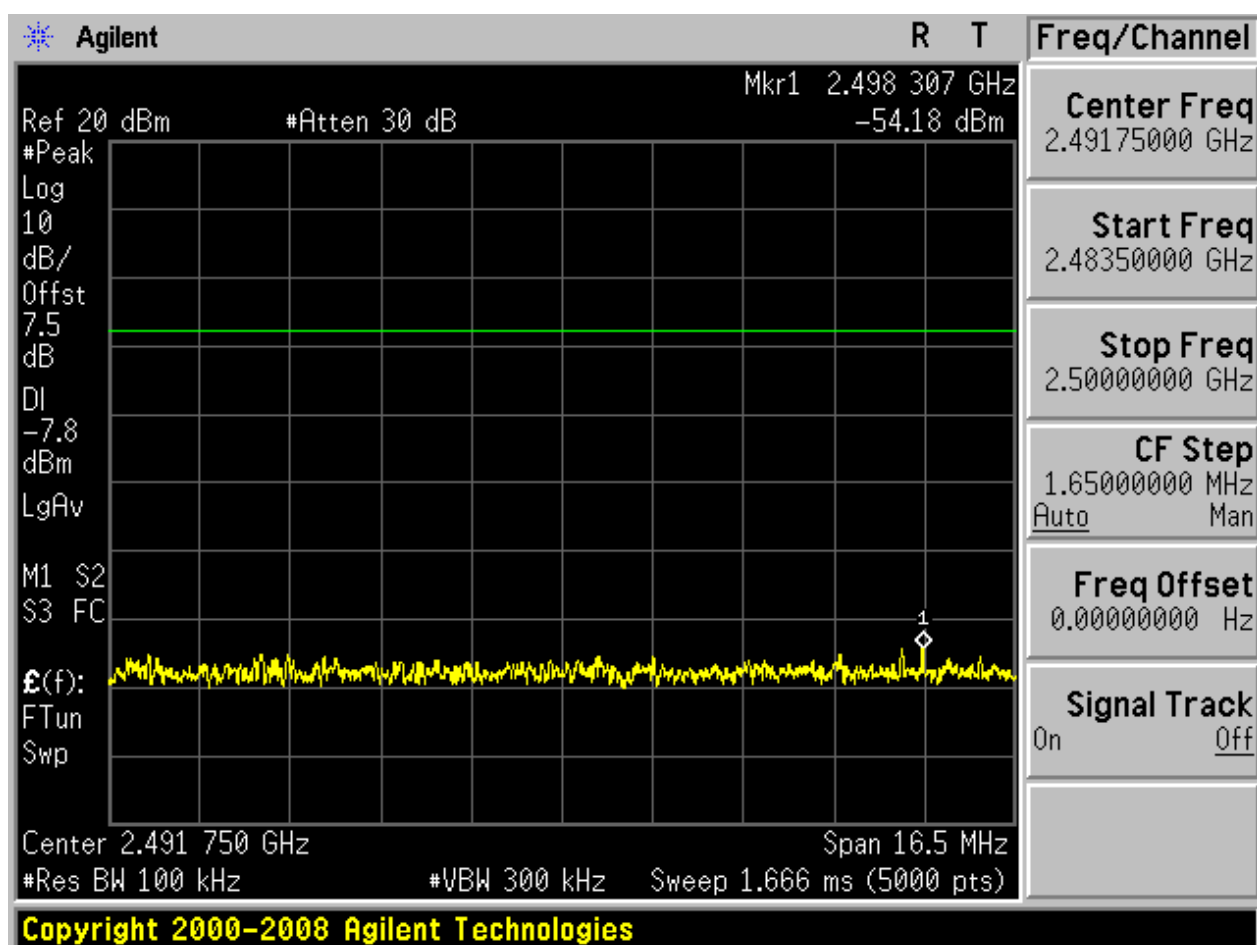
2.8.2 Puw

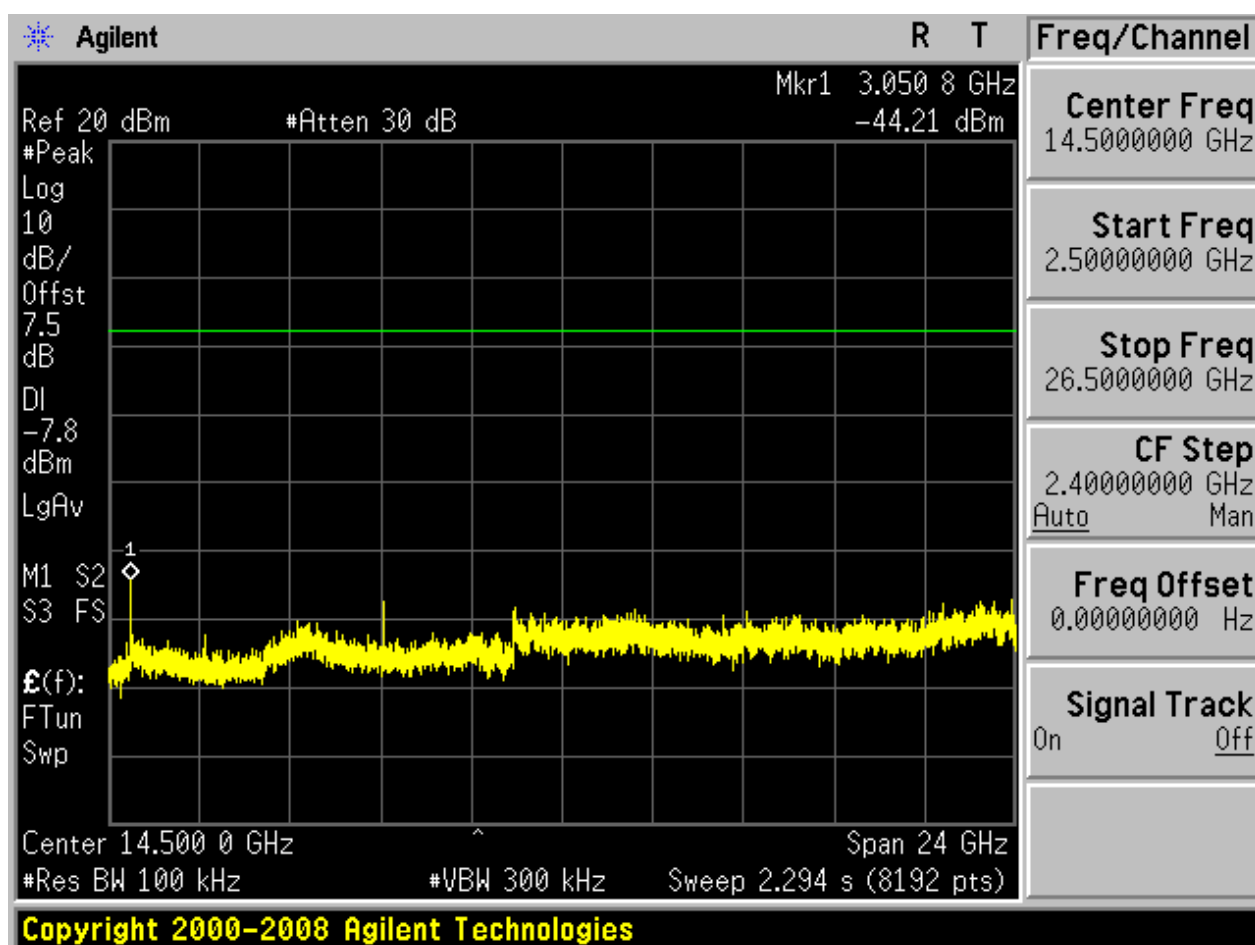






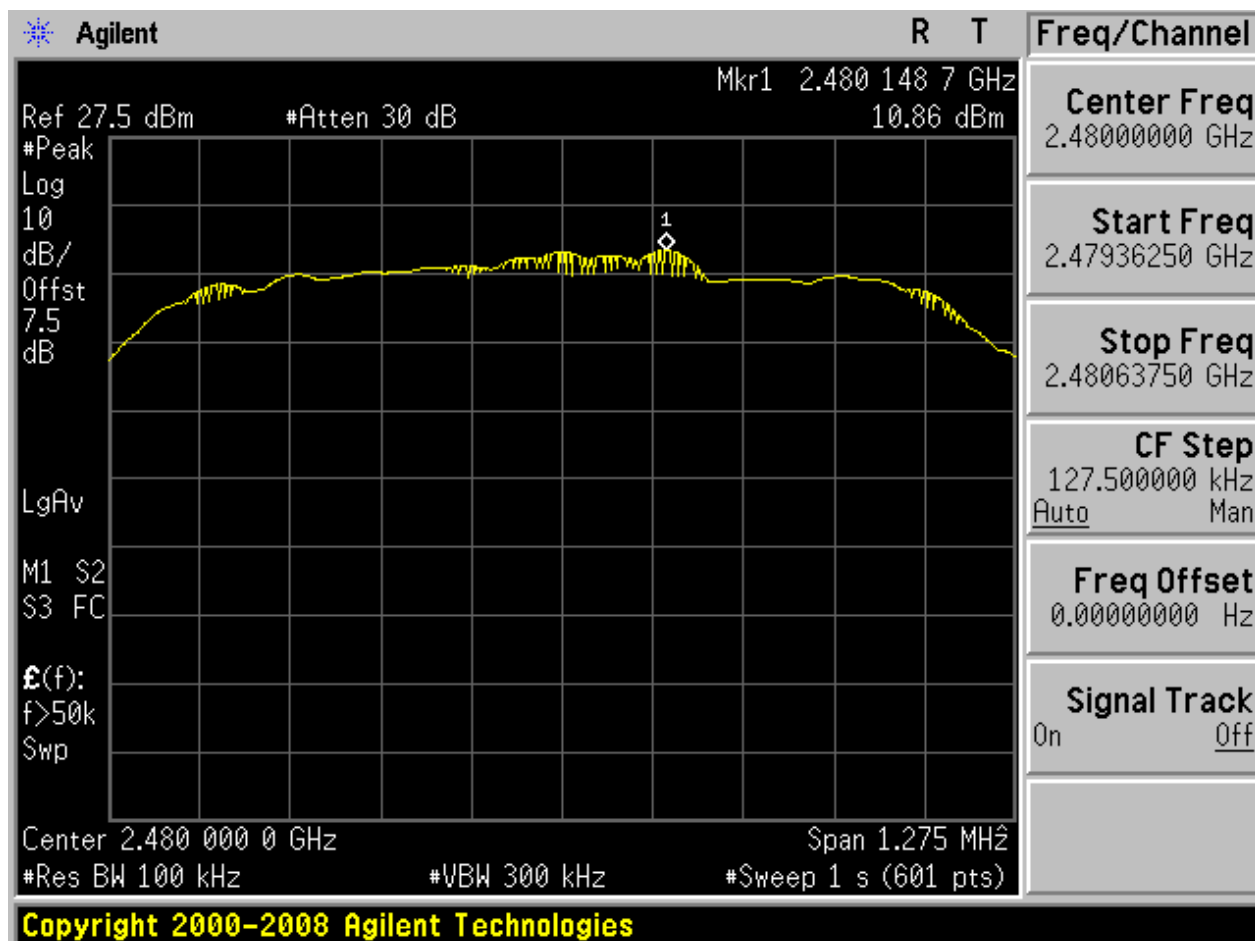






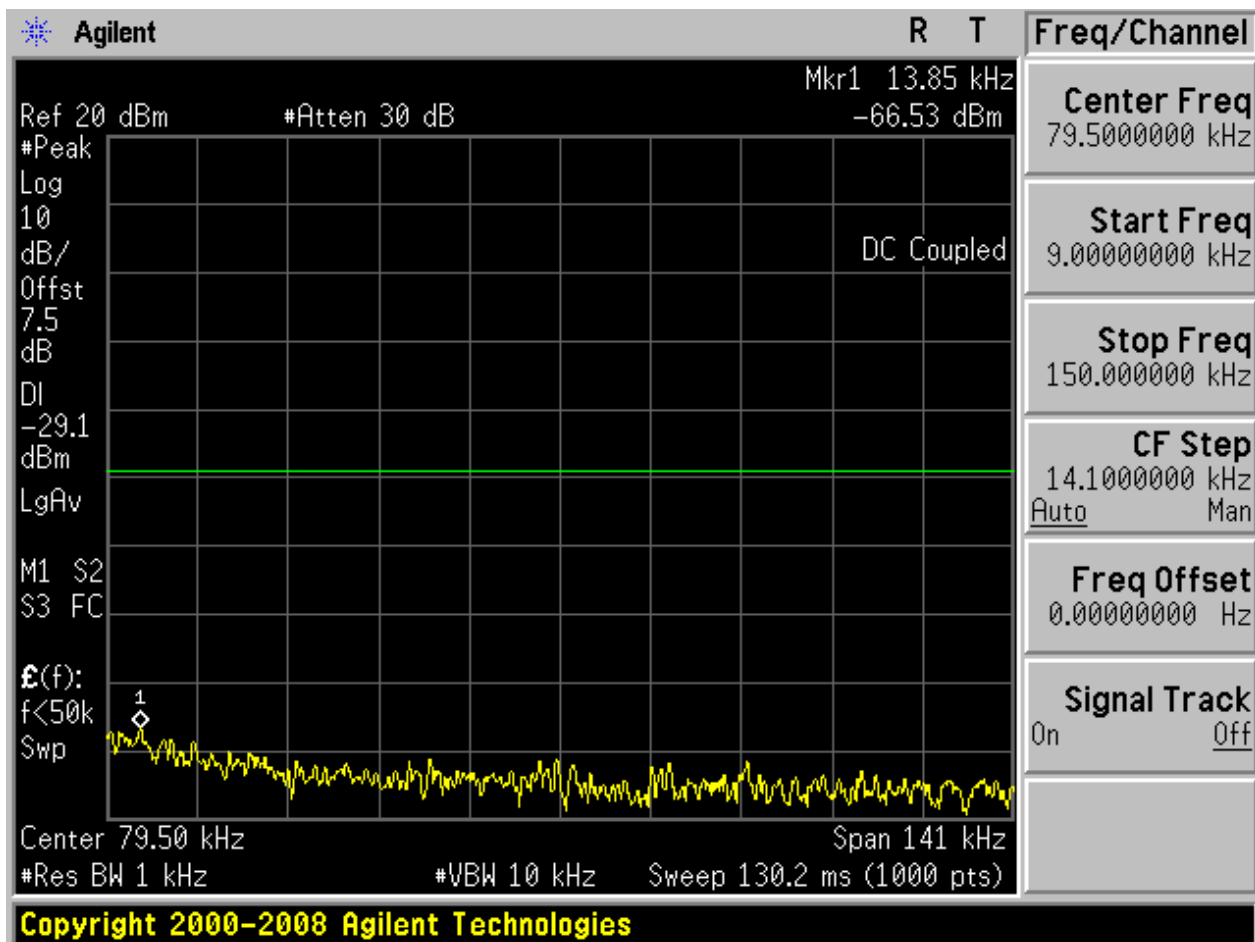
2.9 TM3_3DH5_Ch78

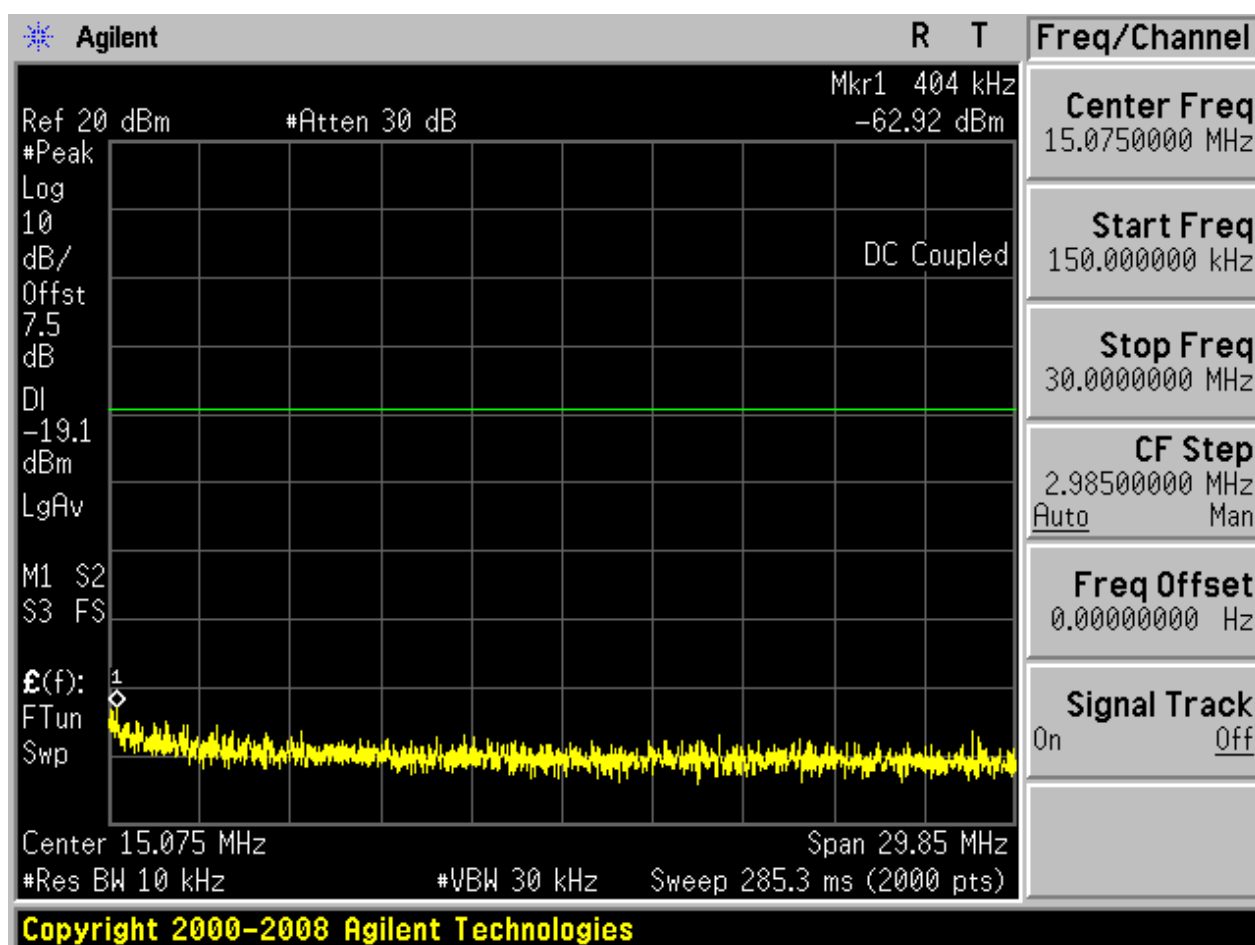
2.9.1 Pref

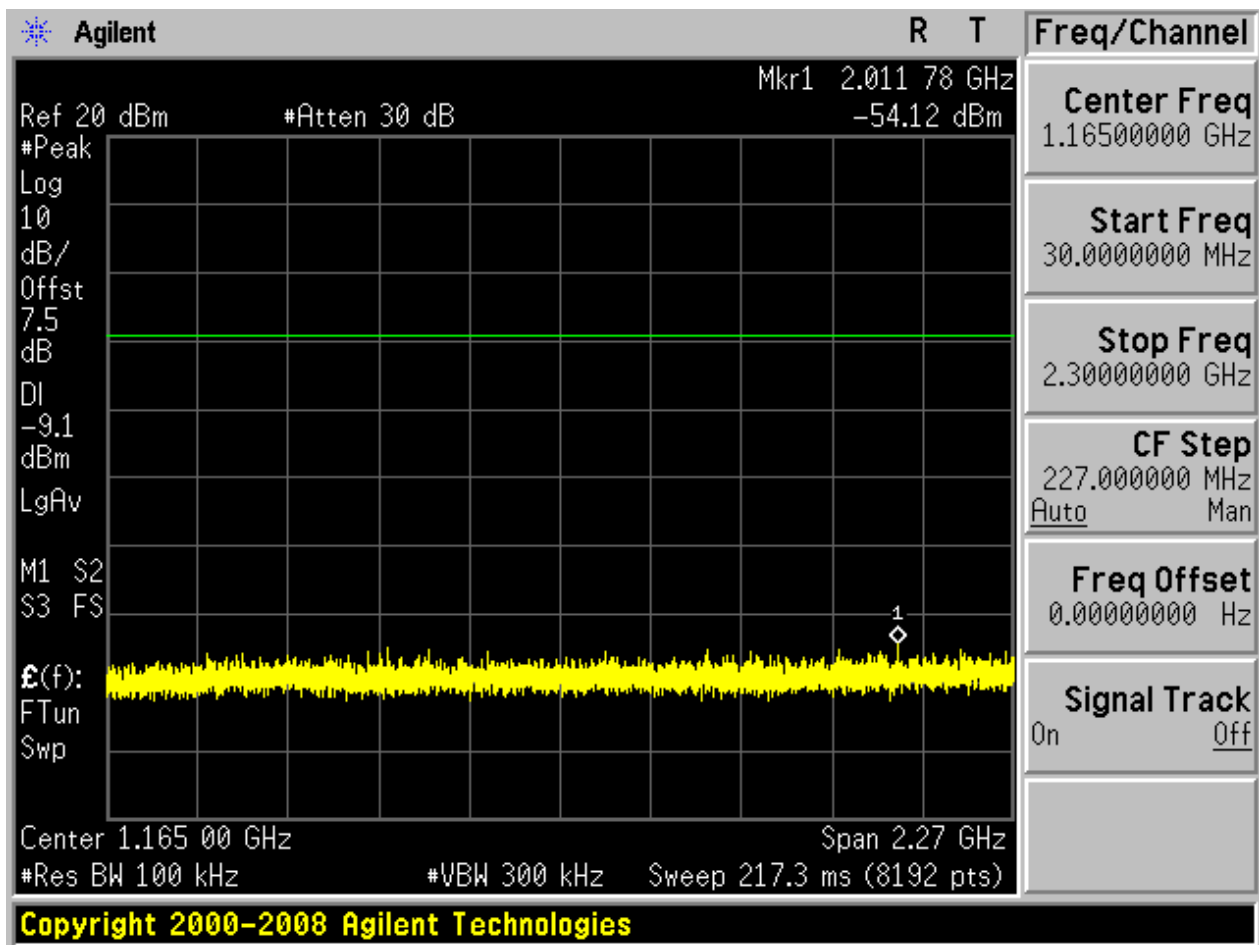


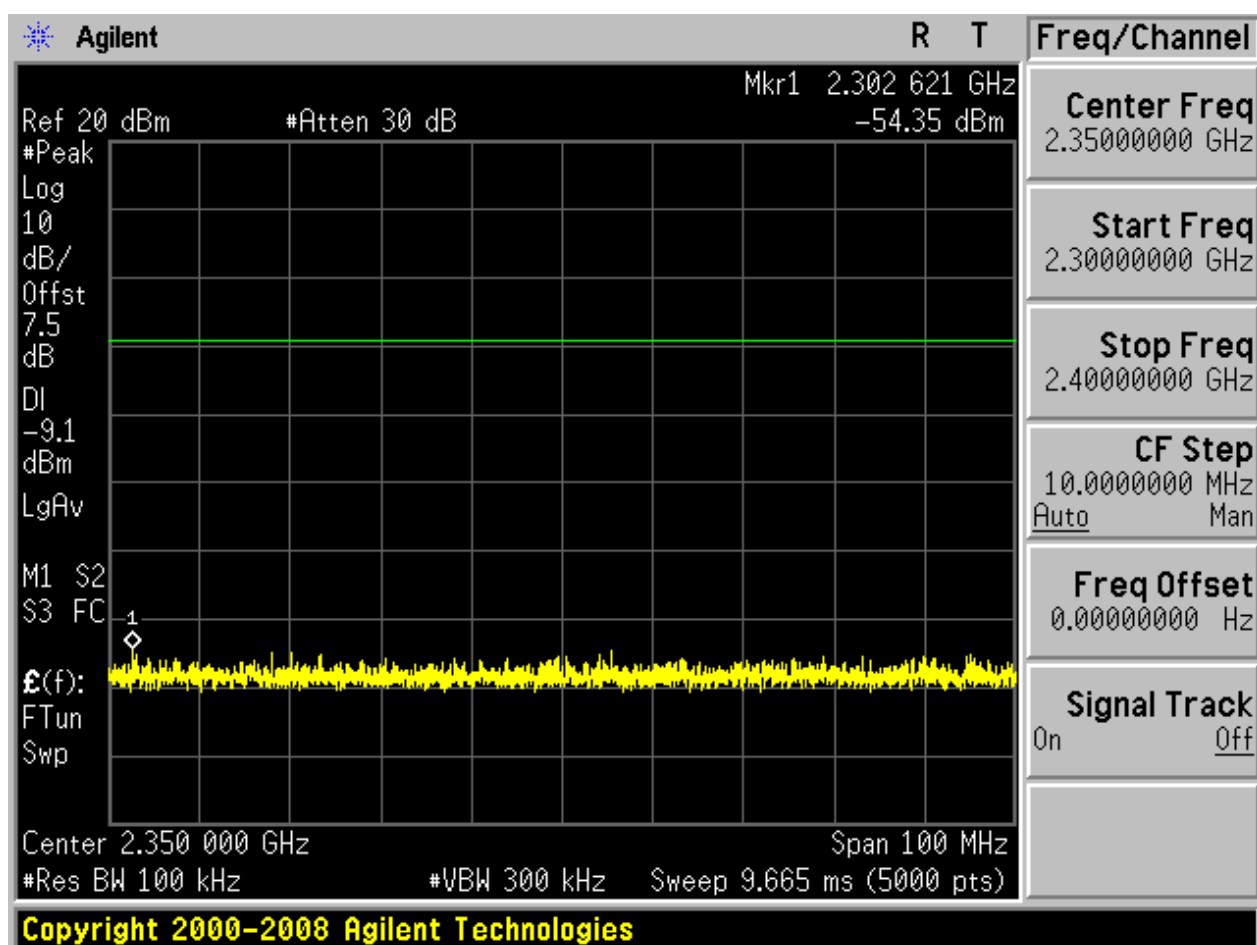


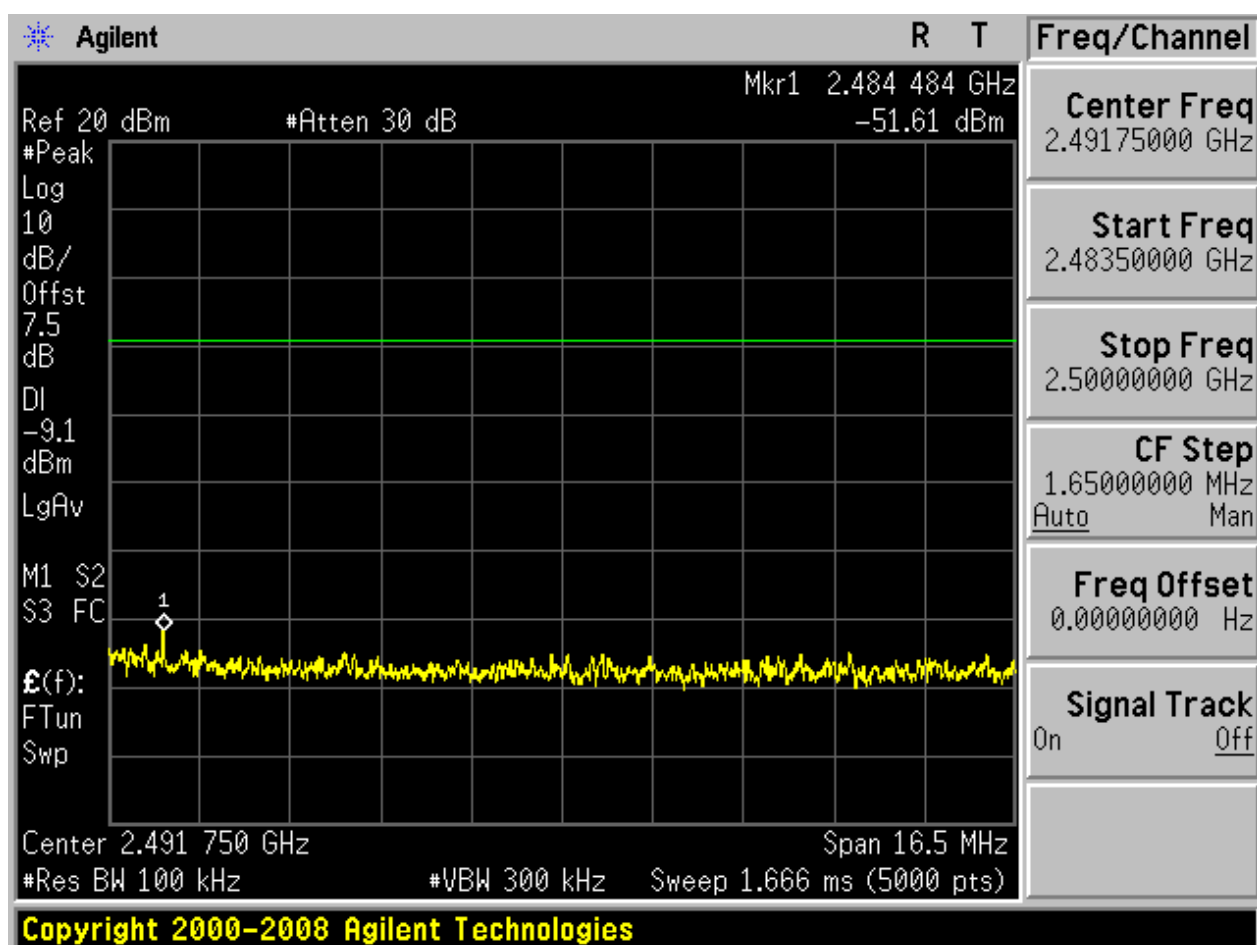
2.9.2 Puw

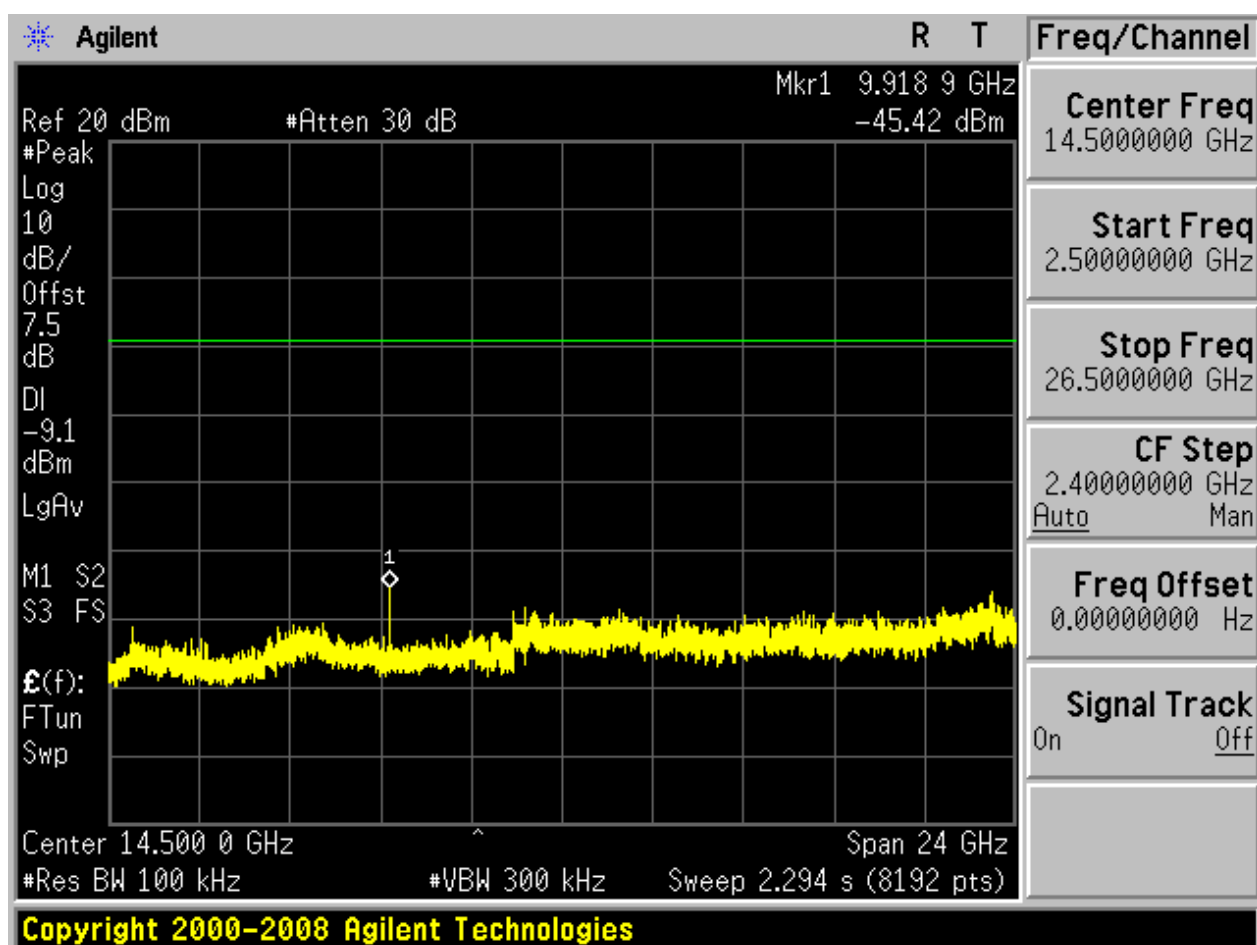












Appendix H: Radiated Emissions in the Restricted Bands

1 Result Table

We tested all modes, but the data presented below is the worst case.

The whole testing range is from “30 MHz to 26.5 GHz (10th harmonics)” is divided into 4 parts according to the test site settings, which are:

- (Part 1): Test range of “9 KHz to 30 MHz”,
- (Part 2): Test range of “30 MHz to 1 GHz”,
- (Part 3): Test range of “18 GHz to 26.5 GHz”.
- (Part 4): Test range of “2.3 GHz to 2.5 GHz”, and
- (Part 5): Test range of “1 GHz to 18 GHz”.

In this Appendix, only the test results and plots under the worst case can be reported. In the result table, the “< Limit” denotes that “Not found obvious spikes or see marked spikes on plots and listed emissions records”.

Test Range	EUT Conf.	Emissions	Verdict
30 MHz to 1 GHz	TM1_DH5_Ch0 (Worst Conf.)	< Limit	Pass
1 GHz to 3 GHz	TM1_DH5_Ch0 (Worst Conf.)	< Limit	Pass
	TM1_DH5_Ch78 (Worst Conf.)	< Limit	Pass
3 GHz to 18 GHz	TM1_DH5_Ch0 (Worse Conf.)	< Limit	Pass
18 GHz to 26.5 GHz	TM1_DH5_Ch0 (Worst Conf.)	< Limit	Pass

2 Result Plot

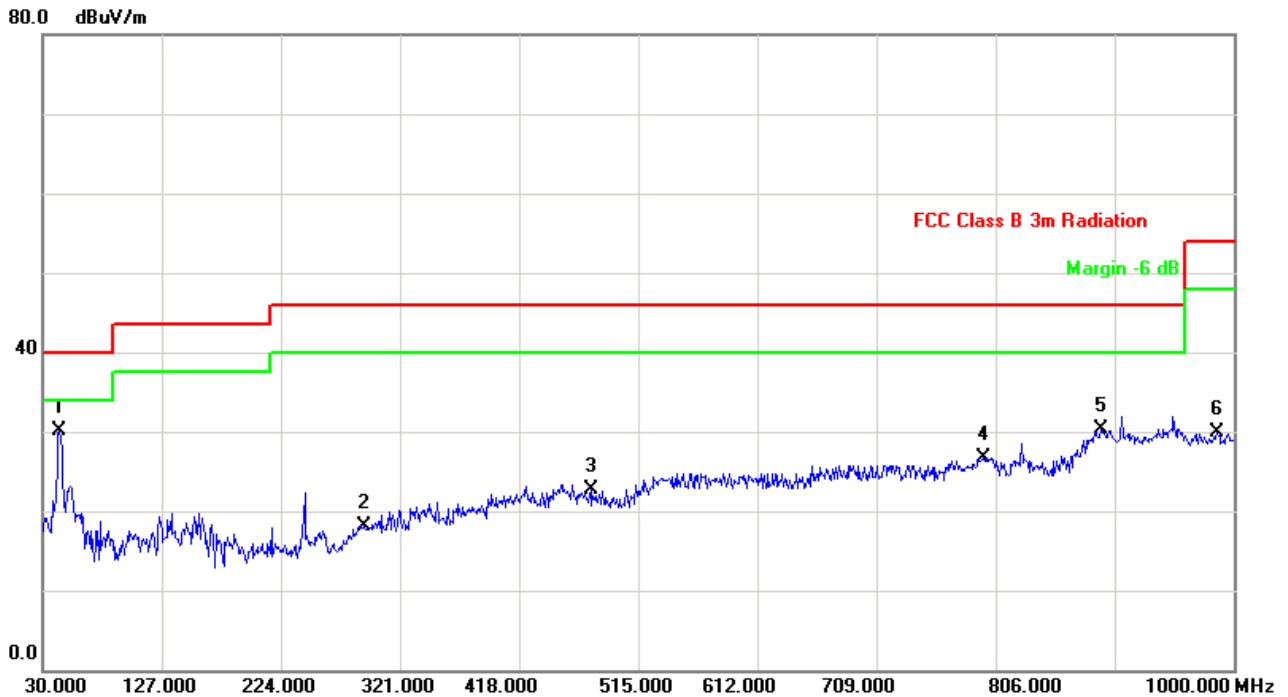
Part 1: Testing Range of “9 KHz to 30 MHz”

NOTE1: No peak found in the Test Range of “9 kHz to 30MHz”

Part 2: Testing Range of “30 MHz to 1 GHz”

Note 1: The test results and plot for testing range of “30 MHz to 1 GHz” showed as below is the WORST case for all Test Modes and Channels. This range will not be presented for each Test Mode and each Channel.

Note 2: The emissions in this range are mainly from the Platform Device (Notepad PC and its ancillary components).



Freq. (MHz)	Ant. H/V	Reading(RA) (dBuV)	Corr.Factor(CF) (dB)	Measured(FS) (dBuV/m)	Limits(QP) (dBuV/m)	Margin (dB)
43.5800	V	42.23	-12.08	30.15	40.00	-9.85
291.9000	V	27.94	-9.86	18.08	46.00	-27.92
476.2000	V	29.34	-6.70	22.64	46.00	-23.36
796.3000	V	25.12	1.62	26.74	46.00	-19.26
891.3600	V	27.12	3.13	30.25	46.00	-15.75
986.4200	V	27.45	2.48	29.93	54.00	-24.07



Part 3: Testing Range of “18 GHz to 26.5 GHz”

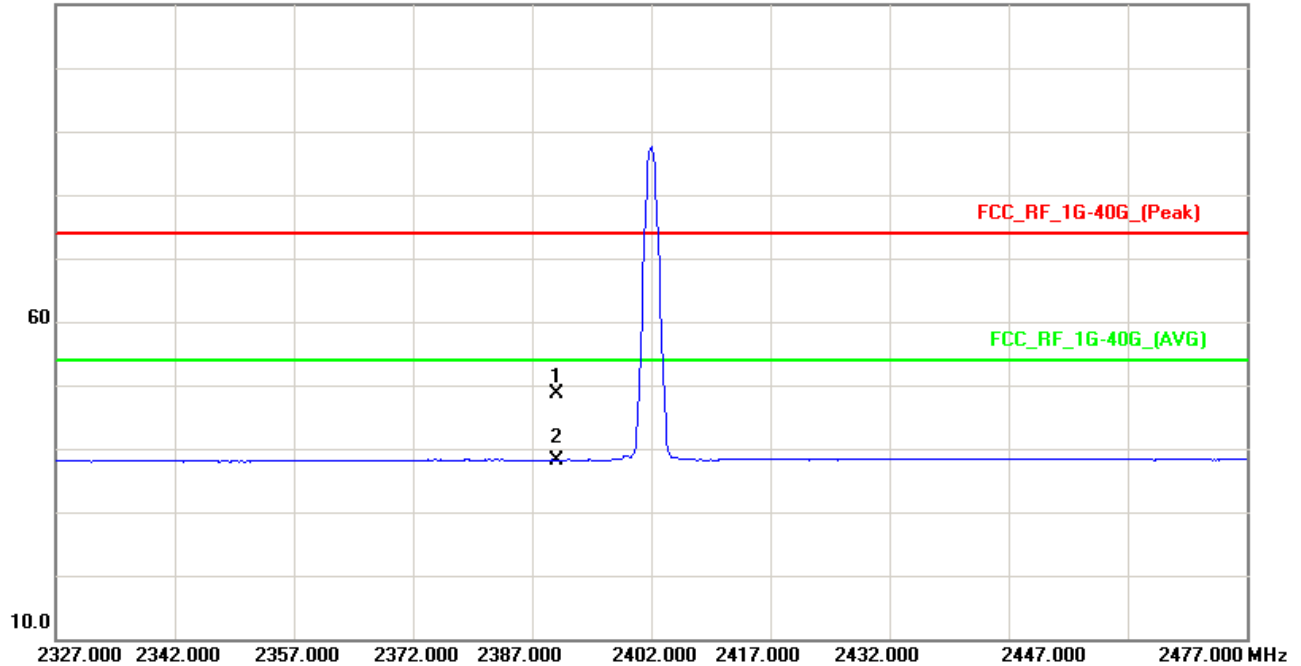
NOTE1: No peak found in the Test Range of “18 GHz to 26.5 GHz”

Part 4: Testing Range of “2.3GHz to 2.5GHz”

- Note 1: The testing range of “2.3 GHz to 2.5 GHz” is for checking radiated emissions located in restricted bands near the EUT operating bands.
- Note 2: Two limits are required in the testing range above 1 GHz, that is Peak limit (74 dB μ V/m) and Average Limit (54 dB μ V/m).
- Note 3: The peak spike exceeds the limit line is EUT's operating frequency.

Channel 0

110.0 dB μ V/m

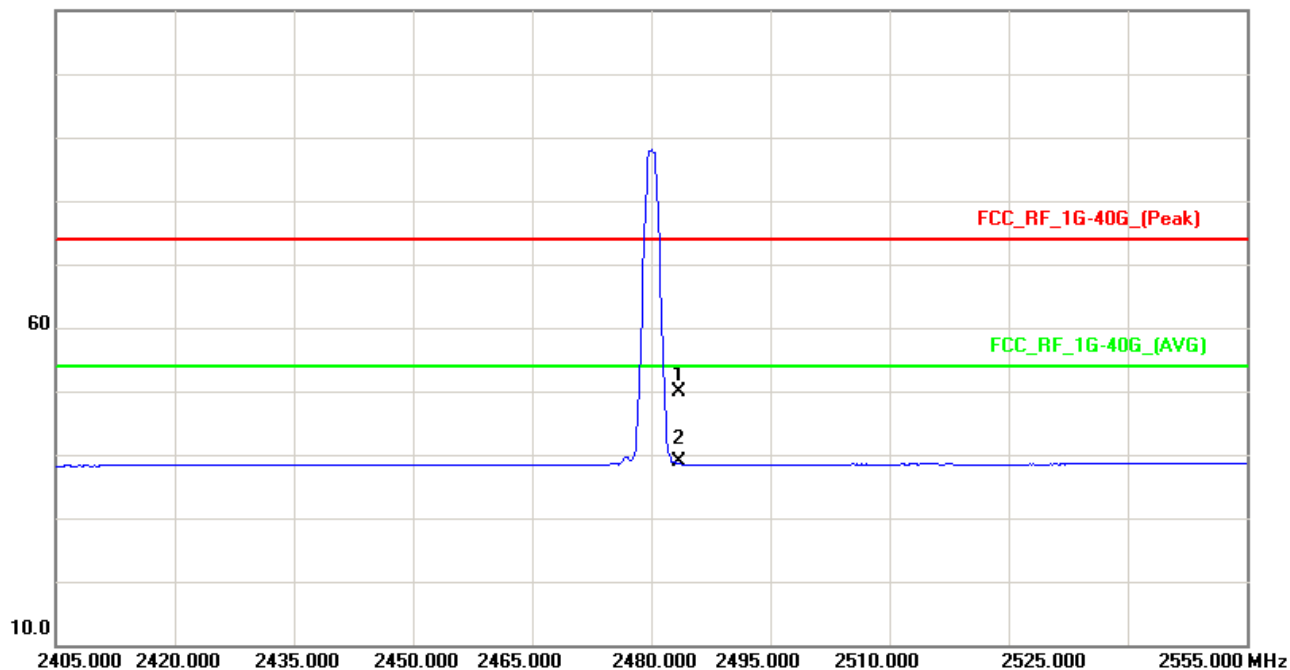


Note: The peak exceeds the limit line is carrier frequency.

Freq. (MHz)	Ant. H/V	Reading(RA) (dB μ V)	Corr.Factor(CF) (dB)	Measured(FS) (dB μ V/m)	Limits (dB μ V/m)	Margin (dB)	Note
2390.000	V	16.73	34.17	50.90	74.00	-23.10	Peak
2390.000	V	4.35	34.17	38.52	54.00	-15.48	AVG

Channel 78

110.0 dBuV/m

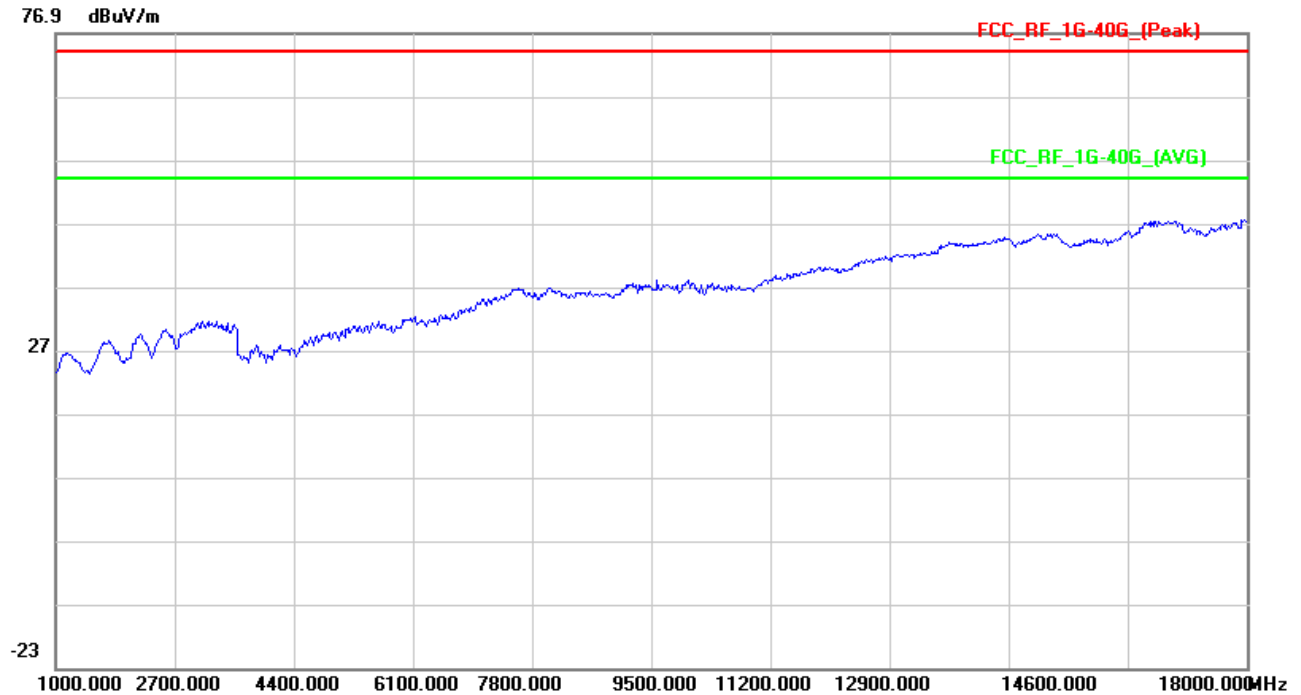


Note: The peak exceeds the limit line is carrier frequency.

Freq. (MHz)	Ant. H/V	Reading(RA) (dBuV)	Corr.Factor(CF) (dB)	Measured(FS) (dBuV/m)	Limits (dBuV/m)	Margin (dB)	Note
2483.500	H	15.42	34.43	49.85	74.00	-24.15	Peak
2483.500	H	4.34	34.43	38.77	54.00	-15.23	AVG

Part 5: Testing Range of “1 GHz to 18 GHz”

- Note 1: The test results and plot for testing range of “1 GHz to 18 GHz” showed as below is the WORST case for all Test Modes and Channels. This range will not be presented for each Test Mode and each Channel.
- Note 2: The testing range of “1 GHz to 18 GHz” is for checking radiated emissions located in restricted bands far away from the EUT operating bands.
- Note 3: Two limits are required in the testing range above 1 GHz, that is Peak limit (74 dB μ V/m) and Average Limit (54 dB μ V/m).





Appendix I: AC Power Line Conducted Emissions

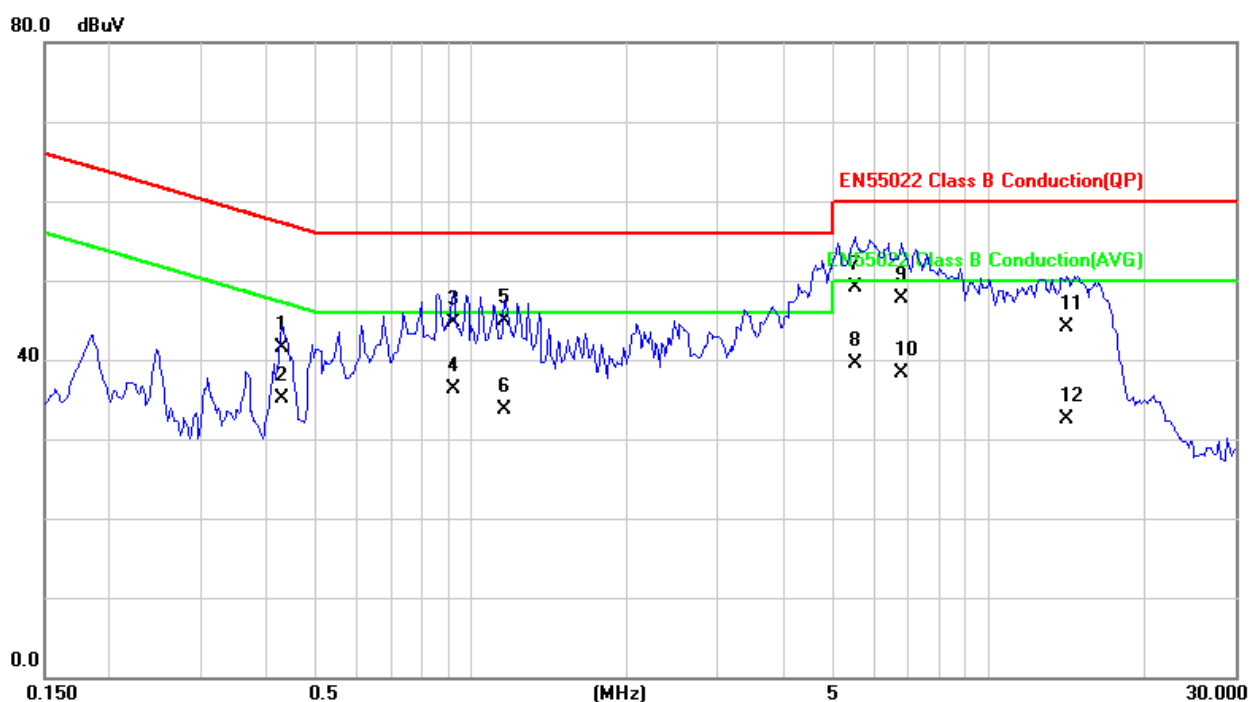
3 Result Table

In this Appendix, only the test results and plots under the worst case can be reported.

EUT Conf.	Maximum Emissions	Verdict
TM1_DH5_Ch39	Not found obvious spikes or see marked spikes on plots and listed emissions records.	Pass

4 Result Plot

4.1 TM1_DH5_Ch39



Freq. (MHz)	Terminal L/N	Measured(dBuV)		Limits(dBuV)		Margin(dB)	Note
		QP-Mode	AV-Mode	QP-Mode	AV-Mode		
0.4313	L	41.51	35.01	57.23	47.23	-12.22	AV
0.9234	L	44.65	36.25	56.00	46.00	-9.75	AV
1.1656	L	44.91	33.71	56.00	46.00	-11.09	QP
5.5117	L	49.09	39.49	60.00	50.00	-10.51	AV
6.8047	L	47.77	38.37	60.00	50.00	-11.63	AV
14.1641	L	44.04	32.44	60.00	50.00	-15.96	QP

END